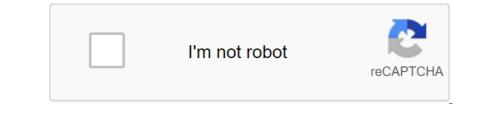
Infrared thermography errors and uncertainties pdf





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The Script and Uncertainty for non-short input variables. 6 Summary. The Script and Uncertainty for correlated input variables. 6 Summary. The Script and Uncertainty of Infrared thermography Errors and Uncertainty by Waldemar Minkin and Sebastian Dudzik, Technical University, Poland This edition was first published in 2009 in 2009 by John Wylie and Sons, Ltd Registered Office of John Wylie and Sons Ltd, Atrium, South Gate, Chichester, West Sussex, PO19 8S, UK For details of our global newsrooms, for customer service and for information on how How to apply for permission to reuse copyright materials in this book, please view our website on www.wiley.com. The author's right to be identified as the author of this work was declared under the Copyright, Designs and Patents Act 1988. All rights are reserved. No part of this publication can be reproduced, stored in the search system or transmitted by the UK Copyright, Design and Patent Act 1988, without prior permission from the publisher. 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The designations used by companies to distinguish their products are often approved as trademarks. All trademarks and product or supplier mentioned in this book. This publication is intended to provide accurate and authoritative information on the issue It is sold on the understanding that the publisher is not engaged in the provision of professional services. If you need professional advice or other expert help, you should seek the services of a competent specialist. MATLABS module, please contact: MathWorks, Inc. 3 Apple Hill Drive Natick, MA 01760-2098, USA Tel: 508-647-7000 Fax: 508-647-7001 Email: protected email:www.mathworks.com Library of Congress Publishing Inamination of data in Minkin, Walmar. Infrared thermography. 2. Infrared visualization. Uncertainty. 4. Tolerance (engineering) I. Dudzik, Sebastian, 1975- II. Title. TA1570. M62 2009 621.36'2-dc22 2009031444 Catalogue entry for this book is available at the British Library. ISBN: 978-0-470-74718-6 (Hbk) Set at 10/12pt, Times by Thomson Digital, Noida, India. Printed in the UK by CPI by Anthony Rowe, Chippenham, Wiltshire. Man, being a servant and translator of Nature, can do and understand so much and translator of Nature, can do and understand so much and Organum, Aphor. I our Wives El zbieta and Barbara Content Foreword ix About authors xi Confessions of xiii Symbols XV Glossary XVII 1 Key Concepts in Error Theory and Uncertainties 1.1 Systematic and Accidental Errors 1.2 Uncertainty in Indirect Dimensions 2.3 Emission 2.4 Measuring Infrared Cameras 15 15 15 15 20 29 3 Infrared Camera Algorithm Measurement Processing Path 3.1 Processing information in measurements of infrared thermal imaging 4.1 Introduction 4.2 Systemic interactions in infrared thermal imaging measurements 4.3 Simulation systematic Interactions 61 61 62 66 5 Uncertainty Measurements in Infrared Thermalography 5.1 Introduction 5.2 Methodology Modeling Experiments 5.3 Components combined standard uncertainty for non-short input Variables 81 81 82 95 viii 5. 4 Simulation of Combined Standard Uncertainty for Correlated Input Variables 8.5 Simulation of Combined Standard Uncertainty in Correlated Input Variables 8.1 81 82 95 viii 5. 4 Simulation of Combined Standard Uncertainty for Unrelated Input Variables 5.5 Simulation of Combined Standard Uncertainty for Unrelated Input Variables 5.5 Simulation of Combined Standard Uncertainty in Correlated Input Variables 5.5 Simulation of Combined Standard Uncertainty for Unrelated Input Variables 5.5 Simulation of Combined Standard Uncertainty in Correlated Input Variables 5.5 the infrared measurement of thermal imaging Presented A.3 software procedure for calculating coverage interval and combined standard uncertainty in the measurement of infrared thermal imaging using the presented software procedure for calculating coverage interval and combined standard uncertainty in the measurement of infrared thermal imaging using the presented A.3 software procedure to simulate cross-correlations between the input variables of the infrared thermal imaging using the A.5 MATLAB Source Code (MATLAB Source Code) presented software procedure to simulate cross-correlations between the input variables of the infrared thermal imaging using the presented software procedure to simulate cross-correlations between the input variables of the infrared thermal imaging using the presented software A.5 MATLAB Source Code (MATLAB Source Code) presented software procedure to simulate cross-correlations between the input variables of the infrared thermal imaging using the presented software (USING the presented software A.5 MATLAB Source Code) presented software (USING the presented software A.5 MATLAB Source Code) presented software procedure to simulate cross-correlations between the input variables of the infrared thermal imaging using the presented software (USING the presented software A.5 MATLAB Source Code) presented software proceedure to simulate cross-correlations between the input variables of the infrared thermal imaging using the presented software proceedure to simulate cross-correlations between the input variables of the infrared thermal imaging using the presented software proceedure to simulate cross-correlations between the input variables of the infrared thermal imaging using the presented software proceedure to simulate cross-correlations between the input variables of the infrared thermal imaging using the presented software proceedure to simulate cross-correlations between the input variables of the infrared thermal imaging using the presented software proceedure to simulate cross-correla Code (A.5 MATLAB Source Code (A.5 MATLAB Source Code (MATLAB Source Code (MATLAB Source Code (MATLAB Source Code)))Scripts) A.6 SOURCE code MATLAB Source Code (MATLAB Source Code (MATLAB Source Code))Scripts) A.6 SOURCE code MATLAB Source Code (MATLAB Source Code (A.5 MATLAB Source Code))Scripts) A.6 SOURCE code MATLAB Source Code (MATLAB Source Code))Scripts) A.6 SOURCE code MATLAB Source Code (MATLAB Source Code) (MATLAB Source Code) (MATLAB Source Code) (MATLAB Source Code (MATLAB Source Code))Scripts) A.6 SOURCE code MATLAB Source Code (MATLAB Source Code) (MATLAB S assess the accuracy of infrared thermal imaging measurements, or how accurate the data used in thermal imaging measurements are, for example, in the temperature analysis of selected objects by the final difference method (FEM) or zisik, 1994, Minkin, 1994, Minkin, 1994, Minkin, 1995, Minkin, 1994, this book, which is designed to solve the problem in depth. It is worth noting that this problem is not yet fully solved in the literature. The authors, whether physicists, architects, mechanical engineers or computer scientific field they represent. In this monograph, we have a comprehensive solution to this problem in accordance with international recommendations published in the Guide to The Expression of Uncertainty in Measurement (Guide, 1995, Guide, 2004). This work is the first to address the problem in this way. This is an extension and addition of the study presented in the x10
monograph minkina (2004). This book also aims to explain numerous misunderstanding is the misinterpretation of the noise equivalent temperature difference (NETD), published in catalogs as heat sensitivity and sometimes interpreted as a parameter associated with the accuracy of the measurement error. This option only affects the quality of the thermogram, as it guarantees better homogeneity of signals received from specific detectors. In practice, it can provide information about the temperature difference error between the two points of this area of uniform emission, measured by the same pixel of the multipixel array (matrix) of detectors in idealized conditions of measuring the short distance from the camera to the object and without sources emitting alarming radiation. This occurs when a measurable model stored in the camera's microcontroller's memory is performed, and the model parameters (eob, Tatm, To, v, d) come in with zero error. Of course, it is actually difficult to make such a measurement. The second misunderstanding is the misinterpretation of another parameter published in the catalogues: namely, the accuracy of the measurement of thermography. This accuracy is primarily related to the quality of the array detector calibration (Minkina, 2004). The better the x Preface calibration (i.e. the more accurate the static characteristics of individual detectors to the same general form), the lower the measurement error. Secondly, the accuracy of the measurement si influenced by the calibration are obviously error-laden. Therefore, if the catalog gives this error as 2 C, 2%, then for this range of measurements you should take more of the two values. For example, for a measurement range of 0-100 C we have to take 2 C, while for a range of 100 -500 C we have to take 2%. As before, the error value refers to idealized measurement model stored in the memory of the microcontroller and zero errors in the memory of the microcontroller and zero errors in the model parameters entered. In real-world conditions: that is, an adequate measurement model stored in the presence of external radiation interfering with the radiation of the object), the error can be many times greater. In extremely difficult atmospheric conditions, contactless temperature measurement is not possible at all. Analyzing the uncertainty of the processing algorithm in this work, we use the numerical method of distribution of distribution of distributions, recommended by Working Group 1 BIPM (International Bureau of Weights and Measures) (Guide, 2004). Uncertainty analysis was conducted for both correlated and unrelated model input variables. This allowed a quantitative assessment of the infrared camera. From a terminology point of view, this can be explained through different concepts. In literature, in addition to thermovision, the term thermography is often used. As measures are often computerized, the term computer-aid thermography is used as well. Thermography is used as well. Thermography is used as well. Thermography is often used. As measures are often computer-aid thermography is used as well. Thermography is used as well. graphic systems, not vision systems. Computer thermography is often used in English literature. Modern thermal imaging systems are called infrared cameras. Sometimes they can be theory of error and uncertainty. Chapter 2 addresses the main measurements in infrared thermal imaging, such as the law of heat and radiation. In Chapter 3, we describe a typical measurement trajectory algorithm, as well as a generalized temperature measurement trajectory algorithm, as well as a generalized temperature measurement trajectory algorithm. Chapter 4 examines the question of the error of measuring the infrared system using classical methods. In Chapter 5, we describe the results of simulations of measurement uncertainty studies in infrared thermal imaging, derived from the Faculty of Electrical Engineering university of technology, specializing in stokhova, born in 1953 in stokhova, born in the Electric drives. In 1983, he received his Ph.D. from the Institute of Electrical Meterology at the Vrock University, Ukraine, recommended by the Department of Measurement at the Lyvo'at Technology. On 22 June 2006, the President of Poland presented him with the nomination of a professor call deterology at the Vrock University, Ukraine, recommended by the Department of Measurement and Information of a professor call deterology at the Vrock University, Ukraine, recommended by the Department of Measurement and Information of a professor call deterology at the Vrock University, Ukraine, recommended by the Department of Measurement at the Lyvo'at Technology. engineering (full professor). Professor Minkina's scientific interests include thermometry, computerized thermography, heat measurements and theory, as well as thermal measurements of four monographs in metrology: Measurements and theory, as well as thermal vision measurements of thermal vision measurements and theory, as well as thermal vision measurements of thermal vision measurements of thermal vision measurements and theory as well as thermal measurement methods. He is the author of co-author of four monography, heat measurements of thermal vision measurements and theory as well as thermal vision measurements of thermal vision measurement methods. methods and tools (in Polish), Cze Stokhov University of Technology Publishers, 2004 (ISBN 83-7193-237-5); Compensation of dynamic characteristics of thermal vision in practice (in Polish), Cze Stokhov University of Technology, 2004 (ISBN 83-7193-237-5); Compensation of dynamic characteristics of thermanetric sensors - methods, systems, algorithms (in Polish), Cze Stokhov University of Technology, 2004 (ISBN 83-7193-237-5); Compensation of dynamic characteristics of thermal vision in practice (in Polish), PAK Agenda, Warsaw 2004 (ISBN 83-87982-26-1). He also published, mostly as a sole author, in sensors and drives, measurement, Technisches Messen, Experimental Physics Techniques, Priborostroenije, Messen-Steuern-Regeln, Meteorology at the head of three doctoral dissertations professor of institutes of metrology at the head of three doctoral dissertations protected with distinction. Xii O authors Professor of institutes of metrology at the head of three doctoral dissertations protected with distinction. Xii O authors Professor of institutes of metrology at the head of three doctoral dissertations protected with distinction. Xii O authors Professor of institutes of metrology at the head of three doctoral dissertations protected with distinction. Xii O authors Professor of institutes of metrology at the head of three doctoral dissertations protected with distinction. Xii O authors Professor of institutes of metrology at the head of three doctoral dissertations protected with distinction. Xii O authors Professor of institutes of metrology at the head of three doctoral dissertations protected with distinction. Xii O authors Professor of institutes of metrology at the head of three doctoral dissertations protected with distinction. Xii O authors Professor of institutes of metrology at the head of three doctoral dissertations protected with distinction. Xii O authors Professor of institutes of metrology at the head of three doctoral dissertations protected with distinction. Xii O authors Professor of institutes of metrology at the head of three doctoral dissertations protected with distinction. Xii O authors Professor of institutes of metrology at the head of three doctoral dissertations protected with distinction. Xii O authors Professor of institutes of metrology at the head of three doctoral dissertations protected with distinction. universities of Karlsruhe, West Berlin, St. Petersburg and Lviv, as well as at the Physics-Technical University of Riso, Denmark. He was a visiting lecturer in ph.D. research at the Institute of Solid State Electronics at The Technical University of Riso, Denmark. He was a visiting lecturer in ph.D. research at the Institute of Solid State Electronics at The Technical University of Riso, Denmark. International Seminars Infrarot - Thermography. Professor Minkina is a member of the Instrumentation and Measuring Systems Section of the Polish Academy of Sciences; Member of the Polish Touch Technology Association, the Polish Association of Theoretical and Applied Electrical Engineers and the Association of Polish Electricians, where he is an expert in three fields. He has been a member of the program, Scientific and Organization Committee (KBN) and projects conducted by the State Research Committee (KBN) and projects conducted by the State Research Committee (KBN) and national conferences and many times as a reviewer of the program, Scientific and Organization Committee (KBN) and projects conducted by the State Research Committee (KBN) and projects conducted by the State Research Committee (KBN) and projects conducted by the State Research Committee (KBN) and projects conducted by the State Research Committee (KBN) and projects conducted by the State Research Committee (KBN) and projects conducted by the State Research Committee (KBN) and projects conducted by the State Research Committee (KBN) and projects conducted by the State Research Committee (KBN) and projects conducted by the State Research Committee (KBN) and projects conducted by the State Research Committee (KBN) and projects conducted by the State Research Committee (KBN) and projects conducted by the State Research Committee (KBN) and projects conducted by the State Research Committee (KBN) and projects conducted by the State Research Committee (KBN) and projects conducted by the State Research Committee (KBN) and projects conducted by the State Research Committee (KBN) and projects conducted by the State Research Committee (KBN) and projects conducted by the State Research Committee (KBN) and projects conducted by the State Research Committee (KBN) and projects
conducted by the State Research Committee (KBN) and projects conducted by the State Research Committee (KBN) and projects conducted by the State Research Committee (KBN) and projects conducted by the State Research Committee (KBN) and projects conducted by the State Research Committee (KBN) and projects conducted by the State Research Committee (KBN) and projects conducted by the State Research Committee Since 1996 he has occupied the Department of Microprocessor Systems, Automatic Heat Control and Measurement. In 1995-2005 he was director of the Institute of Electrical Engineering at the University of Technology, specializing in measurement and control Systems. Since 2000 he has been working in the Faculty of Electrical Engineering at the University of Technology, specializing in measurement and control Systems. Engineering at the University of Technology Tse Stokhov University of Technology, where in 2007 he received his Doctorate of Engineering. He is the author or co-author of 21 articles published in magazines and non-destructive testing. Confessions We would like to heartily thank the five at here of active infrared thermographs, artificial neural networks and neuro-fuzzy models heat-free and non-destructive testing. reviewers of this book. The comments made in their reviews have greatly improved the content of this publication. We would also like to thank Dr. Janusz Baran for translating the text from Polish to English. Symbols A B Co 1/4 (5.670 32 0.000 045)102 m K D (L, T) d DTob Df dTob E(X) F H 1/4 (6.626 176 0.0 .4000 036)1034 W m2 K4 c 1/4 299 792 458 1.2 m s1 c 1 1/4 2phc2 1/4 (3.741 832 0.000 020)1016 W m2 K4 c 1/4 299 792 458 1.2 m s1 c 1 1/4 2phc2 1/4 (3.741 832 0.000 020)1016 W m2 K4 c 1/4 299 792 458 1.2 m s1 c 1 1/4 2phc2 1/4 (3.741 832 0.000 020)1016 W m2 K4 c 1/4 299 792 458 1.2 m s1 c 1 1/4 2phc2 1/4 (3.741 832 0.000 020)1016 W m2 K4 c 1/4 299 792 458 1.2 m s1 c 1 1/4 2phc2 1/4 (3.741 832 0.000 020)1016 W m2 K4 c 1/4 299 792 458 1.2 m s1 c 1 1/4 2phc2 1/4 (3.741 832 0.000 020)1016 W m2 K4 c 1/4 299 792 458 1.2 m s1 c 1 1/4 2phc2 1/4 (3.741 832 0.000 020)1016 W m2 K4 c 1/4 299 792 458 1.2 m s1 c 1 1/4 2phc2 1/4 (3.741 832 0.000 020)1016 W m2 K4 c 1/4 299 792 458 1.2 m s1 c 1 1/4 2phc2 1/4 (3.741 832 0.000 020)1016 W m2 K4 c 1/4 299 792 458 1.2 m s1 c 1 1/4 2phc2 1/4 (3.741 832 0.000 020)1016 W m2 K4 c 1/4 299 792 458 1.2 m s1 c 1 1/4 2phc2 1/4 (3.741 832 0.000 020)1016 W m2 K4 c 1/4 299 792 458 1.2 m s1 c 1 1/4 2phc2 1/4 (3.741 832 0.000 020)1016 W m2 K2 c 1/4 (3.741 832 0.000 020)1016 W m2 K4 c 1/4 299 792 458 1.2 m s1 c 1 1/4 2phc2 1/4 (3.741 832 0.000 020)1016 W m2 K4 c 1/4 299 792 458 1.2 m s1 c 1 1/4 2phc2 1/4 (3.741 832 0.000 020)1016 W m2 K2 c 1/4 (3.741 832 0.000 020)1016 W m2 K2 c 1/4 (3.741 832 0.000 020)1016 W m2 K2 c 1/4 (3.741 832 0.000 020)1016 W m2 K2 c 1/4 (3.741 832 0.000 020)1016 W m2 K2 c 1/4 (3.741 832 0.000 020)1016 W m2 K2 c 1/4 (3.741 832 0.000 020)1016 W m2 K2 c 1/4 (3.741 832 0.000 020)1016 W m2 K2 c 1/4 (3.741 832 0.000 020)1016 W m2 K2 c 1/4 (3.741 832 0.000 020)1016 W m2 K2 c 1/4 (3.741 832 0.000 020)1016 W m2 K2 c 1/4 (3.741 832 0.000 020)1016 W m2 K2 c 1/4 (3.741 832 0.000 020)1016 W m2 K2 c 1/4 (3.741 832 0.000 020)1016 W m2 K2 c 1/4 (3.741 832 0.000 020)1016 W m2 K2 c 1/4 (3.7 s2 lv k 1/4 (1.380 662 0.000 044)1023 W s K1 Lv I M q absorption ratio viewing angle, rad one of the input variables in the infrared camera (remaining F, R) technical constant (ISO 31) the speed of light in a vacuum (ISO 31) the speed of light in a vacuum (ISO 31) the speed of light in a vacuum (ISO 31) the speed of light in a vacuum (ISO 31) the first shining constant (ISO 31) the speed of light in a vacuum (ISO 31) the speed of light in a v model), m absolute error of the measurement model in infrared thermal imaging, K or C frequency bandwidth, relative error of the three constant calibration of the infrared camera, the other B, R) thermal flow, W; Heat Power Density, W m2 Permanent Planck (ISO 31) Glowing Intensity, cd Constant Boltzmann (ISO 31); expansion factor brightness, cd M2 wavelength, mm shining output, W m2 thermal flow density, W m2 xvi R r sk (I) sobbing s(X) so 1/4 2 p5 k4 No15 h3 c2 (5.670 32 0.000 7 1)108 W m2 K4 TT Tob To Tatm u(xi) uc (Tob) v Character Reflection Ratio (reflectivity) (one of three calibration constants infrared camera, remaining B, F); external radius, m correlation factor among input variables of the infrared camera measurement model, which describes the relative spectral sensitivity of the camera output signal from the detector, corresponding to the standard deviation of the temperature of the object by the random variable X Constant-Boltzmann (ISO 31) of the object by the random variable X constant-Boltzmann (ISO 31) of the object by the random variable X constant-Boltzmann (ISO 31) of the object temperature of the infrared camera, combined with the standard uncertainty of the humidity of the object temperature (one of the input variables in the infrared camera model), % Glossary Absolute error of measurement is the difference between the TC value calculated by the camera model), % Glossary Absolute error of the measurement infrared temperature (one of the input variables in the infrared temperature of the TR value calculated by the camera model), % Glossary Absolute error of measurement is the difference between the transition of the annual temperature of the TR value camera model), % Glossary Absolute error of measurement is the difference between the measurement infrared temperature of the TR value calculated by the camera model in infrared temperature of the TR value calculated by the camera model in infrared temperature of the TR value calculated by the camera model in infrared temperature of the TR value calculated by the camera model in infrared temperature of the TR value calculated by the camera model in infrared temperature of the TR value calculated by the camera model in infrared temperature of the TR value calculated by the camera model in infrared temperature of the TR value calculated by the camera model in infrared temperature of the TR value calculated by the camera model in infrared temperature of the TR value calculated by the camera model in infrared temperature (and the transition of the temperature). surface area (represented) by this element. Precision (measurement) is the maximum deviation expressed as a percentage of the scale or degrees Celsius that the readings of the device will deviate from the correct standard reference. Black body is also the perfect radiator. The emission of the black body is equal to one. Bolometric detectors are resistors of very low heat capacity with a large, negative temperature resistance factor. Calibration is a procedure for checking and/or tweaking the tool. After calibration, the instrument readings will agree with the standard uncertainty of P uc(y) is a positive square root of the combined standard uncertainty of P uc(y) is a positive square root of the combined standard uncertainty of P uc(y) is a positive square root of the combined uncertainty of P uc(y) is a positive square root of the combined standard uncertainty of P uc(y) is a positive square root of the combined standard uncertainty of P uc(y) is a positive square root of the combined standard uncertainty of P uc(y) is a positive square root of the combined uncertainty of P uc(y) is a positive square root of the combined uncertainty of P uc(y) is a positive square root of the combined standard uncertainty of P uc(y) is a positive square root of the combined uncertainty of P uc(y) is a positive square root of the combined uncertainty of P uc(y) is a positive square root of the combined uncertainty of P uc(y) is a positive square root of the combined uncertainty of P uc(y) is a positive square root of the combined uncertainty of P uc(y) is a positive square root of the combined uncertainty of P uc(y) is a positive square root of the combined uncertainty of P uc(y) is a positive square root of the combined uncertainty of P uc(y) is a positive square root of the combined uncertainty of P uc(y) is a positive square root of the combined uncertainty of P uc(y) is a positive square root of the combined uncertainty of P uc(y) is a positive square root of the combined uncertainty of P uc(y) is a positive square root of the combined uncertainty of P uc(y) is a
positive square root of the combined uncertainty of P uc(y) is a positive square root of the combined uncertainty of P uc(y) is a positive square root of the combined uncertainty of P uc(y) is a positive square root of the combined uncertainty of P uc(y) is a positive square root of the combined uncertain . A confidence level (1 (a) is a probability value associated with a confidence interval or statistical coverage interval. Uncertainty of the bady for the full range of radiation, called total emission, is the ratio of the spread of the spread of the standard experimental deviation, called total emission, is the ratio of the standard experimental deviation, called total emission, is the ratio of the standard experimental deviation, called total emission, is the ratio of the spread by multiplying the spread of combined standard uncertainty of uc(y) by expanding k:U 1/4 kuc.y. The expected E(X) P discrete random X variable, whose xi values appear with pi probabilities, is E'X 1/4 pi xi. Field of View (IFOV) is an area that can be observed from a given distance d using optics mounted on an infrared camera. The gray body is an object whose emission is a constant value less than unity over a certain spectral range. The 18th Glossary Instant Field of View (IFOV) is the field of view of a single detector (pixel) in the detector array. The error limitation is the smallest range around the measured value containing the actual value of y. Luminance or brightnessLv is the flow of light in this direction per unit Angle. The increments of input quantities (i.e. absolute errors). The common differential method) is based on extending the function of the measurement model in the Taylor series around the point, defined by actual (true conventional) input values. Monochrome radiant radiant the same temperature and is observed at the same angle. Noise equivalent power (NEP) is the RMS (Root Medium Area) power incident of monochrome wavelength I radiation, which generates output voltage, the value of which is equal to the noise level and the temperature of the abserved object and the temperature (NETD) is the difference between the temperature of the noise level. A non-chrome wavelength I radiation, which generates output voltage, the value of which is equal to the noise level and the temperature (NETD) is the difference between the temperature of the noise level. gray body is an object whose emission varies depending on the wavelength over the wavelength of interest. One-way coverage interval: if T is a function of observed values, so that for the calculated population parameter of u, the probability of Pr (T u) is at least equal (1 a) (where (1 a) is a fixed number, posible value of you) is a fixed number, posible value of you to T (or interval from the lowest possible value of you to T (or interval from the calculated population parameter of u, the probability of Pr (T u) is a fixed number, posible value of you) is a fixed number, posible value of you to T (or interval from T to the highest possible value of you) is a fixed number, posible value of you to T (or interval from T to the highest possible value of you) is a fixed number, posible value of you to T (or interval from T to the highest possible value of you) is a fixed number, posible value of you to T (or interval from T to the highest possible value of you) is a fixed number, posible value of you to T (or interval from T to the highest possible value of you) is a fixed number, posible value of you to T (or interval from T to the highest possible value of you) is a fixed number, posible value of you to T (or interval from T to the highest possible value of you) is a fixed number, possible value of you to T (or interval from T to the highest possible value of you) is a fixed number, possible value of you to T (or interval from T to the highest possible value of you) is a fixed number, possible value of you to T (or interval from T to the highest possible value of you) is a fixed number, possible value of you to T (or interval from T to the highest possible value of you to T (or interval from T to the highest possible value of you to T (or interval from T to the highest possible value of you to T (or interval from T to the highest possible value of you to T (or interval from T to the highest possible value of you to T (or interval from T to one-sided a). Pyrolectric detectors are built from semiconductors that have the so-called pyroelectric effect. The quantile of the order b of probability distribution, described by the cumulative function of Goo 1/4 b is satisfied. This means that the probability of this value occurring is b. The shining output (emitted) is the radiant the radiant the probability of this value occurring is b. energy (shining flow) dF emitted arbitrarily by a small surface element containing the address point to the projected dF area of that element. The intensity of the radiant is a radiant flow per unit of solid angle. A random error is the difference between the result of an individual measurement and the average, calculated on an infinite number of measurement and the average, calculated on an infinite number of measurement soft absolute error to the actual value. The relative error of the measurement models in infrared thermal imaging is the ratio of the absolute error of DTob to the actual temperature of tr. The response speed is a parameter that, like IFOV, describes the ability of an array detector. The Slice Response Function (SRF) is a parameter that temperature of the detector. The standard deviation of s(X) random variable error of DTob to the absolute error of DTob to the abso is a positive square root of variance. The 19th Standard Measurement Uncertainty is the uncertainty of this measurement, expressed as a standard deviation. A systematic error (bias) is the difference between the average, designed for an infinite number of the Tob 1/4 Tob object. Thermopylene detectors are built as thermopil, that is, a system of thermocells connected in a row. The standard type A uncertainty is standard uncertainty is a parameter that characterizes the distribution of frequency distribution. The uncertainty based on the distributed to the measured amount in a justifiable manner. Voltage or current (spectral) sensitivity is the ratio of the RMS value of the first harmonic voltage of the detector output (current) to the value of RMS of the first harmonic voltage of the first harmonic voltage of the first harmonic voltage of the detector output (current) to the value of RMS of the RMS value of the first harmonic voltage of the fir this is a consequence of the increasing complexity of measurement models: the number of input volumes increases and the relationship between inputs and exits becomes more complicated. This makes it difficult to assess accuracy using classical methods that use analytical descriptions. On the other hand, technological advances provide a better understanding of physical reality, which, among other things, includes changes in the definitions of units of measurement that are the basis of each metric system. For example, consider how the definition of a meter has evolved over the past two centuries (www.gum.gov.pl): 1793: The meter is 1/10,000,000 distance from the equator to the Earth is 40 million meters). 1899: Meter distance measured at 0 C, between two engraved lines on the top surface of the international standard meter prototype, made of platinum iridium bar (102 cm in length) with an H-shaped cross-section. 1960: The meter is equal to 1,650,763.73 wavelengths of orange-red crypton-86 isotope radiation. 1983: Meter distance traveled by light in a vacuum in 1/299 792 458 seconds. To assess the accuracy of measurements, it is necessary to identify the basic theoretical concepts of error and uncertainty. Below, we present measurement error definitions for a single measure value. The absolute error of error and uncertainty. measurement lies in the difference between the measured value and the actual value of the U: Dy 1/4 y: Infrared thermography: Mistakes and Uncertainties 2009 by John Wylie and Sebastian Dudzik No1:1 Infrared thermography 2 The relative measurement error is the ratio of absolute error to the actual value of y in the formula (1.1) is replaced by the true normal value. Because the exact value of the absolute error is unknown, it is important to estimate the range in which the actual value of y (Guide 2004): y Dymax : 1:3 In the analysis of measurement errors occurring in repeated experiments, the division is made into systematic and random errors. Studying the results of repeated measurements of the same number leads to the observation that one component of the error does not change is mark or meaning or develops with changes in the terms of reference in accordance with a specific law (function). This component was called a systematic error or bias (Taylor 1997, Guide 1995). It is defined as follows: a systematic error (bias) is the difference between the average value, designed for an infinite number of measurements of the amount made under the same conditions, and its actual value. The second component of the error is commonly referred to as a random error (Guide 2004). It can be reduced by repeating the measurement and the average, designed for an infinite number of measurements made under the same conditions. The aforementioned measurement error definitions relate to the results of individual measurements. When a measurement model is given as an input measure, it is called an indirect measurement. The indirect measurement error of output based on known input errors: extending the Taylor model function to the first-order terms (the general differential difference method); or the increments method. The increments method (the exact method) consists of determining the increments of input quantities (i.e. absolute errors). Consider the measurement model as a function of several variables: y 1/4 f x1; x2; ...;
xn th; No1:4, where x1, x2, ... xn th; No1:4, where x1, x2, arguments f). Then we can write the increment of the function as: Dy 1/4 y dy y: 1:5'The first two components on the right side (1,5) can be expressed as: x2 and Dx2; . . ; xn th Dxn f xx1; x2; . . . ; xn th Dxn f xx1; method was used in the computer simulation of the error method in the infrared thermalography presented in Chapter 4. Unfortunately for complex measurement models, the error score using (1,7) and (1.8) is very tedious. Therefore, the error score using (1,7) and (1.8) is very tedious. around the point, defined by the actual (true ordinary) input values. Assuming that the feature (1.4) is continuous and, for simplicity, that only the input x1 is burdened with the Dx1 error, the extension in the Taylor series has the following form: f x1 ; x2 ; ... ; xn No 1/4 f . 3! Conditions of orde higher than one may be omitted in the aforementioned expansion, suggesting that their impact on the result is negligible. Based on (1.6), we can write: Dy1 1/4 Dx1 f 0 x1; x2; ...; xn, called the x1 entry sensitivity index. When you consider errors from all x1 inputs; x2 ... xn, the total error of the indirect measurement can be written as the sum: Dy 1/4 n X i1/41 Dxi @y; @xi 1:11, where partial derivatives (protected email) are calculated by x1; x2; ...; xn K. Since in (1.11) all increments of input variables x1; x2; ...; xn K. Since in (1.11) all increments of input variables x1; x2; ...; xn K. Since in (1.11) all increments of input variables x1; x2; ...; xn K. Since in (1.11) all increments of input variables x1; x2; ...; xn K. Since in (1.11) all increments of input variables x1; x2; ...; xn taken with the same sign, the total error is overstated. In real-world experiments, the probability that all input measurements are burdened with positive (or negative) errors is small and decreases with the increase in input (Fuller 1987). Thus, a more realistic estimate of the indirect measurement of an absolute error is usually used in practice - the average square error: s @y 2 @y 2 Dx2 dxn : 1:12 Dy 1/4 Dx1 @x1 @x2 @xn Infrared thermography 4 In terms of temperature measurement using infrared system, system, system, system, system, system, error analysis can be useful For strictly defined reference conditions. Such analysis can also be useful in a reasonable assessment of the accuracy of measurements in situations where there is no information on these conditions. An additional purpose of the analysis is to compare the different measurements In precise at different measured at different points is used in the calculations of the final element (FEM). 1.2 Uncertainty in indirect measurements In precise comparative measurements (such as standard measurements) it is necessary to describe reference conditions in the distribution of probability. In such situations, it is more convenient to use the concept of measurements) it is necessary to describe reference conditions in the distributed to the measurements. Unfortunately, the aforement uncertainty, that can be attributed to the measurement uncertainty. accurately characterize the accuracy of the measurements, the following definition of standard uncertainty (Guide 1995) was introduced as a standard deviation. To estimate the quantitative accuracy of the measurement is the uncertainty of measurement values are standard deviation. characterized by specific functiones of probability distribution. To measure accuracy, the most important statistics of random variables are the expected value of E(X) of the discrete random X variable. Thus, the expected value is replaced by its evaluator - arithmetic average from independent observations N (S'oderstr om and Stoica 1994): N 1X 1/4 xi : 1:14 x N i1/41 Standard deviation s(X) random variable is a positive square root variance: 1:15 s'X 1/4 E1/2X E'X2 : Basic concepts in error theory and uncertainties 5 Practical problems are used by a standard deviation evaluator called an experimental standard deviation. It is calculated from the N independent observations xi: a priori. Example 1.1 Assessment of probability density parameters from a series of measurements. The density under repetitive conditions. The uncertainty analysis was based on a series of measurements of X quantity under repetitive conditions. The density function parameters from a series of measurements of X quantity under repetitive conditions. subject to Gaussian distribution (this distribution was determined on the basis of the shape of the histogram). The results of numerical calculations are shown in figure 1.1a. A hard line denotes the probability density function obtained for calculated parameters. To assess standard uncertainty, we used the arithmetic average (1.14) and the experimental standard deviation of 1.16 as the best evaluators of the shape of the histogram). The results of numerical calculations are shown in figure 1.1a. A hard line denotes the probability density function obtained for calculated parameters. To assess standard uncertainty, we used the arithmetic average (1.14) and the experimental standard deviation of 1.16 as the best evaluators of the shape of the histogram). this way, we could use the functions MATLAB means () and std () to determine these basic statistics on the resulting distribution. This experiment illustrates how to evaluate the standard uncertainty of Type A. Figure 1.1 Assessment of Standard Uncertainty by Single Distribution Density Feature Figure 1.1b shows as the uncertainty of the type B standard can be determined by the equal distribution of the probability of variable X. Distribution density function: g'x 1/4 1'2a g'4 0 for x a for other x: 1:17 In this example, to determine the uncertainty of the type B standard uncertainty is a q 3:40 for x a for other x: 1:17 In this example, to determine the uncertainty of the type B standard uncertainty is a q 3:40 for x a for other x: 1:17 In this example, to determine the uncertainty of the type B standard uncertainty is a q 3:40 for x a for other x: 1:17 In this example, to determine the uncertainty of the type B standard uncertainty of the type B standard uncertainty is a q 3:40 for x a for other x: 1:17 In this example, to determine the uncertainty of the type B standard uncertainty is a q 3:40 for x a for other x: 1:17 In this example, to determine the uncertainty of the type B standard uncertainty
of the type B standard uncertainty of the type B standard uncertainty is a q 3:40 for x a for other x: 1:17 In this example, to determine the uncertainty of the type B standard uncertainty of the type B where it is half the length of the interval. In the case of errors, the problem is how the individual standard uncertainty of the inputs of a complex analytical model affects accuracy indirect measurements (i.e. the assessment of measurements (i.e. the assessment of measurement uncertainty) of the inputs of the model are correlated or not, the covarian factor appears in thee assessment of measurements (i.e. the assessment of measurements (i. definition of combined uncertainty. Provided that input variables are not interconnected, the cumulative standard uncertainty is determined according to VIM (1993): the combined uace y' 1/4 @xi i1/41, where y 1/4 f (x1, x2, ..., xn) is a function of the ith input wariables. N X @f 2 2 uxi; No1:18 u2c y' 1/4 @xi i1/41, where y 1/4 f (x1, x2, ..., xn) is a function of the measurement model (1.4) and u2 (xi) is the variance of the ith input wariables. N X @f 2 2 uxi; No1:18 u2c y' 1/4 @xi i1/41, where y 1/4 f (x1, x2, ..., xn) is a function of the combined user to the ith input wariables. are correlated, an expression describing uncertainty is more complex because it includes estimates of input covarality. Cumulative measurement uncertainty u defined as (Taylor 1997): nX 1 X n X @f 2 @f @f u2 sxi 2 u'x; xj th; No 1:19 u2c yo 1/4 @xi @x i 1/41 j1/4i 1 where u'xi; xj is the assessment of the kovarian between xi and xj. Because model inputs are treated as random variables when assessing the uncertainty of indirect measurements, certain evaluators (expected values, standard deviations) are also random variables. Therefore, we need to define certain parameters using the concepts of probability. These concepts (VIM 1993) are discussed below. The one-way coverage interval is as follows. If T is a function of observed values, so that for the U population calculation, the probability of Pr (T u) or Pr (T u) is at least equal (1 a) (where (1 a) is a fixed number, positive and smaller than one), then the interval from the lowest possible value of you to T (or interval from T to the largest possible value of you) is a one-way coverage interval with a level of confidence (1 a). A level of trust is a probability (1 (a) of probability associated with a simultaneous assessment of the probability with which the measurement result is within the interval, defined by this uncertainty of the uncertainty of the uncertainty of the uncertainty of uc(y) by the expansion factor K: U 1/4 kuc'y's: 1:20 Extended uncertainty determines the limits of the uncertainty interval for this level of confidence. The value of the expansion factor depends on the probability distribution of the variable output of the model. For example, if a random variable has a Gaussian yield, the probability that is for k 1/4 1, is about 95%; from y 2uc (y), i.e. for k 1/4 1, is about 95%; and from y 3uc(y), that is for k 1/4 2, about 95%; and from y 3uc(y), that is for k 1/4 3, about 95%; from y 2uc (y), i.e. for k 1/4 1, is about 95%; from y 2uc (y), i.e. for k 1/4 1, is about 95%; and from y 3uc(y), that is for k 1/4 1, is about 95%; from y 3uc(y), that is for k 1/4 1, is about 95%; from y 2uc (y), i.e. for k 1/4 2, about 95%; and from y 3uc(y) to y 3uc (y), that is for k 1/4 3, about 95%; from y 3uc(y), that is for k 1/4 1, is about 95%; from y 3uc(y), that is for k 3uc(y), that 3uc(y) variables is an inconvenience in determining the expansion factor. For models with a lot of input, we can assume that the theorem of the central limit is applied. In this case, a priori assumption of the Gaussian distribution, especially where the measurement practices reveal significant differences in the assumption of the central limit is applied. In this case, a priori assumption of the Gaussian distribution, especially where the measurement model shows that the variable output has a Gaussian distribution. strong non-linear differences and the true distribution of variable output is asymmetrical. When the probability of a variable output is not known, we need to determining as a result the number of degrees of freedom from the Welch-Satterthwaite equation (Welch 1936, Satterthwaite 1941 : neff 1/4 u4c y; N X u4 yo 1:21 i i1/41 n and calculation of extended uncertainty as (Guide 1995): Up 1/4 tp neff suc sy' 1/4 tp neff suc sy'; 1:22, where the tp noeff ratio is the distribution value of the student's t, calculated on the basis of the number of degrees of freedom approximated by the formula (1.21). In summary, the following steps can be taken to assess the combined standard uncertainty (2004 Guide): 1. Assessment of expected values and standard deviations of u'x' 1/4 zu'x1 . . . u'xn RT distribution probabilities of random X1 variables . . . Xn, representing input x 1/4 x1 . . . Xn CT measurement model. Evaluation of modes (1.4) for its inputs. 4. Calculating output estimates based on the function of the f. 5 measurement model. Evaluation of mode sensitivity indices using partial derivatives determined in step 3, calculated at point x 1/4 x1... xn K. 6. Assessment of the extended uncertainty uc sy based on u'x, u'xi ; xj and model sensitivity indexes using formula 1.18 or 1.19. Infrared thermography 8 7. Estimating the number of degrees of freedom using, for example, a formula 1.21). 8. Calculating extended uncertainty from (1.22). These steps lead to a correct assessment of the extended uncertainty uc sy based on u'x, u'xi ; xj and model sensitivity indexes using formula 1.18 or 1.19. Infrared thermography 8 7. Estimating the number of degrees of freedom using, for example, a formula (1.21). uncertainty only when the following three conditions are met: 1. The model is negligible. Since it is difficult to specify an objective measure of non-linearity, we mean here that the disregard for higher order conditions in the Taylor series extending the function of the release model is Gaussian with good accuracy 3. The approximation of this number of degrees of freedom from the Welch-Satterthwaite equation is quite accurate. In practical dimensions, it is often impossible to meet the above conditions. Therefore, Working Group 1 of the General Committee on Major Issues in Meteorology has prepared a supplement No. 1 to the manual (1995) entitled The Number of Distribution Methods. This add-on provides the idea of numerically estimating the coverage interval. This approach does not require knowledge of the analytical form of the probability distribution function. In further parts of this book we present the main guidelines and goals of this method. 1.3 The distribution function function. In further parts of this book we presented the basic concepts associated with assessing the accuracy of indirect measurements using complex mathematical models. We have described the basic concepts associated with assessing the accuracy of indirect measurements using complex mathematical models. in assessing extended uncertainty. These problems are the consequences of the fact that, in practice, the types of probability distribution of input random variables (i.e. measured quantities) are unknown. The General Committee on Major Problems in Meteorology took this into account when preparing the supplement relates to assessing the accuracy of indirect measured quantities) are unknown. The General Committee on Major Problems in Meteorology took this into non-linear and/or complex measurement models, such as an infrared camera trajectory processing algorithm. The distribution of variable output is not Gaussian; The distribution of variable shows asymmetry; The measurement model is a highly non-linear functior of input quantities; the uncertainties of individual input quantities are incomparable. The idea of distributions is illustrated in figure 1.2 9 Illustration of the valid values ji ith input amount Xi; and gyo, probability density function H output Y 1/4 f/X output. In the method of distribution, uncertainty is assessed using the Monte Carlo method. The main purpose of the computational procedure is to estimate the statistical coverage interval at a given level of trust. It is worth emphasizing that the procedure gives the right results even for highly non-linear functional interactions of density of probability of input random variables. In assessing uncertainty, the following steps can be identified: 1. Determining the output of the measurement model reviewed (indirectly measured number). 2. Determining the input volumes of the model (based on an analysis of a number of input data of the model (based on an analysis of a number of input data of the model (based on an analysis of a number of
input data of the probability distribution of output using a measurement model and a defined distribution of input data. The calculations can be carried out using the parameters of the resulting probability density function; i.e. standard uncertainty and the corresponding expected level of trust. The Monte Carlo method makes it be coverage (confidence) interval, which includes measurements with a probability determined by the expected level of trust. The Monte Carlo method makes it be coverage (confidence) interval, which includes measurements with a probability determined by the expected level of trust. possible to numerically approximation of Goh's cumulative distribution from the amount of output. The simulation is based on the assumption that any input values of that input is as justified as any other. In other words, the value soft hat input is as justified as any other. In other words, the value soft hat input values of that input is as justified as any other. In other words, the value is not preferable. Thus, the drawing values of each input amount, in The value of the measurement model output corresponding to the input values drawn is a representative result. Therefore, a fairly large set of outputs density of acceptable output values drawn is a representative result. Therefore, a fairly large set of outputs density of acceptable outputs density of acceptable outputs density of acceptable output values (measured quantity). The Monte Carlo simulation is performed in this way can bring, to the required accuracy, the distribution of the probability density of acceptable output values (measured quantity). The Monte Carlo simulation is performed in this way can bring, to the required accuracy, the distribution of the probability density of acceptable output values (measured quantity). density function of each input variable C; i 1/4 1; . . . ; N. In the case of statistically dependent variables, samples should be created using the function of joint density of variables. The sample is repeated M times where M is a large number. As a result, we get A independent variables, samples should be created using the function of joint density of variables. The sample is repeated M times where M is a large number. As a result, we get a set of N (implementation) variables, samples should be created using the function of joint density of variables. The sample is repeated M times where M is a large number. As a result, we get A independent variables, samples should be created using the function of joint density of variables. cumulative density of the Y function, based on a generated set of values. No 4. Assessing the statistical parameters of the endpoints of the endpoints of the Ip(y coverage interval) for the estimated probability of coverage, as the two quantile are Goyo. One of the most importan aspects of distribution distribution distribution distribution is the approximation of the cumulative density function of the amount of output. Steps for the approximation procedure are as follows: 1. Sorting the values of the year; r 1/4 1; ...; M. 2. Appointment of equilibrium cumulative probabilities to sorted values by formula (Cox et al 2001): r 0:5; r 1/4 1; . . . ; M: No1:23 M No 3. Formation of G'h probability distribution, you can calculate its expected value, which is an estimate of the measured amount of Y, and its standard deviation, which is an estimate of standard uncertainty. Estimates of the vaz; pr: pr 1/4 - Goh 1/4 pr mjayer No 1 ; r 1/4 1; . . . ; M 1: No1:24, by determining the approximation of G'h probability distribution, you can calculate its expected value, which is an estimate of the measured amount of Y, and its standard deviation, which is an estimate of standard uncertainty. Estimates of the vaz; pr: pr 1/4 - Goh 1/4 pr mjayer No 1 ; r 1/4 1; . . . ; M 1: No1:24, by determining the approximation of G'h probability distribution. expected value and variance can be calculated as: y 1/4 M 1X yr M r1/41 No1:25 Basic concepts in error theory and uncertainties 11 and: u2c yr 1 1/4 M 1X yer yo2 : M 1 r1/41 No1:26 The last step in the distribution, described by the cumulative function of The Distribution of Goh, This means that the probability of this value is b. If we denote the value for the interval from 0 to 1 p.p., where p is the required probability of the 95% coverage interval will be quantitatively about 0.025 and 0.0975. As a result, we get coverage interval from 0 to 1 p.p., where p is the required probability of the 1/4 0.025, the end of the 95% coverage interval will be quantitatively about 0.025 and 0.0975. As a result, we get coverage interval from 0 to 1 p.p., where p is the required probability of the 1/4 0.025, the end of the 95% coverage interval will be quantitative values of order A and p of the distribution defined by G'h. 10.95 (y). In general, if the probability distribution is symmetrical, the shortest coverage interval is associated with quantitative: a1/4 1p : 2 1:27, as we see, for the coverage interval of 95% and provided that the distribution is symmetrical relative to the expected value (this is not the centered expected value). In this case, there are many intervals that satisfy equality: g'G 1 for th 1/4 gG 1 per pp; and we have to choose a value that determines the shortest possible coverage interval associated with the estimated probability of p. The value of the chosen one thus satisfies the condition: 1 for 1/4 minutes: 1 p.P. 1:29 Below we provide an example of uncertainty analysis using distribution distribution. (The procedure described in this case, there are many intervals that satisfy equality: g'G 1 for th 1/4 gG 1 per pp; and we have to choose a value that determines the shortest possible coverage interval associated with the estimated probability of p. The value of the chosen one thus satisfies the condition: 1 for 1/4 minutes: 1 p.P. 1:29 Below we provide an example of uncertainty analysis using distribution distribution. example is in principle consistent with a much more complex example: assessing the uncertainty of the infrared camera processing algorithm. Example 1.3 Using distribution to determine the coverage interval of 95% of a simple nonlineary model, consider a simple measurement model with two inputs for the infrared thermography 12 Table 1.1 Inputs for a simple neuron of the infrared thermography 12 Table 1.1 Inputs for a simple neuron of the infrared thermography 12 Table 1.1 Inputs for a simple neuron of the infrared thermography 12 Table 1.1 Inputs for a simple neuron of the infrared thermography 12 Table 1.1 Inputs for a simple neuron of the infrared thermography 12 Table 1.1 Inputs for a simple neuron of the infrared thermography 12 Table 1.1 Inputs for a simple neuron of the infrared thermography 12 Table 1.1 Inputs for a simple neuron of the infrared thermography 12 Table 1.1 Inputs for a simple neuron of the infrared thermography 12 Table 1.1 Inputs for a simple neuron of the infrared thermography 12 Table 1.1 Inputs for a simple neuron of the infrared thermography 12 Table 1.1 Inputs for a simple neuron of the infrared thermography 12 Table 1.1 Inputs for a simple neuron of the infrared thermography 12 Table 1.1 Inputs for a simple neuron of the infrared thermography 12 Table 1.1 Inputs for a simple neuron of the infrared thermography 12 Table 1.1 Inputs for a simple neuron of the infrared thermography 12 Table 1.1 Inputs for a simple neuron of the infrared thermography 12 Table 1.1 Inputs for a simple neuron of the infrared thermography 12 Table 1.1 Inputs for a simple neuron of the infrared thermography 12 Table 1.1 Inputs for a simple neuron of the infrared thermography 12 Table 1.1 Inputs for a simple neuron of the infrared thermoscient the infrared simulation consisted of M 1/4 105 circuits and generated an approximate distribution of X1 and X2 input variables for conditions determined by parameters from table 1.1. These distributions of the output of the input variables for conditions determined by parameters from table X1 and X2 input variables for conditions determined by parameters from table 1.1. These distributions of the output of the input variables for conditions determined by parameters from table 1.1. These distribution of the output of the input variables for conditions determined by parameters from table 1.1. These distributions are represented in figures 1.3 and 1.4. In order to To determine the probability density function of the output of the input variables for conditions determined by parameters from table 1.1. These distributions are represented in figures 1.3 and 1.4. In order to To determine the probability density function of the output of the input variables for conditions determined by parameters from table 1.1. These distributions are represented in figures 1.3 and 1.4. In order to To determine the probability density of the input variables for conditions determined by parameters from table 1.1. These distributions are represented in figures 1.3 and 1.4. In order to To determine the probability density of the input variables for conditions determined by parameters from table 1.3. Distribution of the output of the Basic Concepts in Error Theory and Uncertainties 13 Figure 1.4 Distribution of probability density of the input variable X2 Approximation of the G(Y distribution function) distribution approximation is shown in Figure 1.5, and the corresponding approximation of probability density is represented in Figure 1.6. The estimated amount calculated as arithmetic average variable Y is 1/4 302, standard uncertainty of uc'y 1/4 30, and the coverage interval of 95%, marked by vertical lines in figure 1.6, is 10:95 Y 1/4 1/2252; The example above explains the distribution of this method to much more complex measurement models in infrared thermal imaging (described in detail in Chapter 3). For such a complex model, the use of distribution distribution distribution is justified rather than analytical. In addition,
it gives 1 0.8 0.6 0.4 0.2 0 240 260 280 300 320 340 360 Values Y Figure 1.5 The numerical approximation of the cumulative distribution of the variable output model of infrared thermal imaging 14 Figure 1.5 The numerical approximation of the cumulative distribution with a marked 95% short coverage interval is more accurate results due to the non-linearity of the model. The methodology for modeling and researching the infrared model of measuring thermography is presented in Chapter 5. Summing up the above considerations on the basic concepts of metrology, we want to emphasize that the analysis of errors and analysis of errors and analysis of errors and analysis of errors and uncertainty analysis as an additional method for assessing the accuracy of infrared thermalography is presented in Chapter 5. Summing up the above considerations on the basic concepts of metrology, we want to emphasize that the analysis of errors and analysis of errors and analysis as an additional method for assessing the accuracy of infrared thermalography is present error and uncertainty analysis as an additional method for assessing the accuracy of infrared thermalography is presented in Chapter 5. Summing up the above considerations on the basic concepts of metrology, we want to emphasize that the analysis of errors and errors 2.1 The F.V. Herschel experiment, which revealed infrared radiation, was fundamental to the rise and development of research in the infrared spectrum. In his experiment, which revealed infrared radiation into a glass prism. The energy of the random rays was absorbed by the containers, and the thermometers indicated the temperature above the ambient temperature above the ambient temperature above the are rays, weakly refracted by a prism, invisible to the naked eye. Herschel called them invisible rays or invisible thermometric spectrum. A little later they are commonly referred to as infrared rays. Further experiments on interference and polarization have proved that infrared rays, also visible rays, are susceptible to reflection, refraction and absorption. However, it was Herschel who first identified the point of maximum thermal effect and stated that it is beyond the visible range of the spectrum. Although Herschel is considered a pioneer in infrared thermography without the basic laws of radiation transmission of heat. They are formulated and described below. 2.2 Basic laws of radiation transmission of heat it is beyond the visible range of the spectrum. emits thermal (heat) radiation. The intensity of this radiation depends on the wavelength and body temperature (Gerashenko et al. 1989). Infrared thermography: Mistakes and uncertainties 2009 by John Wylie and Sons, Ltd Waldemar Minkina and Sebastian Dudzik infrared thermography 16 Figure 2.1 Pathways of heat radiation flow incident on the body of a certain thermal thickness radiation is a kind of electromagnetic radiation usually occurring in nature. If the heat flow E (the amount of heat per unit of heat per unit of time) (W) falls on the surface of the body of a certain thickness, and the ER (W) flow is absorbed, the ER (W) flow is reflected and the ETT (W) flow is absorbed, the ER (W) flow is reflected and the ETT (W) flow is r sketched in Figure 2.1. The concept of the ideal black body plays a very important role in the measurements of infrared thermalography. Several models of black body soft and Barber 1990). The ideal black body plays a very important role in the measurements in Infrared thermalography. Several models of black body soft and Barber 1990). The black body fully absorbs the radiation of the incident, so the coefficients determined (2.1) are equal to: A 1/4 0; T T 1 radiation absorption incident in the above models is the result of several internal reflections. The following equality - Kirchhoff's law - is satisfied for each body: A T T 1/4 1: No2:3 This law is performed not only for general radiation, Al spectral abstinence is introduced, RI reflection and transmission of T TI. Their values q zi'ik 1988, depend on a certain wavelength I and are defined as (Janna 2000, Bayazitoglu and O Wiecek et al. 1998, Wiecek 1999, Wolfe and ziss 1978): Al 1/4 FIA; FI TI 1/4 F Some authors (e.g. Madura et al. 2001) have announced that for superfast thermal processes the ratios also depend on the time. The ratio (temperature-dependent and wavelength- depending on) of the radiant energy (shining flow) dF emitted by an arbitrarily small surface element containing the address point to the projected dF area of this element containing the address point to the projected dF area of this element is called a radiant output (emitted), and the radiant energy (shining flow) dF emitted by an arbitrarily small surface element containing the address point to the projected dF area of this element is called a radiant energy (shining flow) dF emitted by an arbitrarily small surface element containing the address point to the projected dF area of this element is called a radiant energy (shining flow) dF emitted by an arbitrarily small surface element containing the address point to the projected dF area of this element is called a radiant energy (shining flow) dF emitted by an arbitrarily small surface element containing the address point to the projected dF area of this element is called a radiant energy (shining flow) dF emitted by an arbitrarily small surface element containing the address point to the projected dF area of this element is called a radiant energy (shining flow) dF emitted by an arbitrarily small surface element is called a radiant energy (shining flow) dF emitted by an arbitrarily small surface element to the projected dF area of this element is called a radiant energy (shining flow) dF emitted by an arbitrarily small surface element energy (shining flow) dF emitted by an arbitrarily small surface element energy (shining flow) dF emitted by an arbitrarily small surface element energy (shining flow) dF emitted by an arbitrarily small surface element energy (shining flow) dF emitted by an arbitrarily small surface element energy (shining flow) dF emitted by an arbitrarily small surface element energy (shining flow) dF emitted by an arbitrarily small surface element energy (shining flow) I (W sr1). Shining output expressed as (Kreith 2000, Hudson 1969): M'I; T NO 1/4 dF'I; T.A.; W m2 : dF No2:6 Heat flow density q is expressed in the same units as the shining output for black body given by Planck law (O Mb'I; TK 1/4 2 p c2 hc hc ; W m2 mm 1; I exp I k T 1 5 2:9, where (after a string): Spectral shining output expressed as (Kreith 2000, Hudson 1969): M'I; T NO 1/4 dF'I; T.A.; W m2 : dF No2:6 Heat flow density q is expressed in the same units as the shining output for black body given by Planck law (O Mb'I; TK 1/4 2 p c2 hc hc ; W m2 mm 1; I exp I k T 1 5 2:9, where (after a string) output expressed as (Kreith 2000, Hudson 1969): M'I; T NO 1/4 dF'I; T.A.; W m2 mm 1; I exp I k T 1 5 2:9, where (after a string) output expressed as (Kreith 2000, Hudson 1969): M'I; T NO 1/4 dF'I; T.A.; W m2 mm 1; I exp I k T 1 5 2:9, where (after a string) output expressed as (Kreith 2000, Hudson 1969): M'I; T NO 1/4 dF'I; T.A.; W m2 mm 1; I exp I k T 1 5 2:9, where (after a string) output expressed as (Kreith 2000, Hudson 1969): M'I; T NO 1/4 dF'I; T.A.; W m2 mm 1; I exp I k T 1 5 2:9, where (after a string) output expressed as (Kreith 2000, Hudson 1969): M'I; T NO 1/4 dF'I; T.A.; W m2 mm 1; I exp I k T 1 5 2:9, where (after a string) output expressed is (Kreith 2000, Hudson 1969): M'I; T NO 1/4 dF'I; T.A.; W m2 mm 1; I exp I k T 1 5 2:9, where (after a string) output expressed is (Kreith 2000, Hudson 1969): M'I; T NO 1/4 dF'I; T.A.; W m2 mm 1; I exp I k T 1 5 2:9, where (after a string) output expressed is (Kreith 2000, Hudson 1969): M'I; T NO 1/4 dF'I; T.A.; W m2 mm 1; I exp I k T 1 5 2:9, where (after a string) output expressed is (Kreith 2000, Hudson 1969): M'I; T NO 1/4 dF'I; T.A.; W m2 mm 1; I exp I k T 1 5 2:9, where (after a string) output expressed is (Kreith 2000, Hudson 1969): M'I; T NO 1/4 dF'I; T.A.; W m2 mm 1; I exp I k T 1 5 2:9, where (after a string) output expressed is (Kreith 2000, Hudson 1969): M'I; T NO 1/4 dF'I; T.A.; W m2 mm 1; I exp I k T 1 5 2:9, where (after a string) output expressed is (K Wark (1988) and ISO 31): c 1/4 299 792 458 1.2 m s1, speed of light in a vacuum; h 1/4 (6.626 176 0.000 036)1034 W s2, Constanta Plank; and k 1/4 (1.380 662 0.000 044)1023 W s K1, Boltzmann Constants. Infrared thermography 18 Figure 2.3 2004) Shining exit Mb (I,T) black body by plank formula (2.10) (Minkin By identifying new constants c1 1/4 2phc2 1/4 (3.741 832 0.000 020)1016 W m2 (the so-called first shining constant), c2 1/4 hc/k 1/4 (1.438 786 0.000 045)102 m K (called the second shining constant) according to the International Temperature Scale, ITS-90, The formula (2.9) can be written in a more compact form: c1; W m2 mm1 : No2:10 Mbps; T 1/4 5 c2 l exp | T 1 Charts in Figure 2.3 show the radiant output of Mb (I,T) of the black body defined (2.10), compared to the wavelength I for different T temperatures (Minkina 2004). The band of radiant output Mb (I1,I2) of the black body is an integral part of the spectral intensity (2.10) over the band from the wavelength 1 to the wavelength 12 to the wavelength 12 to the wavelength 12 to the wavelength 12 to dt = 1 5 1 No2:11 Law Planck The radiant output of Mb (I), measured for a specific I (Chrzanowski 2000). This can be done from plank's reverse law: c2 No2:12 T1/4 h il; K: 5 In c1 l'5 I M'l'b l' b B In certain situations Planck's law can be simplified. These specific situations are described by Vienna law and the Reilly-Jeans Act. Vienna's law is the approximation of Planck's law to the small values of the 19th black body, vienna's law is expressed; MB Evil; T No 1/4 c1: W m 2 mm 1 15 exp lc2 TNo2:13 ' Relative error due to formula replacement (2.13) for (2.10) (Minkina 2004): d1/4 MB yl; TSP Mb-yle; TWV c2 1/4 exp;
MB Evil; TP L TT No2:14, where Mb (I,T)P and Mb (I,T)P terms of this extension are missed. This leads to the following Formula Reilly-Jeans for the radiant exit of the black body: Mb yle; T No 1/4 c1 T | 4; W m2 mm1 : c2 No2:16' Relative function (2.10) is: d 1/4 1 i T | h c2 exp 1 : IT c2 No2:17's Wien's offset law is a derivative by equating to zero derivative function (2.10) in relation to wavelength I: () dMb ii; T d c1 1/4 0: 1/4 th2:18 dl I5 exp lc2T 1 This equation determines the wavelength of Imax, for which the radiant output of the black body at this temperature T reaches the maximum: Imax T 1/4 2898 mm K: 2:19 Maximum exit radiant predicted the law of displacement of Vienna: MB 1/4 1:286 10 11 T 5; W m 2 mm 1 : No2:20 Stefan-Boltzmann's Law defines full output for black bodies at all wavelengths. This overall output for black bodies at all wavelengths. This overall output is obtained by integrating the formula (2.10) from zero to infinity: 11/4 MB 1/4 11/4 mbps/l; Tsdl 1/4 11/40 c1 dl : exp lc2T 1 5 l1/40 No2:21 Infrared thermography 20 The final formula of Stefan-Boltzmann has the following form: p4 c1 4 T 1/4 s T 1/4 s T 1/4 c ; W m2 ; MB Evil; TK 1/4 o 15 c42 100 No2:22, where: so 1/4 p4 c1 2 p5 k4 1/4 1/4 5:670 32 0:000 71 10 8 W m2 K 4 4 15 c2 15 h3 c2 is the constant of Stefan-Boltzmann, a Co 1/4 so 108 1/4 (5.670 32 0:000 71 10 8 W m2 K 4 4 15 c2 15 h3 c2 is the constant of Stefan-Boltzmann, a Co 1/4 so 108 1/4 (5.670 32 0:000 71 10 8 W m2 K 4 4 15 c2 15 h3 c2 is the constant of Stefan-Boltzmann, a Co 1/4 so 108 1/4 (5.670 32 0:000 71 10 8 W m2 K 4 4 15 c2 15 h3 c2 is the constant of Stefan-Boltzmann, a Co 1/4 so 108 1/4 (5.670 32 0:000 71 10 8 W m2 K 4 4 15 c2 15 h3 c2 is the constant of Stefan-Boltzmann, a Co 1/4 so 108 1/4 (5.670 32 0:000 71 10 8 W m2 K 4 4 15 c2 15 h3 c2 is the constant of Stefan-Boltzmann, a Co 1/4 so 108 1/4 (5.670 32 0:000 71 10 8 W m2 K 4 4 15 c2 15 h3 c2 is the constant of Stefan-Boltzmann, a Co 1/4 so 108 1/4 (5.670 32 0:000 71 10 8 W m2 K 4 4 15 c2 15 h3 c2 is the constant of Stefan-Boltzmann, a Co 1/4 so 108 1/4 (5.670 32 0:000 71 10 8 W m2 K 4 4 15 c2 15 h3 c2 is the constant of Stefan-Boltzmann, a Co 1/4 so 108 1/4 (5.670 32 0:000 71 10 8 W m2 K 4 4 15 c2 15 h3 c2 is the constant of Stefan-Boltzmann, a Co 1/4 so 108 1/4 (5.670 32 0:000 71 10 8 W m2 K 4 4 15 c2 15 h3 c2 is the constant of Stefan-Boltzmann, a Co 1/4 so 108 1/4 (5.670 32 0:000 71 10 8 W m2 K 4 4 15 c2 15 h3 c2 is the constant of Stefan-Boltzmann, a Co 1/4 so 108 1/4 (5.670 32 0:000 71 10 8 W m2 K 4 4 15 c2 15 h3 c2 is the constant of Stefan-Boltzmann, a Co 1/4 so 108 1/4 (5.670 32 0:000 71 10 8 W m2 K 4 4 15 c2 15 h3 c2 is the constant of Stefan-Boltzmann, a Co 1/4 so 108 1/4 (5.670 32 0:000 71 10 8 W m2 K 4 4 15 c2 is the constant of Stefan-Boltzmann, a Co 1/4 so 108 1/4 (5.670 32 0:000 71 10 8 W m2 K 4 4 15 c2 is the constant of Stefan-Boltzmann, a Co 1/4 so 108 1/4 (5.670 32 0:000 71 10 8 W m2 K 4 4 15 c2 is the constant of Stefan-Boltzmann, a Co 1/4 so 108 1/4 (5.670 32 0:000 71 10 8 W m2 temperature of the Sun For calculations, it should be assumed that the maximum wavelength of the Sun's radiation, Imax, is (approximately) half of the visible range (i.e. Imax 0.50 mm) Using the Vienna Displacement Act: T 1/4 2898'0:50 5800 K: It must be emphasized that the method of calculating the temperature of the Sun's surface is approximate by half of the visible range (i.e. Imax 0.50 mm) Using the Vienna Displacement Act: T 1/4 2898'0:50 5800 K: It must be emphasized that the method of calculating the temperature of the Sun's surface is approximate by half of the visible range (i.e. Imax 0.50 mm) Using the Vienna Displacement Act: T 1/4 2898'0:50 5800 K: It must be emphasized that the method of calculating the temperature of the Sun's surface is approximate because the accuracy is not known. The exact value of this temperature can be determined by measuring the spectral radiant output of Mb (I,T) of the Sun and the application of the Law of Stefan-Boltzmann (2.22). Example 2.2 Calculate how much heat is emitted from human skin above the surface of 1 m2 and 310 K (36.9 C) Based on the Stefan-Boltzmann Act: Mb 1/4 so T 4 1/4 5:67 10 8 310'4 500 W m 2 : All laws and definitions refer to black bodies. Unfortunately, the black bodies. Unfortunately, the black body can only be seen as an idealized model of the real body. In fact, infrared thermal imaging objects are not ideal shock absorbers of random radiation - these are gray bodies. Therefore, one of the very important concepts for explaining the work of modern infrared thermal imaging is the concept of emission. It will be reviewed in the next section. 2.3 Emission 2.3.1 The main concepts The most important feature of the sufface, which affects the amount of energy emitted from it in stationary thermal conditions (fixed temperature) is its emission. If the surface whose temperature should be measured had the properties of the Planck's law (2.10). However, according to the measured had the properties of the planck law (2.10). of the density of heat flow. This is a consequence of the fact that all physical bodies have a limited ability to absorb; that is, they do not satisfy Planck's postulate with reference to the black body. Therefore, it is necessary to introduce a parameter that determines the absorbing ability of the body surface. Based on Kirchhoff's law, this is equivalent to determining the emission of the examined surface (Kreith 2000, Gaussorgues 1994, Gluckert 1992). The emission of the body over the entire range of radiation, called total emission, is the ratio of the full range of the radiant output of M(T) of this body to the full range of the radiant output MI (I,T) of the body at this wavelength I.T) the same temperature: I 1/4 MHTH : MB TK No. 2:23 Monochrome emission I is the ratio of the radiant output MI (I,T) of the body at this wavelength I.T) the same temperature and observed at the same angle: I 1/4 MHTH : MB TK No. 2:23 Monochrome emission I is the ratio of the radiant output MI (I,T) of the body at this wavelength I.T) the same temperature and observed at the same angle: I 1/4 MHTH : MB TK No. 2:23 Monochrome emission I is the ratio of monochrome emission I is the radiant output MI (I,T) of the body at this wavelength I.T) the same temperature and observed at the same angle: I 1/4 MHTH : MB TK No. 2:23 Monochrome emission I is the radiant output MI (I,T) of the body at this wavelength I.T) the same temperature and observed at the same angle: I 1/4 MHTH : MB TK No. 2:23 Monochrome emission I is the radiant output MI (I,T) of the body at the same temperature and observed at the same temperature at the same temperatu точки зрения свойств поверхностного излучения физические тела можно разделить следующим образом (Kreith 2000, Minkina 2004): . . . b(a) 1/4 tonst, (a) 1/4 const, (a) 1/4 const, (a) 1/4 var, серые тела; » a) 1/4 конста, a) & lt; 1, v(l,T) & lt; 1, venting bodies). A dissipative body is a body whose emissivity is independent of angle of observation a. Its surface satisfies the conditions of Lambert's law (so it is called a Lambertian surface). Similarly, we can define a reflective body as a body whose reflectance R is independent of angle of observation and DeWitt 1970, Touloukian and DeWitt 1972, Touloukian and DeWitt 1970, Touloukian and DeWitt 1972, Touloukian and DeWitt 1972, Touloukian and DeWitt 1972, Touloukian and DeWitt 1970, Touloukian and DeWitt 1970, Touloukian and DeWitt 1970, Touloukian and DeWitt 1970, Touloukian and DeWitt 1972, Touloukian and DeWitt 1970, need to introduce some basic laws and definitions associated with the physical aspects of optics (ASTM E 1316). Lambert's law (cosine law of optics) determines the intensity emitted in a direction normal to the surface and lba is the radiant intensity emitted at angle a to the normal to the surface. This equation states that the radiant emissivity from a Lambertian surface is directly proportional to the cosine of angle a Infrared Thermography 22 between the observer's line of sight and the normal to the surface in the surfac for dissipative bodies. For non-black bodies, formula (2.25) is satisfied only approximately, especially in the case of polished metals and for a > 50 . Отклонения обусловлены зависимостью (реальной) нечерной эмиссии тела на углу a. Светящаяся интенсивность lv является поток света в данном направлении на единицу твердого угла. Закон Ламберта имеет также в отношении светящейся интенсивности, то есть: Ива 1/4 lv? cos a; cd; No2:27 , где Ив? это светящаяся интенсивность в направлении, нормальном для поверхности. Яркость или яркость и и иглом между линией видимости наблюдателя и нормальным на поверхность (угол наблюдения). Luminance описывает субъективное впечатление яркости поверхности. С учетом (2.27), формула (2.28) принимает форму: Lv 1/4 DF DF cos a From (2.29) we see that the brightness in a normal direction. In the case of non-black bodies, usually found in reality, the brightness is almost constant for angles between zero and p/4. In addition to the angle of observation, surface emission also depends on the time of observation. This is due to emission fluctuations over time (Madura et al. 2001). It turns out that superfast thermal phenomena are accompanied by significant changes in emissions. This effect can lead to a deterioration in the accuracy of the thermal imaging methods used in superfast thermal phenomena are accompanied by significant changes in emissions. This effect can lead to a deterioration in the accuracy of the thermal imaging methods used in superfast thermal phenomena are accompanied by significant changes in emissions. This effect can lead to a deterioration in the accuracy of the thermal imaging methods used in superfast thermal phenomena are accompanied by significant changes in emissions. surface of the body is a function of the angle of observation, the wavelength of the L, the body temperature T and the
time of t: 1/4 f or; I; T; t: 2:30 In the case of translucent bodies, the emission ratio can be expressed as (Siegel 1992, Linhart and Linhart 2002). 1/4 1 1 RS1 TK 1 RT T 2:31 To make it possible to compare the properties of the material regardless of the state of its surface, sometimes used so-called specific emission of RS1 T 1 RT T 2:31 To make it possible to compare the properties of the material regardless of the state of its surface, sometimes used so-called specific emission. It is designated as 0, the total specific emission or 0 11-12 as a band of specific emission at 0 infrared thermal imaging 23 emission at 0 infrared thermal imaging 23 emission at 0 infrared thermal imaging 23 emission. It is designated as 0, the total specific emission at 0 infrared thermal imaging 23 emission at 0 infrared thermal imaging 24 emission at 0 infrared thermal i published as normal emissions, i.e. emissions are estimated on a normal surface of 1/4 0 (see table of normal emission of various materials in Annex B). Many other factors, such as the condition of the surface of an object or its homogeneity, should be taken into account in order to accuracely. This proved to be a problem in infrared thermal imaging, as establishing the exact value of the object's allowable emission in the mathematical model of the trajectory of the infrared camera measurement is important stage of each measurement is important for the correct estimate of its temperature. Thus, the assessment of the infrared camera measurement is important for the correct estimate of its temperature. methods of emission assessment. For example, Orloy (1982) proposes the following scheme: Stick to a piece of high and well-known emission (e.g., 1/4 0.95) and good thermal conductivity. or paint part of it with special paint known and high. Heat the object to a temperature, distance from the camera to the object and humidity of the atmosphere. Read the point point point point point point point point of the atmosphere temperature, distance from the camera and measure earlier atmosphere. Read the point point point point point point point point point of the object and humidity of the atmosphere. Read the point of the object and humidity of the atmosphere. Read the point po temperature of the area of the known emission. Move the spot point beyond the known emission area. Change the emission parameter of the object in the chamber and read the spot temperature of an object is to determine the temperature of the spot temperature of the known emission. A variant of this method is to determine the temperature statement. The value of the last set of parameters reflects the emission of the object. In another way, a hole at least six times its diameter was drilled on the surface. The emission factor of a high-temperature object (depending on the angle of observation a), for an arbitrary point on a curved cylinder or the emission of an arbitrary flat surface, can also be estimated in the method described below. According to a formula obtained in 1883 by C. Christiansen, heat flow is exchanged between surface 1 has an area of F1 much smaller than the F2 area of Surface 2, infrared thermography 24 is given as: F2 1 1/4 F1 1 Co T2 100 4 T1 100 4; C: 2:32 Hence the thermal flow of the black surface of the body at Tbb temperature, arriving at the camera detector at Td temperature and the Fd area, is: 4 F1 2 1/4, so Fd tbb Td4; C: Formula 2:33 (2.33) is only an approximation, as it does not take into account the geometry of camera lenses and atmospheric parameters. Heat flow emitted by the non-body point of view of dependent emission under the same conditions: 4 Td4; C: F1 2 1/4 so Fd A Tbb No 2:34 When we enter emission 1/4 1 into the chamber, it will show some temperature Ts, different (below) than Tbb. However, the same heat flow: F1 2 1/4 so Fd Ts4 Td4; W No 2:35 still arrives at the detector. Comparing the right side (2.34) and (2.35), we get the following relationship for how to function the temperature of the Td camera detector (for cameras with cooled Td detectors 70-200 K), formula (2.33) can be close to: 4 Ts : thus, the average emission in the detector's sensitivity range. For other materials, you can use one of the following approximate relationships: . . Emission of a perfectly smooth metal surface as a function of the wavelength l (relationships: . . Emission of a real metal surface as a function of the entipola surface as a function of the wavelength l (relationship has for I zgt; 2 mm; Sala 1993): 1/4 1 pffiffiffiff; 1 b 2, where b1 mm1/2 and b2 is a constant coefficient and resistiveness (W m). The emission of a real metal surface as a function of the wavelength l (relationship has for I zgt; 2 mm; Sala 1993): 1/4 1 pffiffiffiff; 1 b 2, where b1 mm1/2 and b2 is a constant coefficient and resistiveness (W m). are constant odds. Measurements in infrared thermal imaging. 25 Monochrome emission I non-conducting investigative materials compared to the refraction of nl (Michalski et al. 1998): 1/4 4nl nl No 12; No2:40, where nl 1/4 1.5-4 for inorganic compounds and 2.0-3.0 for metal oxides. Other methods for estimating emission assessment and its effect on temperature measurement Example 2.3 Experimental assessment of the surface emission of the central heating radiator (CH) in stationary heat-flowing conditions in the work of Dudz budzik (2008), was used the following procedure for assessing the emission of the surface of the panel of the coordinates of the measurement points on the surface of the heater; measuring temperature at certain points using the contact method (Minkin 1992, Minkin 1999, Minkin 1999, Minkin 1999, Minkin 1999, Minkin 1999, Minkin and Grys' 2002c) is accompanied by a simultaneous temperature recording in close proximity to the measurement points using the thermal imaging method; use the smallest square method to estimate the release of the heater surface. The photo in figure 2.4 shows a single-pamayable heater with one convective part of the normal power of 980.53 W, produced by DeLonghi. Heat-like heater Figure 2.4 A photo of the heater with installed LM35A temperature sensors Infrared thermogram with marked temperature measurement points. See Color Plate 1 for the color version presented in Figure 2.5 was recorded during the test were averaged. The heater was supplied with water at a controlled flow temperature. (48.16 0.01) C; 3 pm: (47 3) I h1. The temperature values recorded in stationary thermal conditions according to the following parameters of the heating environment (water): . . . Inflow temperature: (38.67 0.01) C; 3 pm: (47 3) I h1. The temperature values recorded in stationary thermal conditions according to the following parameters of the heating environment (water): . . . following coordinates: x1 1/4 165 pixels, y1 1/4 29 pixels, x2 1/4 165 pixels, x2 1/4 165 pixels, y2 1/4 106 pixels, x3 1/4 165 pixels, y3 1/4 185 0:002 m; in Tob1 1/4 No53:9 0:5C; sob2 1/4 32 963; for h2 1/4 0:30 0:002 m; in Tob2 1/4 0:30 0:002 m; on Tob3 1/4 40:1 0:5C; Table 2.1 Conditions for measuring infrared thermal imaging to estimate surface emission of ch heater Ambient temperature, C 20 0.2 Atmospheric Temperatu that the inputs of Tatm, To, V and D are permanent, the formula (3.17) of the temperature measurement model can be written as: T'ob 1/4 f sob; It's not like I'm going to be C; No2:41, where: The order is the temperature of the object, measured by the Tobom contact method, the emission value was determined in such a way that the measured and calculated temperatures were very similar (Minkina and Chudzik 2003): D1 1/4 TK ob1-Tob2 0 D3 1/4 Requiring the sum: g'ob No 1/4 3 X 1/2T' obi z--Toby 2; 2:43 i1/41 reaches low. The minimization (2.43) was carried out using the Nelles 2001 optimization algorithm. The values of measured and calculated temperatures using the lowest square method at the three points examined are represented in Figure 2.6. The corresponding differences between the measured and calculated temperature are shown in figure 2.7. Figure 2.6 Temperature and calculated temperatures in the three considered Limit error for emission assessment was calculated as follows: The limit error of the contact measurement was supposed to be 0.5 C (i.e. positive limiting error of contact measurement was determined by an increase in the temperature limit values of three points by 0.5 C (i.e. positive limiting error of the emission measurement) and an estimate of the new (undervalued) emission measurement was determined by a decrease in value. The positive limiting error of the emission measurement was determined by an increase in values limiting error of contact measurement was determined by an increase in values. three points to 0.5 C (i.e. negative limiting contact measurement error) and estimating the new (overrated) emission value. It should be emphasized that the worst possible measurement conditions were taken to assess the error, i.e.: . . LM35A sensors maximum margin limiting: according to the catalog, it is 0.5 C (typical error of 0.3 C) (Lieneweg 1976, Minkina and Grys' 2005); Worst distribution of error-limiting sensors: Errors for all sensors were taken with the same sign. In fact, it is unlikely that the temperature measurement at each point is burdened with the same sign (Taylor 1997, zuinn 1983). Therefore, the emission error assessed under this procedure is probably overstated. Example 2.4 How the change in the measured temperature affected the change in emission measurements in infrared thermalography 29 Figure 2.8 Infrared temperature measurement of the aluminum cylinder (cross-section Li03) and plastic (cross-section Li04) in stationary conditions. The infrared temperature for each materials: rubber (cross-section Li03) and plastic (cross-section Li03) and plas thermogram; (b) Temperature profiles; and c) a top view of the experimental installation (Minkina2004). See Color Plate 2 for the color version. Reproduced at the
resolution of Cze stochowa University of Technology The dependence of temperature measurement results on emissions and the angle of observation are clearly visible in the image and graph in figure 2.8. The thermogram shows a cylinder made of aluminum sheet ('ob 1/4 0:09), cross-section of Lio1

with stuck tapes of dielectric materials; rubber (1/4 0:95), cross-section Li02; paper (1/4 0:92), cross-section Li03; and plastic (1/4 0:87), cross-section Li04. The cylinder temperature of about 80 C. In an experiment in a microcontroller infrared camera sees a distinctly different temperature for each material. The highest temperature is shown for the rubber band, because the rubber band, because the rubber band, because the rubber band, the aluminum surface is interpreted as the steepest because the rubber band, the aluminum surface is shown for the rubber band, because the rubber band, the aluminum surface is interpreted as the largest emission of four materials. On the other hand, the aluminum surface is interpreted as the steepest because the rubber band, because the information about infrared cameras with a special reference to measuring cameras. 2.4 Measuring infrared cameras The main component of the infrared system is an infrared camera. Since the atmosphere has two bands of 2 to 5 mm and a long-wave (LW) devices. However there are 30 infrared thermal imaging detectors that work in near IR (0.78-1.5 mm), such as quantum and photo-intensive detectors containing a refrigerator block (cooling) and uncooled detectors that work in the far IR (20-1000 mm), such as thermal detectors that work in the type of detectors that work in the far IR (20-1000 mm), such as thermal detectors containing a refrigerator block (cooling) and uncooled detectors that work in the far IR (20-1000 mm), such as thermal detectors that work in the far IR (20-1000 mm), such as thermal detectors that work in the far IR (20-1000 mm), such as thermal detectors that work in the far IR (20-1000 mm), such as thermal detectors that work in the far IR (20-1000 mm) and uncooled detectors that work in the far IR (20-1000 mm), such as thermal detectors that work in the far IR (20 were equipped with detectors cooled to temperatures from 70 (seldom) to 200 C (most often). Manufacturers offer measuring IR cameras (calibrated by the manufacturer) used to measure temperature field. Visualization cameras are divided into: point (single) detectors, linear and array detectors (FPA, Focal Plane Array), built as matrixes, consisting, for example, of 640 480 individual detectors (pixels). Cameras with a single detector or line of detectors created by an optomechanical scanning prisms. The scanning frequency individual detectors (pixels). Cameras with a single detector or line of detector scanning prisms. The scanning prisms. is usually 25 Hz (50 Hz) for the PAL system in Europe, or 30 Hz (60 Hz) for the NTSC system in the United States. In one camera of the detector, an image of the observed area is built point by point at consecutive points in time. The radiant output of individual points of the image. The signals are amplified and transmitted in sync by scanning motion to the display (formerly the area) where the temperature field image (thermogram) is created. This principle of work was used for 20 years after the first camera came out. The systems had one detector, the characteristic of which determined the type of scanner and its thermal and spatial resolution, that is, its ability to distinguish the temperature in two adjacent points and the number of pixels in the thermogram respectively. Camera One detector have a unique Properties. All the rmogram points have the same parameters because the temperature at each point is measured by the same detector. This is especially important when detecting temperature differences at two points of a homogeneous object. Such a camera can perform self-calibration better before each measurement, compensating, for example, changes in the sensitivity of the detector or changes in the sensitivity of the detector or changes in the sensitivity of the detector or changes in the sensitivity of the detector. 2008). It is also easier to design and make lenses that do not introduce optical or energy distortions (De Mey 1989, De Mey and Wiecek 1998). The next step in the development of thermal imaging systems was the construction of a line of detectors and linear scanning unit, vertical or horizontal, depending on the installation of the max is the construction of a line of detectors and linear scanning unit, vertical or horizontal, depending on the installation of the detectors and linear scanning unit, vertical or horizontal, depending on the installation of the max is the construction of a line of detector set. FPA detectors. A typical array of 640,480 (matrix) is built of 307,200 individual detectors (pixels). Each pixel reads 25 (50) (pal system - Europe) or 30 (60) (NTSC - USA) once a second on roic reading. The frequency of array reading is published in directories as image frequency. Arrays containing different number of detectors are available. There are no mechanical scanning parts in the cells with array detectors: the matrix looks at the object through the optics of the camera (Figure 2.10). The development of fast array detectors has allowed the creation of cameras capable of recording superfast thermal processes, as well as to highlight a new branch of irmography. Measurements in Infrared Thermalography. Measurements in Infrared Thermalography 31 Figure 2.9 Creating a thermographic measurements in line of the creation of cameras capable of recording superfast thermal processes, as well as to highlight a new branch of irmography. Measurements in Infrared Thermalography 31 Figure 2.9 Creating a thermography at hermography. Measurements in Infrared Thermalography. Measurements in Infrared Thermalography 31 Figure 2.9 Creating a thermography. Measurements in Infrared Thermalography. Measurements in Infrared Thermalography 31 Figure 2.9 Creating a thermography. Measurements in Infrared Thermalography 31 Figure 2.9 Creating a thermography. Measurements in Infrared Thermalography. Measurement (single) detector (b), linear detector (c) Currently there are infrared systems capable of recording several hundred thermograms per second. The next step in the development of IR cameras was the introduction in 1997 of the first cameras was the introduction in 1997 of the first cameras of IR cameras built. which have become lighter, more reliable and able to operate much faster. Cooling the detector to cryogenic temperature took more than 10 minutes, while stabilizing the operating temperature in a cell without a cooler does not exceed 1 minute. Measurement and imaging ir cameras are characterized by many parameters describing the ir image and measurement properties (ASTM E 12213, ASTM E 1211). From this picture 2.10 detectors Record the thermograr in the focal plane of the array (FPA) camera: 1, camera optics; 2, array Thermography of 32 books deals with errors and uncertainties of measuring la hovakovsky (2000) and Novakovsky (2001). Below we will list and describe the most important parameters of modern measuring IR cameras. 2.4.1 Noise equivalent temperature difference (NETD) Is the difference between the temperature of the temperature of the temperature of the abserved object and the temperature difference between the temperature of the temperature of the technical black body (or test body) of Tob and the background temperature of To, divided by this difference: NETD 1/4 Un Tob To 1/4; K: DUs DUs Tob To Un No2:44' The temperature of the background temperature of the black body is usually 30 C, with a background temperature of the technical measurement area of the black body is usually 30 C, with a background temperature of the technical measurement area of the black body is usually 30 C, with a background temperature of the technical measurement area of the black body is usually 30 C, with a background temperature of the technical measurement area of the black body is usually 30 C, with a background temperature of the technical measurement area of the black body is usually 30 C, with a background temperature of the technical measurement area of the black body is usually 30 C, with a background temperature of the technical measurement area of the black body is usually 30 C, with a background temperature of the technical measurement area of the black body is usually 30 C, with a background temperature of the technical measurement area of the black body is usually 30 C, with a background temperature of the technical measurement area of the black body is usually 30 C, with a background temperature of the technical measurement area of technical measurement area of the technical measurement area of techn the detector, which results in a change in the output signal equal to the sound of the detector. NETD is determined by observing the technical black body, the temperature of which is close to the background temperature of the
technical black body, the temperature of the Do (Figure 2.11a). An example of a signal coming from a detector along line N is shown in figure 2.11b. NETD is determined when the Us signal coming from a detector along line N is shown in figure 2.11b. NETD is determined by observing the area of the technical black body, the temperature of which is close to the background temperature of which is close to the background temperature of the Do (Figure 2.11a). temperature difference, or as a minimum temperature difference for Tob and To, which can be discerned by a point (single) detector (or linear or array detector) for a given amplifier leads to a reduction in noise voltage (i.e. lower NETD), but, on the other hand, worsens spatial resolution (for example, for constant scanning speed). Circular or rectangular test fields of the stable temperature of the Tob can be used in measurements instead of the technical black body measurements in the infrared thermalography of 33 objects, the physiology of human perception or the properties of the display system. To better assess how netD is evaluated, we present below an example based on Minkina's work (2004). Example 2.5 Comparison of noise properties of two infrared systems Let's determine which of the Systems have less noise voltage Un. We assume that the values of the DUs signal detector for both cameras. Background temperature up to 22 C. Let's also assume that the values of the DUs signal detector for both cameras are given in the technical specifications: . . NETD1 1/4 0.1 K for Tob1 1/4 30 C; NETD2 1/4 0.2 K for Tob2 1/4 50 C. By formula (2.44) we get: Un 1/4 NETD DUs : Tob To 2:45' From here: Un1 1/4 Un2 NETD1 0:1 DUs 1/4 0:0125 DUs; D first range of the camera measurement, and the temperature tob of the observed object is set so that it is in the middle of that range. It is assumed that the temperature of the object, as in figure 2.11a, and find on this line an interval in which the average temperature is constant. If you specify the highest and lowest temperature specified in this Tmax and Tmin interval, respectively, NETD can be defined as: NETD 1/4 Tmax Tmin; K: 2:47 Measurements hould be repeated within a few lines. You can also choose from the thermal sites, the average temperature, it must be installed once near the bottom and then near the upper limit of the camera measurement range. Examples of NETD's relationship with Tob for the FLIR SC 3000 camera with the qWIP detector are shown in figure 2.12. Similar graphs for the SW and LW cameras are compared in 2.13a and b. In 34 Infrared Thermalography Figure 2.12 Typical NETD temperature resolution graphs compared to Tob for: a) LW Camera (1) and SW Camera (2) (IR-Book2000); (b) 760 BB Inframetric Cameras that NETD 1/4 100 mK for Tob 1/4 30 C. Notice the significant sensitivity of NETD to Tobe, especially for SW cameras. A sumed for both types of cameras that NETD 1/4 100 mK for Tob 1/4 30 C. Notice the significant sensitivity of NETD to Tobe, especially for SW cameras. A higher NETD indicates a lower sensitivity of the camera. Therefore, in the technical data of IR cameras, the NETD option is called heat sensitivity or temperature resolution. The value of the temperature resolution for different types of cameras has the following typical values: . . . 10-30 mK - for cameras with HIA detectors designed for research and development applications; 50-100 mK - for measuring cameras; 200 mK for cameras. Temperature approval procedures have not yet been standardized. Thus, the VALUES of NETD for marketing purposes. This option is freely used by camera manufacturers to assess the metrological properties of cameras. It should be noted that if the spectral characteristic of normalized detector detectability is known, the NETD option can be evaluated theoretically. However, this is a broad issue that goes beyond this monograph (Madura et al. 2004). 2.4.2 Field of View (FOV) This identifies an area that can be observed from a given distance d using optics mounted on the camera. This is a broad issue that goes beyond this monograph (Madura et al. 2004). parameter determines the spatial (geometric) resolution of the measurement ir camera. FOV is defined in meters and determines resolution in both horizontal (V) directions. Typical FOV values as d distance functions for 24 18 optics is calculated as: H 1/4 d sin24; m; V 1/4 d sin18; m2:48 2.4.3 Instant Field of View (IFOV) This defines FOV of one detector (pixel) in the array. From a practical point of view, it should be called a minimum field of view. This is the second parameter that determines the spatial (geometric) resolution of the ir-camera measurement. In technical data it is called Table 2.2 Field of View (FOV) vs. distance of a 1/4 1 m for a camera with optics 24 18 is 0.41 0.31 m (see table 2.2). If the camera has a matrix of 320,240 detectors, FOV of one Hmin Vmin detector: 0:41 0:31 1/4 1:3 mm 1:3 mm: 320 240 This means that at a distance of 1 m such as local overheating on a smaller area, but in this case the measured temperature will be underestimated. The IFOV option is proportionably, it is able to detect overheating 1.3 mm by 1.3 mm by 1.3 mm 20 240 This means that at a distance of 1 m such as local overheating 1.3 mm by 1.3 mm by 1.3 mm 20 240 This means that at a distance of 1 m such as local overheating on a smaller area, but in this case the measured temperature will be underestimated. The IFOV option is proportionable to the such as local overheating 1.3 mm by to the distance, so for d 1/4 10 m in the example above it will be 13 mm by 13 mm. Another IFOV assessment method is based on determining the optical angle of the flash radans) arad for one detector: aradH 1/4 24p 1/4 0:0013 rad; 180 320 No2:49 18p 1/4 0:0013 rad; 180 240 2:50, thus Hmin 1/4 dsin (0.0013) 1/4 1.3 mm, aradV 1/4 and Vmin 1/4 dsin (0.0013) 1/4 1.3 mm, aradV 1/4 and Vmin 1/4 dsin (0.0013) 1/4 1.3 mm. In other words, IFOV is the area to which one pixel looks through the camera optics, and determines the absolute lower size limit of the object. The camera's spatial resolution of the camera (i.e. the fewer objects it can observe). However, there are obvious limitations on the size of array detectors in pixels and the production of lenses with smaller angles (i.e. smaller FOV). The spatial resolution of the camera is usually expressed in milliradans (mrade). For example, if technical data indicates a spatial resolution is illustrated in figures 2.14a and b. It shows two cases of exposure to the array detector (pixel) calculated by formulas (2.49) and (2.50). A more detailed analysis of this situation is illustrated in figures 2.14b, the object completely irradiates at least one detector, while in figure 2.14a the object does not completely irradiate any detectors in the array. When an object is warmer than the background, its temperature will be underestimated if the detector is not completely irradiated. Otherwise, for example, when the background is warmer, the temperature of the object will be overestimated if the detector is not completely irradiated. Otherwise, for example, when the background is warmer, the temperature of the object will be overestimated. The term instant means that fulfilling the requirements of the detector is not completely irradiated. Otherwise, for example, when the background is warmer, the temperature of the object will be underestimated. reaction to the object's radiant output. Symbols in drawings 2.14c and d have the following meaning: Measurements in infrared thermal imaging 37 Figure 2.14 Image of a small object (anchor clip for the bridge connection of the high voltage anchor support line) on the array detector, allowing to correctly measure the temperature: a) no detector is completely exposed; (b) At least one detector is fully irradiated (1, object; 2, array detectors); (c) The clip thermogram registered at a long distance - about 40 meters (optical and digital zoom); (d) A short-distance clip thermogram (Minkina2001). View Colored Plate 3 for Color . . IRmax is the maximum temperature of the selected thermogram area, i.e. the maximum indication chosen from the detectors in the array; ARmax is the maximum temperature of the selected thermogram area, i.e. the maximum temperature of the selected thermogram area, i.e. the maximum indication chosen from the detectors in the array; ARmax is the maximum temperature of the selected thermogram area, i.e. the maximum temperature of the selected thermogram area, i.e. the maximum indication chosen from the detectors in the array; ARmax is the maximum temperature of the selected thermogram area, i.e. the maximum indication chosen from the detectors in the array; ARmax is the maximum temperature of the selected thermogram area, i.e. the maximum indication chosen from the detectors in the array; ARmax is the maximum temperature of the selected thermogram area, i.e. the maximum indication chosen from the detectors in the array; ARmax is the maximum temperature of the selected thermogram area (maximum temperature of the selected thermogram area readings in the selected area. Figures of 2.14c and d IRmax 1/4 ARmax show that the location of maximum temperature the renograms is correct. From figure 2.14b, it can be concluded that to correctly measure the temperature thermograms is correct. From figure 2.14b, it can be exposed to at least 2 pixels (then at least one detector is completely irradiated). In practice, this may not be enough if the shape of the object is not square or rectangular. In addition, each real optics distorts the image. These distortions are the result, for example, of chromatic and/or spherical aberration and many other optics imperfections - figure 2.15. They can be described in a simple way by the uniform distribution function (PSF). One of the popular models is given as: x2 and y2; 2:51 PSF'x; y' 1/4 exp 2s2 38 Infrared thermography Figure 2.15. Determining the size of the measurement area:
(a) ideal optics - irradiation area 2 detectors needed for correct measurement; (b) Real optics, blur of images - irradiation of area 3 3 or 4 4 (sometimes 5 5) detectors needed for correct measurement (Danjoux2001, Minkina2004). See Color Plate 4 for the color version, where s is the setting for the optical system's point response (spatial resolution) in milliradians. Its typical values: . . s 1/4 0.5 mrad for better spatial resolution measuring chambers; s 1/4 1.0 mrad for better spatial resolution imaging cameras. The Slit Response Function (SRF) is a parameter that, like IFOV, describes the ability of an array detector camera to measure the temperature of small objects. Figure 2.16 has three situations that can occur when observing a black body to The tobe temperature through a vertical slit. The surface area of the black body seen by one detector is designated by IFOV. The tobe temperature to responds to the sobbing signal from the detector. The measurement field is gradually covered by the temperature diaphragm to co-sing to the signal so from the detector. The sobbing value changes (decreases) as the slit width decreases) as the slit width decreases d. Left parts of the value is roughly equal to the ratio of the value is roughly equal to the ratio of the arad flash) for one detector defined (2.49) and (2.50). The arad value is roughly equal to the ratio of the value is roughly equal to the ratio of the value is roughly equal to the ratio of the arad flash) for one detector defined (2.49) and (2.50). The arad value is roughly equal to the ratio of the value is roughly equal to the ratio of the value is roughly equal to the ratio of the value is roughly equal to the ratio of the value is roughly equal to the value is roughly equa describes the ideal case, and graph 2 describes a real case, given that both optics and cameras (curve 3) is shown in figure 2.17b. We can see that the value of the angular arada corresponding to 50% modulation is much smaller for measuring cameras (curve 3) is shown in figure 2.17b. We can see that the value of the angular arada corresponding to 50% modulation the response compared to the optical flash angle of a single detector for measuring cameras (curve 3) is shown in figure 2.17b. We can see that the value of the angular arada corresponding to 50% modulation is much smaller for measuring cameras (curve 3) is shown in figure 2.17b. We can see that the value of the angular arada corresponding to 50% modulation is much smaller for measuring cameras (curve 3) is shown in figure 2.17b. We can see that the value of the angular arada corresponding to 50% modulation is much smaller for measuring cameras (curve 3) is shown in figure 2.17b. chambers, the function of the slit reaction is steeper. Taking into account the observations we made when discussing the IFOV (IR enter the value of 90% means that the measurements in infrared thermal imaging 39 Figure 2.16 The response detector is sobbing compared to observing a slit width d. The size of the object is IFOV (IR enter the value of 90% means that the measurements in infrared thermal imaging 39 Figure 2.16 The response detector is sobbing compared to observations we made when discussing the IFOV (IR enter the value of 90% means that the measurements in infrared thermal imaging 39 Figure 2.16 The response detector is sobbing compared to observations. Book2000). Reproduced with the permission of the ITC Flir Systems detector, the signal is 10% too small; that is, the specified temperature is underestimated by 10%. This is too great and unacceptable value of the angle of the The above observations on the characteristics of the modulation of the slit reaction function confirm an earlier conclusion that to ensure the correct temperature measurement Figure 2.17 The characteristics of the modulation of the slit reaction function confirm an earlier conclusion that to ensure the correct temperature measurement Figure 2.17 The characteristics of the modulation of the slit reaction function confirm an earlier conclusion that to ensure the correct temperature measurement Figure 2.17 The characteristics of the modulation of the slit reaction function confirm an earlier conclusion that to ensure the correct temperature measurement Figure 2.17 The characteristics of the modulation of the slit reaction function confirm an earlier conclusion that to ensure the correct temperature measurement Figure 2.17 The characteristics of the modulation of the slit reaction function confirm an earlier conclusion that to ensure the correct temperature measurement Figure 2.17 The characteristics of the modulation of the slit reaction function confirm an earlier conclusion that to ensure the correct temperature measurement Figure 2.17 The characteristics of the modulation of the slit reaction function confirm an earlier conclusion that to ensure the correct temperature measurement Figure 2.17 The characteristics of the modulation of the slit reaction function confirm an earlier conclusion that to ensure the correct temperature measurement figure 2.17 The characteristics of the modulation of the slit reaction function confirm an earlier conclusion temperature measurement figure 2.17 The characteristics of the modulation of the slit reaction function confirm an earlier conclusion temperature measurement figure 2.17 The characteristics of the modulation of the slit reaction function temperature measurement figure 2.17 The characteristics of the modulation of the slit reaction function temperature measurement figure 2.17 The characteristics of the modulation temperature measurement figure 2.17 The characteristics o Reproduced at the resolution of Cze stochowa University of Technology 40 Infrared thermography with the camera of this spatial resolution, defined by the IFOV parameter, the size of the object should not be less than 3 3 to 5 5 IFOV. These parameters are very important for accurate temperature measurement with an IR camera. Another very important for accurate temperature measurement with an IR camera. a programmed algorithm, which in turn is developed on the basis of a mathematical model of measurement. In the next chapter, we will discuss in detail both the measurement trajectory algorithm Way Processing Algorithm Way Processing information in measurement. 3 Infrared Camera Processing Algorithm Is important for assessing the uncertainty of measurement in the thermal imaging method. This algorithm determines how measurement data is derived from detector; calibration or mapping (i.e. linearity and temperature compensation of signals from individual array detectors); . . . Detection of infrared radiation in the array detector; calibration or mapping (i.e. linearity and temperature compensation of infrared radiation in the array detectors); . . . Detection of infrared radiation in the trajectory of the infrared radiation in the array detector; calibration or mapping (i.e. linearity and temperature compensation of signals from individual array detectors); processing compensated signals by the camera measurement algorithm according to the appropriate measurement model. The first component in the thermograph measurement trajectory, whether it is a scanner or an infrared detectors. It is often also proposed to divide into chilled and non-cooled (working at ambient temperature). Until 1997, all manufactured infrared cameras were equipped with detectors are matrixes, for example, 640 480 single detectors (pixels) and are standard today. Infrared thermography: Mistakes and uncertainties 2009 By John Wylie and Sons, Ltd Waldemar Minkina and Sebastian Dudzik 42 Infrared thermography Figure 3.1a Spectral transmission of he most common gases (Minkina 2004). Reproduced by permission of the most common gases (Minkina 2004). on the wavelength of radiation (Figure 3.1) (DeWitt 1983, Schael and Rothe 2002). Therefore, infrared devices work in the ranges of the maximum possible transmission, so, traditionally, two types of detectors operating in the 8-5 mm range; Longwave (LW) detectors operating in the 8-5 mm range of the maximum possible transmission, so, traditionally, two types of detectors differ most often: . . Short-wave (SW) detectors operating in the 8-5 mm range; Longwave (LW) detectors operating in the 8-5 mm range of the maximum possible transmission, so, traditionally, two types of detectors differ most often: . . Short-wave (SW) detectors operating in the 8-5 mm range; Longwave (LW) detectors operating in the 8-5 mm range of the maximum possible transmission, so, traditionally, two types of detectors differ most often: . . Short-wave (SW) detectors operating in the 8-5 mm range; Longwave (LW) detectors operating in the 8-5 mm range; Longwave (LW) detectors operating in the 8-5 mm range of the maximum possible transmission, so, traditionally, two types of detectors differ most often: . . Short-wave (SW) detectors operating in the 8-5 mm range; Longwave (LW) detectors operating in the 8-5 mm range; Longwave (LW) detectors operating in the 8-5 mm range; Longwave (LW) detectors operating in the 8-5 mm range; Longwave (LW) detectors operating in the 8-5 mm range; Longwave (LW) detectors operating in the 8-5 mm range; Longwave (LW) detectors operating in the 8-5 mm range; Longwave (LW) detectors operating in the 8-5 mm range; Longwave (LW) detectors operating in the 8-5 mm range; Longwave (LW) detectors operating in the 8-5 mm range; Longwave (LW) detectors operating in the 8-5 mm range; Longwave (LW) detectors operating in the 8-5 mm range; Longwave (LW) detectors operating in the 8-5 mm range; Longwave (LW) detectors operating in the 8-5 mm range; Longwave (LW) detectors operating in the 8-5 mm range; Longwave (LW) detectors operating in the 8-5 mm range; Longwave (LW) detectors operating in the 8-5 mm range; Longwave (LW) d 14 mm range. Figure 3.1b Changes in the atmospheric transmission of T Tatm for different distance values from camera to object d (Minkina 2004).
Reproduced by resolution of Cz e stochowa technology industry. Hundreds of original publications, surveys and patents are produced each year on this issue. The main types of heat detectors are listed below. Bolometric detectors are resistors with very little heat intensity and a large negative temperature resistance factor. As with the termistors, this ratio is defined as: at 1/4 1 dRT B 1/4 2: RT dT T No3:1' Measured infrared radiation changes bolometric bolometric below the termistors, this ratio is defined as: at 1/4 1 dRT B 1/4 2: RT dT T No3:1' Measured infrared radiation changes bolometric below the termistors, this ratio is defined as: at 1/4 1 dRT B 1/4 2: RT dT T No3:1' Measured infrared radiation changes bolometric below the termistors, this ratio is defined as: at 1/4 1 dRT B 1/4 2: RT dT T No3:1' Measured infrared radiation changes bolometric below the termistors, this ratio is defined as: at 1/4 1 dRT B 1/4 2: RT dT T No3:1' Measured infrared radiation changes bolometric below the termistors, this ratio is defined as: at 1/4 1 dRT B 1/4 2: RT dT T No3:1' Measured infrared radiation changes bolometric below the termistors, this ratio is defined as: at 1/4 1 dRT B 1/4 2: RT dT T No3:1' Measured infrared radiation changes bolometric below the termistors, this ratio is defined as: at 1/4 1 dRT B 1/4 2: RT dT No3:1' Measured infrared radiation changes bolometric below the termistors, this ratio is defined as: at 1/4 1 dRT B 1/4 2: RT dT No3:1' Measured infrared radiation changes bolometric below the termistors, this ratio is defined as: at 1/4 1 dRT B 1/4 2: RT dT No3:1' Measured infrared radiation changes bolometric below the termistors, this ratio is defined as: at 1/4 1 dRT B 1/4 2: RT dT No3:1' Measured infrared radiation changes bolometric below the termistors, this ratio is defined as: at 1/4 1 dRT B 1/4 2: RT dT No3:1' Measured infrared radiation changes bolometric below the termistors, the termistors at 1/4 1 dRT B 1/4 2: RT dT No3:1' Measured infrared radiation changes bolometric below the termistors at 1/4 1 dRT B 1/4 2: RT dT No3:1' Measured infrared radiation changes bolometric below the termistors at 1/4 1 dRT B 1/4 2: RT dT No3:1' Measured infrared radiation changes bolometric below th bolometers are also manufactured. The structure of one pixel of an uncooled array detector (microbolometer) is really ingested in figure 3.2. The detector absorbs infrared wavelength | 1/4 8-14 mm. Microbridge is supported by two metal pins fixed in a silicon base. The pins work also as thermometer connectors with the ROIC system. This layer works Figure 3.2. (a) The structure of one pixel: 1, insulation section; 2, metal pin; 3, metal washer of the ROIC chain (integrated reading scheme); 4, roIC chains; 5, reflecting layer. (b) Block signal processing chart. (c) Image of a scanning electron microscope (Tissot et al. 1999) Infrared thermography 44 as a 2.5% K1 sensitivity thermometer, which does not significantly absorb radiation. The radiation is absorbed by a very thin (8 nm) reactively deferred film of titanium nitride. The the rmal insulation layer (1.2107 K W1) insulates the thermometer from the reading circuit. The role of the reflector (aluminium layer) placed on the surface of roIC is to reflect the infrared radiation that penetrated the microbridge back to the thermometer. The size of one pixel shown in figure 3.2 is 50 mm. The entire reading cycle takes 40ms. The array detector is a matrix of 256 64 pixels. The signal is read by multiplexing each pixel into the ROIC system. The entire reading cycle takes 40ms. The reading frequency is 25 or 50 Hz for the PAL signal (European standard) and 30 or 60 Hz for the NTSC signal (US standard). Microbolometry detectors work at room temperature (i.e. 300 K) stabilized with Peltier cooler. Therefore, unlike detectors are built as a frequency is 25 or 50 Hz for the PAL signal (European standard) and 30 or 60 Hz for the NTSC signal (US standard). Microbolometry detectors work at room temperature (i.e. 300 K) stabilized with Peltier cooler. thermopyl, that is, a system of thermal elements connected in a row. The measuring node is connected to a photo sensitive element illuminated by infrared radiation. The active surface temperature of the connection generates thermoelectric power: E 1/4 kT1 to th; No3:2 where (T1 To) is the difference in connection temperature (K) and to thermoelectric ratio (mV K1). Pyrolectric detectors are built from semiconductors that have the so-called pyroelectric effect. Below the temperature of Curie TC (Figure 3.3) any change detector causes it to change its charge that produces an electric current that can be measured by the so-called pyroelectric effect is charge that produces an electric current that can be measured by the so-called pyroelectric effect is charge that produces an electric current that can be measured by the so-called pyroelectric effect is charge that produces an electric current that can be measured by the so-called pyroelectric effect is charge that produces an electric current that can be measured by the so-called pyroelectric effect is charge that produces an electric current that can be measured by the so-called pyroelectric effect is charge that produces an electric effect is charge that produces an electric current that can be measured by the so-called pyroelectric effect is charge that produces an electric effect. field, the pyroelectric effect can be increased to a value proportional (depending on temperature) to the electric figure 3.3 Spontaneous polarization of the P pyrolectric detector compared to the technological algorithm of infrared camera processing Path 45 permissibility m (T) dielectric. This is called field amplification of pyroelectric effect or bolometric ferroelectric effect. Pyroelectric p ratio is described as: qE p 1/4 po 0 qm dE; qT No3:3, where: po is a pyroelectric coefficient without polarization; m is an absolute electrical permissibility (F m1); and E is the intensity of the electrical permissibility (F m1); and E is the intensity of the electric field (V m1). Pyrolectric detectors. Therefore, special apertures vibrating at a frequency of 25 (30) or 50 (60) Hz should be used in infrared cameras with pyroelectric detectors to compare the level of radiation incident on two adjacent detectors are sometimes used as motion sensors. They are also manufactured as non-cooled detectors are the second type of infrared detectors. They can be divided into the following subtypes. Photoconducting detectors (photo-tester or photoconducting cells) are detectors with so-called internal photovoltaic emission. The infrared radiation that falls on the direction plate. Typically, the cross geometry of photo-tester or photoconducting cells) are detectors with so-called internal photovoltaic emission. The infrared radiation that falls on the direction plate. of the polarizing current. Changing the drop in the voltage of the resistor, connected in a series with a detector, is a measured signal. In the case of high-resistance detectors, a permanent voltage pattern is preferable. The measured signal is then current in the detector chain. Photovoltaic detectors, a permanent voltage pattern is preferable. The measured signal is then current in the detector, is a measured signal. In the case of high-resistance detectors, a permanent voltage pattern is preferable. The photovoltaic effect occurs with so-called internal photovoltaic detectors, a permanent voltage pattern is preferable. when excess media are inserted near barriers. Barriers can be photodiodes with intersections p-n or Schottky. Photo-media detectors are with so-called external photovoltaic radiation. In this case, the electrons are thrown away photo-angled material from photons of incidents and emitted outwards. Photons are absorbed by photocamodic material, deposited on a special basis, which is often transparent to the radiation of the incident. Detectors based on quantum wells were developed by ATT in the early 1990s. Their structure is built of thin foil AlGaAs and GAAs. To ensure optimal operating cooling to a temperature of 203 C (70 K) is required, which is more than conventional cooled detectors with a temperature resolution of 20-40 mK. For this reason, they are used for cooling. The quantum detectors that require 196 C (77 K). Stirling coolers built in Dewar flasks are used for cooling. The quantum detectors with a temperature resolution of 20-40 mK. For this reason, they are used for cooling to a temperature of 203 C (70 K) is required, which is more than conventional cooled detectors with a temperature resolution of 20-40 mK. used mainly in complex scientific studies. They have the best spectral detectability in the narrow subband (1 mm wide) of the LW range, from 8 to 9 mm. Another characteristic of these detectors is the relatively high homogeneity of individual elements (pixels) in the array. Images can be recorded with a 14-bit resolution speaker (i.e. 214 1/4 16,384 quantitative level) of an analog digital converter. Information about the main features of photo detectors is presented in table 3.1 (Rogalski 2003). Infrared Thermography 46 Table 3.1 Highlights photonactor detector type Carrier arousal Electricity, Photoconductivity, Photoconductivity, Photovoltaic Conductivity, Photovoltaic, HgCdTe Si, InSb, HgCdTe Si, InSb, HgCdTe Si, InSb, HgCdTe Si:In, Si:Ga, Ge:Cu GaAs/CSO, PtSi GaAs/AlGaAs InAs/InGaSb Since infrared detection is the first operation performed by measuring the infrared detectors The main parameters of infrared detectors were described, for example, in monographs (Rogalski 2000), Rogalski 2003) and in the works of Breiter et al. (2000), Breiter et al. (2002), Tissot et al. (1999) and Minkina et al(2000). The parameters that are most important for the accuracy of the infrared camera measurement trajectory are discussed below. Voltage or the infrared detectors, spectral sensitivity is given as sensitivity to black
body radiation at a certain temperature, usually 500 K. Sensitivity temperature is a parameter, determines the change of signal per unit of the mereature of the constant time of the constan maximum frequencies of the fastest thermal detectors do not exceed several hundred hertz. Photon detectors are much faster. Their limit frequency reaches several hundred megahertz. The constant time of the detectors are much faster. Their limit frequency reaches several hundred hertz. superfast photofinders. Noise equivalent power (NEP) is an RMS power incident monochrome radiation wavelength I, which generates output voltage, the value of the unit at the exit of the noise voltage is proportional to the square root of noise bandwidth. In other words, it is the radiation force needed to obtain a signal factor to the noise level normalized for a unit of bandwidth. In other words, it is the radiation force needed to obtain a signal factor to the noise of the unit at the exit of the unit at the exit of the noise level normalized for a unit of bandwidth. In other words, it is the radiation force needed to obtain a signal factor to the noise of the unit at the exit of the unit at the unit at the exit of the unit at No3:4, where the Fd is an active detector surface (cm2) and Df frequency bandwidth (Hz). The D detector index is linked to the surface of the detectability determines the signal-to-noise ratio normalized relative to the frequency bandwidth used and the active surface of the detector for random thermal radiation of the unit energy. The more detectability and the wider the bandwidth of the frequency used, the better the detector. Photos of the approximate array detectors used in THERI infrared cameras (www.flir.com, pl, www.flir.com, pl, www.flir.co temperature signals from individual detectors (pixels) called calibration of the array or mapping (Minkina 2004, Novakovsky 2001, IR-Book 2000). 3.1.3 Processing The array camera measurement algorithm consists of up to several hundred thousand pixel detectors. Each of them has, in different treatment characteristics: sj 1/4 f 'Mj; No3:5 where sj is a output signal and Mj radiation intensity. The distribution of the array or mapping (Minkina 2004, Novakovsky 2001, IR-Book 2000). 3.1.3 Processing The array camera measurement algorithm consists of up to several hundred thousand pixel detectors. Each of them has, in different treatment characteristics: sj 1/4 f 'Mj; No3:5 where sj is a output signal and Mj radiation intensity. The distribution of processing the array or mapping (Minkina 2004, Novakovsky 2001, IR-Book 2000). 3.1.3 Processing The array camera measurement algorithm consists of up to several hundred thousand pixel detectors. array. When the camera is turned on, the detectors are not calibrated. This condition is illustrated by the example of the thermogram Figure 3.4 Array Detectors (FPA) used in cameras from FLIR: (a) an uncooled microbolometer with thermogram Figure 3.4 Array Detectors (FPA) used in cameras from FLIR: (a) an uncooled microbolometer with thermogram Figure 3.4 Array Detectors (FPA) used in cameras from FLIR: (a) an uncooled microbolometer with thermogram Figure 3.4 Array Detectors (FPA) used in cameras from FLIR: (a) an uncooled microbolometer with thermogram Figure 3.4 Array Detectors (FPA) used in cameras from FLIR: (a) an uncooled microbolometer with thermogram Figure 3.4 Array Detectors (FPA) used in cameras from FLIR: (b) and the cameras from FLIR: (c) and the cam III. See Color Plate 5 for Color 48 Infrared Thermography Figure 3.5 Termogram from uncalibrated camera and calibration of static characteristics of pixel detector; sj, jth detector; sj, jth detector signal output) (WIP Seminar 2000). Reproduced with the permission of ITC Flir Systems, shown in figure 3.5b. To measure the detectors correctly, the detectors must be calibrated according to the same I/O (Figure 3.5c). The calibration is automatic every time you turn on the power. It takes place in three stages of all static characteristics to the same Ds (Figure 3.5b) range-long A/D converter used in the ROIC camera circuit. Typically, its resolution is 12 or 16 bits. Step II - by equalizing the tilt ratios of the aja characteristics (Figure 3.5b). Step III is the correction of all static processing characteristics to the same (figure 3.5c), so that the average point of this T1-T2 camera measurement range of the DS A/D. The camera measurement range of the DS A/D. The camera microcontroller recalculates the signal values from the calibrated detector array to the T temperature according to the measurement model described in section 3.2. To do this you need to evaluate the calibration constants R, B, F. Assessment of these calibration constants is carried out individually for each part of the camera. This procedure is described in section 4.2. To estimate the effect of thermal self-radiation of the camera, the reference temperature of the camera. This procedure is described in section 4.2. processing characteristics described above (Figure 3.5). Compensation is made using the infrared camera measurement algorithm Processing Path 49 by Formula (TOOLKIT IC2): absPixel 1/4 globalGain LFunc'imgPixel 3:6, where: absPixel 1/4 globalGain And globalOffset are constants that correspond to the parameters of the instrument amplifiers of the measurement path. The linear LFunc function is based on two factors: Obas, the basic offset used in nonlinearity of untreated pixel value. Another important task of the processing algorithm, in addition to estimating the constant linearity of untreated pixel values. LFunc function is based on two factors: Obas, the basic offset used in nonlinearity of untreated pixel value. temperature for each pixel, is to display the recorded thermogram as a color image. To get an image of the temperature field, the camera performs a visualization procedure that assigns temperature for processing the thermogram on the PC. Below, we describe the color imaging algorithm used in the temperature field, the camera performs a visualization algorithm should perform such a solored assignment in both the camera and the software for processing the temperature field, the camera and the software for maging algorithm used in the temperature field. original TermoLab software, which works with FLIR cameras. TermoLab is a thermal analysis system (Minkina et al. 2002, Minkina et al. 2003), whose algorithm uses radiometric data stored in a thermal file (.img) created by AGEMA/FLIR. The AFF file includes a table of 16 values describing the distribution of colors in the thermogram. Two coloring methods are shown in drawings 3.6 and 3.7. The first - isothermal algorithm - is used internally in the camera, the second - the histogram algorithm - is used by the software TermoLab (TOOLKIT IC2, Dudzik 2000). The histogram algorithm - is used by the software TermoLab (TOOLKIT IC2, Dudzik 2000). The histogram algorithm - is used by the software TermoLab (TOOLKIT IC2, Dudzik 2000). The histogram algorithm - is used by the software TermoLab (TOOLKIT IC2, Dudzik 2000). thermogram file. Next, each pixel is filtered using the destination algorithm, which allows you to calculate the corresponding index in the color map (table coloring). The final step is the 3.6 Isothermal Coloring Algorithm used in FLIR (TOOLKIT IC2) infrared thermography 50 Figure 3.7 Histogram Coloring Algorithm used in FLIR (TOOLKIT IC2) infrared thermography 50 Figure 3.7 Histogram Coloring Algorithm used in FLIR (TOOLKIT IC2) infrared thermography 50 Figure 3.7 Histogram Coloring Algorithm used in FLIR (TOOLKIT IC2) infrared thermography 50 Figure 3.7 Histogram Coloring Algorithm used in FLIR (TOOLKIT IC2) infrared thermography 50 Figure 3.7 Histogram Coloring Algorithm used in FLIR (TOOLKIT IC2) infrared thermography 50 Figure 3.7 Histogram Coloring Algorithm used in FLIR (TOOLKIT IC2) infrared thermography 50 Figure 3.7 Histogram Coloring Algorithm used in FLIR (TOOLKIT IC2) infrared thermography 50 Figure 3.7 Histogram Coloring Algorithm used in FLIR (TOOLKIT IC2) infrared thermography 50 Figure 3.7 Histogram Coloring Algorithm used in FLIR (TOOLKIT IC2) infrared thermography 50 Figure 3.7 Histogram Coloring Algorithm used in FLIR (TOOLKIT IC2) infrared thermography 50 Figure 3.7 Histogram Coloring Algorithm used in FLIR (TOOLKIT IC2) infrared thermography 50 Figure 3.7 Histogram Coloring Algorithm used in FLIR (TOOLKIT IC2) infrared thermography 50 Figure 3.7 Histogram Coloring Algorithm used in FLIR (TOOLKIT IC2) infrared thermography 50 Figure 3.7 Histogram Coloring Algorithm used in FLIR (TOOLKIT IC2) infrared thermography 50 Figure 3.7 Histogram Coloring Algorithm used in FLIR (TOOLKIT IC2) infrared thermography 50 Figure 3.7 Histogram Coloring Algorithm used in FLIR (TOOLKIT IC2) infrared thermography 50 Figure 3.7 Histogram Coloring Algorithm used in FLIR (TOOLKIT IC2) infrared thermography 50 Figure 3.7 Histogram Coloring Algorithm used in FLIR (TOOLKIT IC2) infrared thermography 50 Figure 3.7 Histogram Coloring Algorithm used in FLIR (TOOLKIT IC2) infrared thermography 50 Figure 3.7 Histogram C by the color defined in the color map used. Pixels create a thermogram of images displayed on a camera or computer monitor. Examples of enlarged images from the 4 a array detector for different color maps are shown in Figure 3.8. In smaller Pixel scales give the impression of a continuous image. A suitable selection of color cards can generate Opportunities. For example, you can create images that represent invisible bands of radiation (e.g. ultraviole selection of color cards can generate Opportunities. For example, you can create images that represent invisible bands of radiation (e.g. ultraviole selection of color cards can generate Opportunities. infrared, X-rays, etc.), but we need to keep in mind that colors are normal. This visualization method is called pseudocolrisization because the selected sets of colors are produced as a
mixture of three main colors with a 3.8 enhanced digital image for different color map RGB (red, green, blue). Intermediate colors are not really related to measured values or perceived by humans. The method of pseudo-colorization because the selected sets of colors are not really related to measured values or perceived by humans. maps: (a) gray scale; (b) Cool; (c) Hot; HSI (Intensity of Shade Saturation); Spring; (f) Summer; Autumn; (h) Winter. See Color Plate 6 for the color version of the Infrared Camera Measurement Processing Algorithm Way 51 corresponding weights r, g, b. Each weight sr, g, b. Each weight sof the main colors R, G, B. To present the image using RGB components requires three matrixes with stored weights r, g, b. Each weight sof the main colors R, G, B. To present the image using RGB components requires three matrixes with stored weights r, g, b. Each weight sof the main colors R, G, B. To present the image using RGB components requires three matrixes with stored weights r, g, b. Each weight sof the main colors R, G, B. To present the image using RGB components requires three matrixes with stored weights r, g, b. Each weight soft the main colors R, G, B. To present the image using RGB components requires three matrixes with stored weights r, g, b. Each weight soft the main colors R, G, B. To present the image using RGB components requires three matrixes with stored weights r, g, b. Each weight soft the main colors R, G, B. To present the image using RGB components requires three matrixes with stored weights r, g, b. Each weight soft the main colors R, G, B. To present the image using RGB components requires three matrixes with stored weights r, g, b. Each weight soft the main colors R, G, B. To present the image using RGB components requires three matrixes with stored weights r, g, b. Each weight soft the main colors R, G, B. To present the image using RGB components requires the matrixes with stored weights r, g, b. Each weight soft the main colors R, G, B. To present the matrixes with stored weight soft the matrixes weigh and their amount can be from 0 to 1. Computer systems make it easier to store integrative values, so 1 byte (i.e. 8 bits) are represented by weights. This allows you to represent 28 1/4 256 shades of each color component. Overall, the 3 byte format, 24 bits of RGB allows for representation (28)3 1/4 256 256 1/4 16 777 216 colors. There are also advanced RGB formats that use 32 bits for color coding. In an 8-bit grey scale, the scales of color components are equal, r 1/4 g 1/4 b, so you can imagine 256 shades of gray. Most thermogram programs, like the TermoLab package above, allow you to identify users' color maps (Dudzik 2007). However, when choosing colors, you should consider that some colors, you should consider that some colors have an additional meaning: for example, red is used for warning. We must re-emphasize the distinction between the thermogram - the data matrix from the array detector - and the image - by a graphic presentation of data using a color map or a gray scale. In addition to the gray scale, thermography most often uses the following precisely defined color cards, such as glowbow, gray, medical, midgreen, midgray or yellow, are used less frequently. An alternative form of thermogram for a given color cards, such as glowbow, gray, medical, midgreen, midgray or yellow, are used less frequently. An alternative form of thermogram presentation is a 3D graph. The height of the bar in the third dimension is proportional to the temperature of the corresponding pixel. The equivalent of a pixel on a 3D thermogram is called a hoksel (volume pixel). A 3D presentation can be more useful for quality heat evaluation. Additional measurement also represent the time. Useful when changes quickly and it is difficult to investigate changes on numerous sets of thermograms recorded in the measurement sequence. The size of the thermogram (in pixels) can be larger than the original size of the detector array due to either interpolation, which generates a larger matrix (Nowakowski 2001, B a bka and Minkina 2002a b, B bka and Minkina 2003a). A detailed discussion of digital thermogram processing goes beyond this book. More information on this issue can be found in Nowakowski (2001), for example. The final work of the infrared system algorithm measures the way the compensated signal is processed in the surface temperature assessment using the infrared system algorithm measures the way the compensated signal is processed in the surface temperature. The basis of this processing is a mathematical model of measurement with an infrared system algorithm measures the way the compensated signal is processed in the surface temperature assessment using the infrared system algorithm measures the way the compensated signal is processed in the surface temperature assessment using the infrared system algorithm measures the way the compensated signal is processed in the surface temperature assessment using the infrared system algorithm measures the way the compensated signal is processed in the surface temperature assessment using the infrared system algorithm measures the way the compensated signal is processed in the surface temperature assessment using the infrared system algorithm measures the way the compensated signal is processed in the surface temperature assessment using the infrared system algorithm measures the way the compensated signal is processed in the surface temperature assessment using the infrared system algorithm measures the way the compensated signal is processed in the surface temperature assessment using the infrared system algorithm measures the way the compensated signal is processed in the surface temperature assessment using the infrared system algorithm measures system depends heavily on the error of the method caused by the measurement model used. The following section focuses on this issue. 3.2 Mathematical measurement model with infrared camera theory of thermal radiation of bodies (Schuster and Kolobrodov 2000, Stahl and Miosga 1986, Walter and infrared thermography 52 Gerber 1983). In the mathematical measurement, the method caused by the measurement model used. The following section focuses on this issue. 3.2 Mathematical measurement model used. following thermal flows entering the infrared detector (Minkina 2004, Minkin and B ba 2002) should be taken into account: . . . The wob stream emitted by the subject The wrefl stream emitted by the atmosphere; The flow emitted by the subject The wrefl stream emitted by the atmosphere; The flow emitted by the subject The wrefl stream emitted by the subject at the most recent models, its impact on measurement is considered insignificant. These threads can be expressed as: wob 1/4 ob T Tatm Tatm Mob Tob; No3:9a'wrefl 1/4 1/21 Ob' K'O K T Tatm Atm Mo 3:9b'watm 1/4 1/21-Patm Athm Atm th; No3:9c, where: about is the emission band of the surrounding; Matm, Mob, Mo are a radiant outlet from the atmosphere, object and environment, respectively (W m2); TTatm is a band of air transmission; Tatm, Tobe, To be the temperature of the atmosphere, object and environment, respectively (W m2); TTatm is a band of air transmission; Tatm, Tobe, To be the temperature of the atmosphere, object and environment, respectively (W m2); TTatm is a band of air transmission; Tatm, Tobe, To be the temperature of the atmosphere, object and environment, respectively (W m2); TTatm is a band of air transmission; Tatm, Tobe, To be the temperature of the atmosphere, object and environment, respectively (W m2); TTatm is a band of air transmission; Tatm, Tobe, To be the temperature of the atmosphere, object and environment, respectively (W m2); TTatm is a band of air transmission; Tatm, Tobe, To be the temperature of the atmosphere, object and environment, respectively (W m2); TTatm is a band of air transmission; Tatm, Tobe, To be the temperature of the atmosphere, object and environment, respectively (W m2); TTatm is a band of the surrounding; Matm, Mob, Mo are a radiant outlet from the atmosphere, object and environment, respectively (W m2); TTatm is a band of the surrounding; Matm, Mob, Mo are a radiant outlet from the atmosphere, object and environment, respectively (W m2); TTatm is a band of the surrounding; Matm, Mob, Mo are a radiant outlet from the atmosphere, object and environment, respectively (W m2); TTatm is a band of the surrounding; Matm, Mob, Mo are a radiant outlet from the atmosphere, object and environment, respectively (W m2); TTatm is a band of the surrounding; Matm, Mob, Mo are a radiant outlet from the atmosphere, object and environment, respectively (W m2); Ttatm is a band of the surrounding; Matm, Mob, Mo are a radiant outlet from the atmosphere, object and environment, respecti environment, respectively (K). A diagram illustrating the interaction of heat flows is shown in Figure 3.9. The output signal from the camera detector can be described by the formula: s C'wob and wodb s watm; Figure 3.9. The output signal from the camera detector can be described by the formula: s C'wob and wodb s watm; Figure 3.9. The output signal from the camera detector can be described by the formula: s C'wob and wodb s watm; Figure 3.9. The output signal from the camera detector can be described by the formula: s C'wob and wodb s watm; Figure 3.9. The output signal from the camera detector can be described by the formula: s C'wob and wodb s watm; Figure 3.9. The output signal from the camera detector can be described by the formula: s C'wob and wodb s watm; Figure 3.9. The output signal from the camera detector can be described by the formula: s C'wob and wodb s watm; Figure 3.9. The output signal from the camera detector can be described by the formula: s C'wob and wodb s watm; Figure 3.9. The output signal from the camera detector can be described by the formula: s C'wob and wodb s watm; Figure 3.9. The output signal from the camera detector can
be described by the formula: s C'wob and wodb s watm; Figure 3.9. The output signal from the camera detector can be described by the formula: s C'wob and wodb s watm; Figure 3.9. The output signal from the camera detector can be described by the formula: s C'wob and wodb s watm; Figure 3.9. The output signal from the camera detector can be described by the formula: s C'wob and wodb s watm; Figure 3.9. The output signal from the camera detector can be described by the formula: s C'wob and wodb s watm; Figure 3.9. The output signal from the camera detector can be described by the formula: s C'wob and wodb s watm; Figure 3.9. The output signal from the camera detector can be described by the formula: s C'wob and wodb s watm; Figure 3.9. The output signal from the camera detector can be described by the formula: s C'wob and the camera detector can be described by th depending on atmospheric damping, optical camera components and detector properties. Based on (3.9) and (3.10), the model measurement can be expressed as (Minkina and Dudzik 2005): s 1/4 'ob T Tatm sob t Tatm 1'ob sso t Tatm sob t Tatm 1'ob sso t Tatm sob t Tatm intensity of thermal radiation of the black body, at the temperature of the ambient, respectively. The signal is as: so 1/4 R; exp'B-To F q3:12, where R, B, F are constants associated with the camera calibration flow of the object studied, as: sobbing 1/4 s 1 1 ob R 1 T Tatm R ob exp'BTo F ob T Tatm S ob S 1/4 R; exp'B-To F q3:12, where R, B, F are constants associated with the camera calibration flow of the object studied, as: sobbing 1/4 s 1 1 ob R 1 T Tatm R ob exp'BTo F ob T Tatm S ob S 1/4 R; exp'B-To F q3:12, where R is a set of the object studied with the camera calibration flow of the object studied as: sobbing 1/4 s 1 1 ob R 1 T Tatm R ob exp'B To F ob T Tatm S ob T Tatm S ob T Tatm S as a set of the object studied with the camera calibration flow of the object studied as: sobbing 1/4 s 1 1 ob R 1 T Tatm R ob exp'B To F q3:12, where R is a set of the object studied with the camera calibration flow of the object studied as: sobbing 1/4 s 1 1 ob R 1 T Tatm R ob exp'B To F q3:12, where R is a set of the object studied as: sobbing 1/4 s 1 1 ob R 1 T Tatm R ob exp'B To F q3:12, where R is a set of the object studied as a set of the object stud Tatm ratio associated with the absorption of infrared radiation layer of the atmosphere, plays an important role in this equation. Absorption, in turn, is caused by vapor molecules (H2O), carbon dioxide (CO2) and ozone (O3). The concentration of these compounds in the atmosphere varies depending on the weather, climate, season or geographical location. As mentioned in section 3.1, there are bands of less infrared absorption, called atmospheric windows, tha allow measurements of infrared thermalography: SW window (2-5 mm, atmospheric window I) and LW window (8-14 mm, atmospheric window II). Consequently, infrared cameras are naturally divided into SW and LW cameras. Even in the laboratory, it was noted that at a distance of 1 to 10 m, the absorption of the atmospheric window II). Consequently, infrared cameras are naturally divided into SW and LW cameras. Even in the laboratory, it was noted that at a distance of 1 to 10 m, the absorption of infrared cameras are naturally divided into SW and LW cameras. Even in the laboratory, it was noted that at a distance of 1 to 10 m, the absorption of infrared cameras are naturally divided into SW and LW cameras. radiation for the wavelength | 1/4 4.3 mm is played by carbon dioxide, present in the exhaled air. Rudovsky (1978) stated, for example, that after 3 hours in an enclosed room of about 40 cubic meters, the concentration of CO2 exhaled by two people was such that at a distance of d 1/4 0.8 m, 70% of the wavelength radiation | 1/4 4.3 mm was absorbed by air. Depending on the infrared camera model, there are several different models of atmospheric transmissio such as FASCODE, MITRAN, MODTRAN, PcModWin, SENTRAN, WATRA and others (Pr e gowski and S'widerski 1996, Pr e gowski 2001). For example, in THEMA 470 Pro SW and AGEMA 880 LW systems, the manufacturer uses the following odds values: . . FOR SW camera: 1/4 0.003 93 m1/2, b 1/4 0.000 49 m1/2, b 1/4 0.000 4 m1; for LW camera: 1/4 0.008 m1/2, b 1/4 0 m1. These values are determined under normal atmospheric temperature conditions of 1/4 15 C and relative humidity v% 1/4 50%. Under different conditions, the model of atmospheric temperature conditions by formula (3.14). You can see that the atmosphere has the best transmission in the LW infrared band. Very similar results are presented in Pr gowski (2001). Figure 3.10 TTatm Atmospheric Simulation Characteristics compared to camera; (c) v 1/4 50%, LOWTRAN (3.14) for LW and SW camera; and for comparison: b) Tatm 1/4 20 C, v 1/4 50% model (3.15) for ThermaCAM PM 595 LW camera; (c) v 1/4 50%, LOWTRAN (3.14) for LW and SW camera; and for comparison: b) Tatm 1/4 15 C, v 1/4 50% model (3.15) for ThermaCAM PM 595 LW camera; (c) v 1/4 50%, LOWTRAN (3.14) for LW and SW camera; and for comparison: b) Tatm 1/4 20 C, v 1/4 50% model (3.15) for ThermaCAM PM 595 LW camera; (c) v 1/4 50% model (3.15) for ThermaCAM PM 595 LW camera; (d) Tatm 1/4 20 C, Model (3.15) for ThermaCAM PM 595 LW Infrared Camera Algorithm Measuring The Way of Processing 55 Transmission Model determined by FLIR for ThermaCAM PM 595 LW Infrared Camera Algorithm Measuring The Way of Processing 55 Transmission Model determined by FLIR for ThermaCAM PM 595 LW Infrared Camera Algorithm Measuring The Way of Processing 55 Transmission Model determined by FLIR for ThermaCAM PM 595 LW Infrared Camera is a function of three variables: atmospheric relative humidity v%, distance from camera to object d and atmosphere of Tatm (Minkin and Dudzik 2005, Dudzik 2007; T Tatm 1/4 f v%; g; Tatm No.3:15 This model will be applied to the analysis of errors and uncertainties performed later in this monograph. In particular, nine coefficients adjusted empirically. shown in 3.10b-d drawings, were obtained using full form (3.15). It should be emphasized that the formula model (3.15) applies to most infrared cameras produced by AGEMA (e.g. series 900) and FLIR (e.g. ThermaCAM PM 595 LW). An example of the experimental TTatm transmission characteristics against distance d for the LW and SW camera is presented in figure 3.11. Measurements were taken on two different values of relative humidity v% and three values of the experiment was to test how the temperature of the object. The purpose of the experiment was to test how the temperature of the object. The purpose of the experiment was to test how the temperature of the object affects its visibility in the infrared range under these conditions. Given (3.12)-- (3.15) the temperature of the object affects its visibility in the infrared range under these conditions. the model of measuring infrared camera is defined as the function of five variables: Tob 1/4 fob; Tatm; For; v; D.E.; K: We must emphasize that the model above is a simplified model. In fact, the camera detector receives radiation and depending on the sources. The simplification can be explained by looking at figure 3.12. The signal appearing in the formula (3.12), proportional to the intensity of environmental radiation and depending on the sources. The simplification can be explained by looking at figure 3.12. The signal appearing in the formula (3.12), proportional to the intensity of environmental radiation and depending on the sources. temperature of the ambient To (in (3.12)), is actually an average reaction to radiation, based on Tcl temperature clouds, from The Tb temperature of Tatm. All these temperature of Tatm. All these temperatures are slightly different from each other (Orlove 1982, DeWitt 1983, Saunders 1999). The aforementioned description of the phenomena that make up measurements in infrared thermal imaging does not cover 1982, DeWitt 1983, Saunders 1999). all possible measurement situations. For example, an object under study may be in an oven, in a vacuum chamber, or in a wind tunnel. In such cases, the camera looks out the window must also be transparent within the visible 56 Infrared Thermalography Figure 3.11 Examples of object visibility characteristics taking into account the atmospheric transmission of TTatm, camera to object distance d, atmospheric relative humidity v% and camera; 2, SW Camera; rapid temperature changes. The spectral characteristics of the transmission factor of the typical materials used for windows usually indicate the properties of windows at room temperature and at a certain thickness. Information on the effect of the temperature and thickness and thickness at room temperature and at a certain thickness. Information on the material. Manufacturers of the temperature and thickness thickness of the window on the spectral characteristic is not always clarified, as well as restrictions on the mechanical strength and maximum working temperature of the window. When measurement model described above should be summarized to take into account additional radiation flows. The paths of radiation flows are illustrated in figure 3.14. Infrared Camera Measuring Path Processing 57 Figure 3.12 Explanation of simplifications assumed in infrared camera Model 3.17; Ambient temperature Then it is the average temperature of Tcl clouds, the atmosphere of Tatm, the earth Tgr and the buildings Of Tb (Minkina 2004). Воспроизводится по разрешению Cz e stochowa технологический университет с учетом дополнительных потоков радиации, сигнал, поступающий на детектор камеры, может быть выражен в рассмотренной модели так: s 1/4 'ob 'T Tatm1 to b' T Tatm1 to b' T Tatm1 are temperature of Tcl clouds, the atmosphere of Tatm, the earth Tgr and the buildings Of Tb (Minkina 2004). Воспроизводится по разрешению Cz e stochowa технологический университет с учетом дополнительных потоков радиации, сигнал, поступающий на детектор камеры, может быть выражен в рассмотренной
модели так: s 1/4 'ob 'T Tatm1 to b' T Tatm1 to b' T Tatm1 are temperature of Tcl clouds, the atmosphere of Tatm, the earth Tgr and the buildings Of Tb (Minkina 2004). Воспроизводится по разрешению Cz e stochowa технологический университет с учетом дополнительных потоков радиации, сигнал, nocrynaющий на детектор камеры, может быть выражен в рассмотренной модели так: s 1/4 'ob 'T Tatm1 to b' T Tatm1 are temperature of Tcl clouds, the atmosphere of Tatm, the earth Tgr and the buildings Of Tb (Minkina 2004). Bocnpoussed are temperature of Tcl clouds, the atmosphere of Tatm 2 are temperature are temper permission of ITC Flir Systems infrared thermal imaging 58 Figure 3.14 Ways of radiation flows in measurement through the inspection window (IR-Book 2000). Reproduced by permission of ITC Flir Systems Using formula (3.18) we can derive sob (Minkina 2004): sob 1/4 s ð1 «ob F Tatm1 T w T Tatm1 P satm1 T Tw T Tatm1 T Tw T Tatm1 T Tw T Tatm1 T Tw T Tatm1 P satm1 C we s w Rw so2 ð1 T Tatm1 P satm2 : «ob T Tatm1 T Tw and T Tw T Tatm1 T Tw T Tatm1 P satm1 T Tw T Tatm1 P satm1 T Tw T Tatm1 P satm1 C we s w Rw so2 ð1 T Tatm1 P satm1 T Tw and T Tw T Tatm1 T Tw T Tatm1 P satm1 T Tw T Tatm1 P satm1 T Tw and T Tw T Tatm1 P satm1 T Tw T Tatm1 P satm1 R and T Tw T Tatm1 P satm1 P satm1 T Tw T Tatm1 P satm1 T Tw and T Tw T Tatm1 P satm1 T Tw and T Tw T Tatm1 P satm1 P sat 33:19 The measurement model of a typical infrared camera does not take account всех тепловых потоков. To measure it correctly, it should be made of a material that does not absorb radiation in the spectral range of the infrared camera. TTw 1. If a typical infrared camera (3.13) should be made of a material that does not absorb radiation in the spectral range of the infrared camera. TTw 1. If a typical infrared camera (3.13) should be made of a material that does not absorb radiation in the spectral range of the infrared camera. be used with the model, consider the following questions: T-use of a range filter in which the atmosphere between the camera and the object has a very good transmission (best vacuum); or T location of the camera software. The reasoning method used to create an accurate, general model of the infrared camera measurements, taking into account radiation from individual optical components and filters (Hamrelius 1991). The infrared camera microcontroller. It is very often implemented in off-line, Infrared Camera Measuring Path Processing 59 and performed installed on the PC. In this case, raw radiometric data (i.e. uncompensated pixel values, calibration parameters, etc.) are transferred to the computer in special format files. Digital infrared data used by different manufacturers. Below we present a brief description of the TermoLab system developed by one of the authors for their own needs (Dudzik 2007). TermoLab is a more versatile approach and allows for analysis of temperature fields recorded with a camera of any type. The only requirement imposed on the recording device is the matrix output format (temperature fields recorded with a camera of any type. The only requirement imposed on the recording device is the matrix output format (temperature fields recorded with a camera of any type. The only requirement imposed on the recording device is the matrix output format (temperature fields recorded with a camera of any type. The only requirement imposed on the recording device is the matrix output format (temperature fields recorded with a camera of any type. The only requirement imposed on the recording device is the matrix output format (temperature fields recorded with a camera of any type. The only requirement imposed on the recording device is the matrix output format (temperature fields recorded with a camera of any type. The only requirement imposed on the recording device is the matrix output format (temperature fields recorded with a camera of any type. The only requirement imposed on the recording device is the matrix output format (temperature fields recorded with a camera of any type. The only requirement imposed on the recording device is the matrix output format (temperature fields recorded with a camera of any type. The only requirement imposed on the recording device is the matrix output format (temperature fields recorded with a camera of any type. The only requirement imposed on the recording device is the matrix output format (temperature fields recorded with a camera of any type. The only requirement imposed on the recording device is the matrix output format (temperature fields recorded with a camera of any type. The only requirement imposed on the recording device is the matrix output format (temperature fields recorded with a camera of any type. The only recorded with a camera of any type. The only recorded with a c software usually allows for standard engineering analysis (temperature calculation, presentation), basic statistical analysis (filtering, noise-cancelling, etc.) and reporting for research purposes and makes possible an advanced statistical analysis (filtering, noise-cancelling, etc.) and comparative (filtering, noise-cancelling, etc.) and etc.) and etc.) analysis of thermograms with the detection of inconsistencies (for diagnostic applications). You can expand the system depending on the individual needs of the user. These are the main features of TermoLab software: Compensation for exposure due to the emission of the object, surrounding and atmospheric radiation. This function is performed by reading additional data (emission, humidity, etc.) from AFF files. Compensation for self-radiation of the camera components. The software calibrates the detector readings using different humidity, etc.) from AFF files. color maps and achieving the optimal matching of the color map to the temperature range. Identify isothermal areas. Evaluation of histograms - the system allows you to calculate the frequency of temperature for any thermogram sub-air. It is possible to estimate and analyze horizontal and vertical profiles. Superposition of thermograms - correlation analyses with definition Inconsistencies. Create pseudo3D thermograms. The presentation of the series of images is the simultaneous display and analysis of several thermograms. The presentation of the series of images is the simultaneous display and analysis of several thermograms. The presentation of the series of images is the simultaneous display and analysis of several thermograms. specialized PC software. These interfaces and data formats are closely related to certain types of cameras. Because the cameras available on the market are very different, data analysis is most often possible with software from only one manufacturer. 60 TermoLab's infraredrmography has a built-in UMI (Universal Matrix interface) that reads data either as a matrix of temperature values stored in MATLAB files (from any type of camera) or as a direct detecto signal from AFF files (only from FLIR cameras). The first option allows data analysis from any camera that stores images as matrix. The system offers ample opportunities for statistical analysis of infrared data, as well as graphic representation of results. Reports, including measurements and calculations obtained during the program, can also be stored in MATLAB files and processed in the MATLAB files and processed in the MATLAB files and processed in the mat original FLIR (TOOLKIT IC2) product and directly supports FLIR cameras (formerly AGEMA). So far, we have focused on describing the measurements of infrared thermal imaging in terms of the measurements. I our view, error analysis and uncertainty analysis do not exclude each other. On the contrary, taking into account the complexity of measurement in infrared thermal imaging. In this book, errors and uncertainties were calculated for the FLIR ThermaCAM PM 595 LW model infrared camera. For other types of cameras and manufacturers, the results and conclusions can be very similar. 4 Measurement errors in infrared thermal imaging 4.1 Introduction The concept of measurement error has a basic value for assessing the accuracy of the measurement errors in infrared thermal imaging 4.1 Introduction The concept of measurement error has a basic value for assessing the accuracy of the measurement error has a basic value for assessing the accuracy of the measurement error has a basic value for assessing algorithm (based on a mathematical model of measurement) of the trajectory of the infrared camera measurement (Minkina 2004). To properly assess accuracy, you need to evaluate errors in the method introduced by the camera trajectory algorithm for a single element (pixel) of the array detector and the actual tremperature of the surface temperature displayed by one pixel is constant. The relative error of the measurement model in infrared thermal imaging is the ratio of the absolute error of DTob to the actual temperature of TR: dTob 1/4 DTob : TR No4:2, Unfortunately, the actual value of TR in the above definitions is unknown. Therefore, in this monograph, we replace it with the true normal value assigned a priori while modeling the camera processing algorithm. In Chapter 1, we divided measurement errors into systematic and random errors. In the case of measurements in infrared thermal imaging, systematic interactions strongly affect the accuracy of infrared thermal imaging: Mistakes and uncertainties 2009 John Wylie and Sons, Ltd Waldemar Minkina and Sebastian Dudzik 62 Infrared thermal imaging. 4.2 Systematic interactions in the measurements of infrared thermal imaging. 4.2 Systematic interactions in the measurements of infrared thermal imaging. 4.2 Systematic interactions in the measurements of infrared thermal imaging. 4.2 Systematic interactions in the measurements of infrared thermal imaging. 4.2 Systematic interactions in the measurements of infrared thermal imaging. temperature measurement errors using infrared cameras are classified as follows: . . . Method errors
Calibration errors e-path errors. In real-world conditions, errors in the method may follow from the causes below or the interactions occurring during the measurement: . . . detector; incorrect assessment of atmospheric and atmospheric aurora transmission; noise detector. The more objects of different emission depicted in one thermogram, the more noticeable the impact of the emission depicted in one thermogram, the more objects of different emission of an object depends on the wavelength, temperature, material, surface condition, direction of observation, polarization, and - in superfast thermal processes - in time. moisturize it or - if possible - by evenly heating it, and then make an emission card. The application of these solutions is easy in the laboratory, but usually not possible in industrial conditions. This is especially since the emission of objects is one of the input quantities in the camera measurement algorithm. The effect of radiation emitted by others increases when it is reduced. This follows from (3.11). The effect is more significant for Tob. Additional errors due to solar radiation appear in infrared thermal imaging performed in the object is filtered by the atmosphere and depends on the day, time and atmospheric conditions. The study of the effect of solar radiation on accuracy in infrared thermal imaging is not so easy: usually this radiation makes measurement impossible, except for qualitative studies of high temperature into a buildings and the radiation of the earth (see figure 3.12). Limiting the effects of atmospheric radiation of the sky, the radiation of the earth (see figure 3.12). Limiting the effects of atmospheric radiation of the sky, the radiation of the earth (see figure 3.12). the microcontroller chamber. Unfortunately, the problem is to determine this temperature in a reliable way. This is difficult because the proximity of the object can cover many components of different emission values located in an open measuring chamber, which reduced the influence of external radiation. In addition, the walls of the camera were covered with an emulsion of a high (close to unity) emission factor. Unfortunately, this method allows only a small class of objects to be explored in the laboratory. Since the overall temperature of the atmosphere can be ignored when the distance of the atmosphere can be ignored when th from the camera to the object does not exceed a few meters. When measuring the temperature of distant objects, you should consider the self-radiation of the atmosphere. This is especially important when the input variables ob, To, Tatm, v and d measuring models correlate with each other (Dudzik 2005) and if, in addition, the observed objects have low emission ratios (Dudzik 2005) and if, in addition, the observed objects, you should consider the self-radiation of the atmosphere. This is especially important when the input variables ob, To, Tatm, v and d measuring models correlate with each other (Dudzik 2005) and if, in addition, the observed objects have low emission ratios (Dudzik 2005) and if, in addition, the observed objects have low emission ratios (Dudzik 2005) and if, in addition, the object set of errors occurs when calibrating infrared extends the self-radiation of the atmosphere. This is especially important when the input variables ob, To, Tatm, v and d measuring models correlate with each other (Dudzik 2005) and if, in addition, the object set of errors occurs when calibrating infrared extends the self-radiation of the atmosphere. This is especially important when the input variables ob, To, Tatm, v and d measuring infrared extends the self-radiation of the atmosphere. cameras 2002). The temperature measurement error due to the calibration process usually arises from: . . Differences in the self-radiation of optical components and camera filters during calibration, disregard for the influence of ambient radiatior reflected from the black body, and limited resolution of the camera temperature; limited accuracy of the reference standard, as well as a limited number of calibration points and the theoretical framework below. In addition to the automatic calibration of the detector described in Chapter 3, the entire camera, as the final product, is sent by the manufacturer to the calibration laboratory, where it undergoes a number of calibration stages. A calibration certificate is attached to each part that goes through this process. This certificate includes (among other things): The name of the laboratory Serial camera number of calibration process. This certificate is attached to each part that goes through this process. This certificate is attached to each part that goes through this process. This certificate includes (among other things): The name of the laboratory Serial camera number of calibration process. This certificate is attached to each part that goes through this process. and signature of the persons concerned (performance and approval of the person). Technical data for each measuring chamber indicates the accuracy of measurements, such as 2 C or 2% of the range. This parameter should be interpreted as accuracy of measurements, such as 2 C or 2% of the range. out using a technical black body, whose ob 1 is above the operating range of the calibrated device. For short distances between the camera and the black body, it can be assumed that T Tatm 1 and ob 1 (technical black body, it can be assumed that T Tatm 1 and ob 1 (technical black body). Then, from (3.13) we get a sob 1/4 s. Laboratory calibration is done by measuring si signals corresponding to the different Ti temperatures set on technical black body). Then, from (3.13) we get a sob 1/4 s. Laboratory calibrated device. For short distances between the camera and the black body, it can be assumed that T Tatm 1 and ob 1 (technical black body). Then, from (3.13) we get a sob 1/4 s. Laboratory calibration is done by measuring si signals corresponding to the different Ti temperatures set on technical black body. radiation. The calibration curve described (4.3) is the approximation of points (si, Ti) by function: si 1/4 R; exp'B'Ti q F 4:3 Ti 1/4 B; K; R F In si No4:4, where R, B, F are constants, are determined to get the best fit function (4.3) to calibration points. Based on (4.4) the infrared camera converts the si detector signal into the Ti temperature for a certain wavelength of radiation (11, 12). From a theoretical point of view, the characteristic (4.3) follows from the si detector signal into the Ti temperature for a certain wavelength of radiation (4.4) the infrared camera converts the si detector signal into the Ti temperature for a certain wavelength of radiation (11, 12). From a theoretical point of view, the characteristic (4.3) follows from the camera converts the si detector signal into the Ti temperature for a certain wavelength of radiation (4.4) the infrared camera converts the si detector signal into the Ti temperature for a certain wavelength of radiation (11, 12). approximation of the integration of the product of the black body of the radiant output of M(I.T) on the detector (according to Planck's law) and sk function (I) describing the relative spectral sensitivity of the camera - Figure 4.1 (Wallin 1994, Kaplan 2000). This product is integrated into the l1-l2 camera interval and for the assigned temperature of the Black Body Ti: 1/2 c Ti 1/4 C Sk III c dI 1 : c2 1 I exp I Ti 4:5'5 Characteristic Sk(I) is determined mainly by the function of D (I) normalized detectability detector (sensitivity) and spectral characteristic of camera transmission. In general, the values R, B, F are different for each part of the characteristics of the relative spectral sensitivity of sk(I) longwave (LW) camera are represented in table 4.1. Figure 4.1 An example of the camera and for each range of the characteristics of the relative spectral sensitivity of sk(I) longwave (LW) camera are represented in table 4.1. Figure 4.1 An example of the characteristics of the relative spectral sensitivity of sk(I) longwave (LW) camera are represented in table 4.1. Figure 4.1 An example of the characteristics of the relative spectral sensitivity of sk(I) longwave (LW) camera are represented in table 4.1. Figure 4.1 An example of the
characteristics of the relative spectral sensitivity of sk(I) longwave (LW) camera are represented in table 4.1. Figure 4.1 An example of the characteristics of the relative spectral sensitivity of sk(I) longwave (LW) camera are represented in table 4.1. Figure 4.1 An example of the characteristics of the relative spectral sensitivity of sk(I) longwave (LW) camera are represented in table 4.1. Figure 4.1 An example of the characteristics of the relative spectral sensitivity of sk(I) longwave (LW) camera are represented in table 4.1. Figure 4.1 An example of the characteristics of the relative spectral sensitivity of sk(I) longwave (LW) camera and for each part of the characteristics of the relative spectral sensitivity of sk(I) longwave (LW) camera are represented in table 4.1. Figure 4.1 An example of the characteristics of the relative spectral sensitivity of sk(I) longwave (LW) camera and for each part of the characteristics of the relative spectral sensitivity of sk(I) longwave (LW) camera and for each part of the characteristics of the relative sensitivity of sk(I) longwave (LW) camera and for each part of the characteristics of the relative sensitivity of sk(I) longwave (LW) camera and for each part of the characteristics of the relative sensit Systems Measurement Errors in Infrared Thermalography 65 Table 4.1 Options R, B, F gauge function of the camera ThermaCAM PM 595 (LW) (TOOLKIT IC2) Measuring Ranges, C 40-120 80-500 350-2000 R B, K F 101 920 17 250 1 870 1463.4 1466.6 1491.8 1 1 1 Typical Static Characteristics s 1/1 The shortwave (SW: 3-5 mm) and longwave (LW: 8-14 mm) camera are shown in figure 4.2. Constants R, B, F are stored in the memory of the camera microcontroller, which calculates each time the measured temperature To, distance from camera to object d and relative atmosphere humidity v%. The calibration procedure is detailed in DeWitt (1983), Machin and Chu (2000) and Machin et al. (2008). The interior of the laboratory for calibration procedure is detailed in DeWitt (1983), Machin and Chu (2000) and Machin et al. (2008). The interior of the laboratory for calibration of infrared cameras and a set of technical black bodies are shown in the photos in figure 4.3. The third source of systematic errors is the electronic path of the cooling systems The limited bandwidth of the cooling systems. . . . Detector noise instability of the cooling systems (in cooled chambers); Fluctuation and/or other electronic components; . . . linearity of A/D converters. They are the main source of errors in contactless measurements of temperature fields using infrared cameras. (b) A set of a static characteristics measuring the trajectory of shortwave (SW: 3-5 mm) and longwave (LW: 8-14 mm) camera 66 Infrared Figure 4.3 (a) Laboratory room for calibration of infrared cameras; (b) A set of technical black bodies (IR-Book 2000). See The Color of the Plate 7 for the color version. It is reproduced with the permission of ITC Flir Systems, similar to well-known and widely used optical pyrometers. Contact methods using thermoelectric, resistant or termistor thermometers offer much better accuracy, especially since the range of measured temperature is similar to both methods. Unfortunately, contact methods sometimes cannot be applied. The inaccuracy of the infrared thermal imaging method may be obvious, especially when measuring the temperature of a heterogeneous object built from materials of different emissions. Therefore, this method is recommended for remotely determining the temperature distribution of homogeneous objects of a very similar emissions. Therefore, this method is recommended for remotely determining the temperature distribution of homogeneous object built from materials of different emissions. Therefore, this method is recommended for remotely determining the temperature distribution of a very similar emission. be carefully analyzed and the measuring staff should have a great deal of experience in interpreting measurements in infrared thermal imaging. Since the error in the method is the main component in assessing the accuracy of measurement in infrared thermal imaging. Since the error in the method is the main component in assessing the accuracy of measurement in infrared thermal imaging. measurement model is necessary to assess errors in the infrared thermal imaging method. In this monograph, we analyze an error in a model-based method (3.17), the five input values representing the measurement conditions must be determined in a model-based method (3.17), the five input values representing the measurement conditions must be determined in a model-based method (3.17), the five input values representing the measurement conditions must be determined in a model based method. the camera software: the object of the emission about, the temperature of the environment To, the temperature of the atmosphere Tatm, the relative humidity v and the camera-object distance d. Further in the relative humidity v and the camera-object distance d. Further in the relative humidity v and the camera-object distance d. Further in the relative humidity v and the camera-object distance d. Further in the relative humidity v and the camera-object distance d. Further in the relative humidity v and the camera-object distance d. (formula (1.8)) to assess measurement errors in infrared thermal imaging 67 Table 4.2 Reference values of input parameters projected in model modeling (3.17) Emission Object Value (ob) Ambient Temperature (Tatm), K 0.98; 0.80; 0.60; 0.40 293 293 Relative humidity (v) 0.5 Distance from camera to object (d) 1, 100 offset components associated with individual input parameters. Error in the method is investigated for all input measurements The simulation was conducted in the MATLAB R2006b environment. The model dor different measurement conditions (affecting inputs) and different inputs) and different inputs. The measurement conditions (affecting inputs) and the relative error ranges of input parameters are listed in Table 4.2, and the relative error state in Table 4.2, and the relative error ranges of input parameters are listed in Table 4.2, and the relative error state inputs. The measurement conditions (affecting inputs) and different inputs. The measurement conditions (affecting inputs) and the relative error state in Table 4.2, and the relative error ranges of input parameters are listed in Table 4.2, and the relative error state inputs. It is limited to narrow intervals because the generalization of the results condenses the graphs and makes them unclear, making it impossible to detect changes in the function of the error 1/4 50 K big or small? If the tob object temperature is 1/4 2000 K, it seems small (relative margin of error 1/4 50 K big or small?) for a typical contactless temperature is 1/4 2000 K, it seems small (relative margin of the results condenses the graphs and makes them unclear, making it impossible to detect changes in the function of the error. In our view, the use of absolute DTob error 1/4 50 K big or small? If the tob object temperature is 1/4 2000 K, it seems small (relative margin of error dTob 1/4 2:5%) for a typical contactless temperature measurement. Taking these inconveniences into account, we decided to analyze the sensitivity of the infrared camera measurement model using relative errors in the affecting amounts. We believe that the modeling results presented further as graphs of relative errors in the affecting amounts. We believe that the modeling results presented further as graphs of the object's surfaces. In this section, we present the modeling results present th results obtained for the model (3.17), suggesting that the installation of the object surface emission in the chamber is incorrect. The dTob temperature measurement error component due to the Tob and Tob, while the graphs in Figure 4.4 and 4.5. The graphs in Figure 4.4 relate to the Tob case of Tob and Tob, Tatm simulated the temperature of the object emission d'ob error is represented in figures 4.4 and 4.5. object, equal to: 303 K (30 C), 323 K (50 C), 323 K (50 C), 343 K (70 C), 363 K (90 C). For the case of Tob To Table 4.3 Ranges relative error of the input parameters of the model (3.17) Input parameters of the model (3.17) Input parameter Emission Object Error Range (Ob) Ambient temperature (To), K Atmosphere (To), K Atmosphere (To), K At emission object on the error of the Tob temperature measurement (Tob and Tob and Tatm) for Tatm 1/4 To 1/4 293 K (Minkin and Ba bka 1 2002) and Tob Tatm , modeling was performed for the temperature of the object, equal to: 263 K (10 C), 274 K (1 C), 283 K (10 C), 293 K (20 C). On the basis of the presented results, the following conclusions can be drawn: . . An error in the object emission parameter has a strong effect on the error of temperature measurement. In figure 4.4, we see that re-evaluating about leads to a lesser error than an underestimation. For example, for d' 1/4 30%, the dTob arror is 2---7% provided that: Tatm 1/4 To 1/4 293 K, Tob 1/4 (300-400) K and about 1/4 0.4-0.98. In figure 4.4, we also see that the error component in question increases with the increase in Tobe and is not dependent on ob. In figure 4.5 we see that if Tob To and Tob Tatm, the dTob 1/4 f d'ob error does not depend on 'ob' and increases greatly when Tob decreases. Figure 4.5 illustrates a situation where the results of any measurements of infrared thermal imaging are unreliable. When Tob's to, Tob and Tob To, Tob Tatm, the dTob error is close to zero, which means that the model is less sensitive to changes in the number considered. For Tob 1/4 To We call this a special point model. Described features of the model will follow from the mathematical form of the formula (3.17). On the other hand, when Tob 1/4 To 1/4 Tatm, the error, according to the theory of measurement of thermography, carried out at volume 1/4 to 1/4 Tatm, are unreliable. In Minkina's work (2004), model
insensitivity to the about changes, for Tob 1/4 To 1/4 To 1/4 To 1/4 Tatm, explains more vividly. Contributions of individual components of radiation coming to the detector are presented graphically in figure 4.6. The detector receives radiation streams is proportional to the intensity of radiation (which increases with and the issue of ob, atm and o 1/4 1, respectively. Figure 4.6a illustrates a situation where the emission of an object is small. In this case, the measured intensity of radiation from the object is about 30% of the radiation received by the detector. The remaining 70% coming from the atmosphere and the environment conditions are extremely unfavorable not only because of the intended temperature distribution, where the object cooler than the surrounding and 70 infrared thermal imaging Figure 4.6 Graphic illustration of deposits from specific components of radiation arriving at the camera detector in the atmosphere of a critical case (Tob, Tob Tatm), but also because of the emission of an object that is supposed to be smaller than the atmosphere of a critical case (Tob, Tob Tatm), but also because of the emission of an object that is supposed to be smaller than the atmosphere and the environment of the emission of an object that is supposed to be smaller than the atmosphere and the environment of the emission ('atm, o... In this case, the contribution of the object's radiation to the total flow coming to the camera detector may be even lower. The above simulation results suggest the constant temperature of the object. Кроме того, мы можем исследовать влияние ошибок отдельных объемов ввода в модели измерения (3.17), предполагая постоянный сигнал рыдания (ва bka и Minkina 2002c), где: 1 1 «ob R 1» Т Tatm R : 4:6 рыдать 1/4 с ob exp'BTo F ob T Tatm exp'To F ob T Tatm с предполагаемой объектом эмиссии об, для постоянного рыдания и атмосферной передачи Т Tatm, представлены на рисунке 4.7. The effect of the object's emission on the temperature measurement of the Tob object temperature equal to the temperature of the To ambient, described earlier, is represented by a curve 1 in figure 4.7. Other curves in Figure 4.7 point to Toba's dependence on ob for Tob 61/4 To. The case when the temperature of the object is close to the ambient temperature of the object is close to the ambient temperature of the object is close to the ambient temperature is not the only unfavorable situation that occurs during measurements in infrared thermal imaging. Another difficult situation is to measure the temperature of the object is close to the ambient temperature is not the only unfavorable situation that occurs during measurements in infrared thermal imaging. polished metals, when the interpretation of the reflection is easy to detect by changing the angle of observation. After a slight change in angle, the intensity of the reflected radiation of the hot object remains almost the same, while the reflection is easy to detect by changing the angle of observation. After a slight change in angle, the intensity of the radiation of the reflected radiation of the object's surface, let's look and in the case of low emission of the not object remains almost the same, while the reflection is easy to detect by changing the angle of observation. at the following example. Example The thermograms of a low-emission object in Figure 4.8 are the thermograms of a polished aluminum is 0.1. Figure 4.8 are the thermograms of a polished aluminum is 0.1. Figure 4.8 are the thermograms of a polished aluminum is 0.1. temperature: (a) mirror image of a person, measuring the temperature of the sheet; (b) The image of a glass of hot water in the background of the sheet and its background of the resolution of Cze, university of technology infrared thermal imaging 72 with hot water, located against the estination of the sheet and its background reflection (the right edge of the paper sheet stuck on the aluminum is marked with a dotted line), c) view (Minkina 2004). See Color Plate 8 for the color version. Reproduced at the resolution of Cze, university of technology infrared thermal imaging 72 with hot water, located against the estination of the sheet and its background reflection (the right edge of the paper sheet stuck on the aluminum is marked with a dotted line), c) view (Minkina 2004). See Color Plate 8 for the color version. Reproduced at the resolution of Cze, university of technology infrared thermal imaging 72 with hot water, located against the estination of Cze, university of technology infrared thermal imaging 72 with hot water, located against the resolution of Cze, university of technology infrared thermal imaging 72 with hot water, located against the resolution of Cze, university of technology infrared thermal imaging 72 with hot water, located against the resolution of Cze, university of technology infrared thermal imaging 72 with hot water, located against the resolution of Cze, university of technology infrared thermal imaging 72 with hot water, located against the resolution of Cze, university of technology infrared thermal imaging 72 with hot water, located against the resolution of Cze, university of technology infrared thermal imaging 72 with hot water, located against the resolution of Cze, university of technology infrared thermal imaging 72 with hot water, located against background of the sheet and its background reflection. A sheet of white paper, emission 0.8, stuck on the left side of aluminum for comparison. The right edge of the paper is marked in the glass (the left part of the reflection of the glass) is lower than the actual vertices and its background reflection. A sheet of white paper, emission 0.8, stuck on the left side of aluminum for comparison. The right edge of the paper is marked in the glass (the left part of the reflection from the glass) is lower than the actual vertices and its temperature, because the aluminum sheet is not an ideal white body (its emission ob 0.1). If the aluminium emission objects whose temperature is close to the ambient temperature (atmosphere) are unreliable. Figure 4.8c shows the view from above the installation. 4.3.2 The effect of the ambient temperature adjustment error on the temperature measurement error In this section we discuss the effect of incorrect ambient temperature adjustment on the temperature measurement error. Relevant simulations of dTob measurement error. Relevant simulations of dTob measurement error are shown in the figures 4.9 and 4.10. Results presented in a) 0.25 Tob 303 K 0.2 Tob 303 K 0.2 Tob 303 K 0.15 Tob No 343 K (b) % 0 to 0.1 4 -0.15 -0.6 -0.2 -0.8 -2 2 T 303 K about 1.5 tob 323 K -1 0, % 1 2 -1 -3 3 - 293 (284-302) K, Sob 0.60 (d) -2 4 T 303 K about 3 Tob 323 K -1 0, % 0.1 to No 293 (284-302) K, Sob 0.40 Tob 343 K 2 Tob 343 K 1 Tob 1 2 3 -5 -2 -1 -0 1 2 3 , 4.9 Influence of Ambient Temperature On the setting of an error in the error of measuring the temperature of the toba (Tob and Tatm) for Tatm 1/4 To 1/4 293 K (Minkin and Ba bka 2002, Minkina 2004). Reproduced by resolution of Cze stikhov University of Technological Measurement Errors in Infrared Thermal imaging 73 Figure 4.10 The effect of ambient temperature on the setting of error on the error of measuring the temperature of the toba (Minkin and Ba bka 2002, Minkina 2004). Reproduced by resolution of Cze stikhov University of Technological Measurement Errors in Infrared Thermal imaging 73 Figure 4.10 The effect of ambient temperature on the setting of error on the error of measuring the temperature of the toba (Minkina 2004). Reproduced by resolution of Cze stikhov University of Error on the error of measuring the temperature of the toba (Minkina 2004). Reproduced by resolution of Cze stikhov University of Error on the error of measuring the temperature of the toba (Minkina 2004). temperature of Tob (Tob To and Tob Tatm) for Tatm) for Tatm 1/4 To 1/4 293 K (Minkin and Ba bka 2002, Minkin 2004). Reproduced by permission of Cze stochowa University of Technology Figure 4.9 have been obtained for Tob's and Tob's Tatm; The results are presented in figure 4.10 for Tob To and Tob Tatm. The analysis of the above model simulation (3.17), in terms of the effect of incorrect ambient temperature adjustment To on the margin of sampling error, can be summarized as follows: . . The dTo error in setting the emission object. Unlike d'characteristics, dTob vs. dTo characteristics, dTob vs. dTo characteristics, dTob vs. dTo characteristics, dTob vs. dTo characteristics show symmetry, which means that both undervalued and overpriced To settings cause similar errors. From the numbers 4.9 and 4.10, we see that over-tuning leads to a negative error and an understated adjustment to a positive error. For example, for dTo 1/4 3% dTob error 0:1--5:0 if Tatm 1/4 To 1/4 (300-400) K and ob 1/4 component associated with the incorrect setting of Object 74. Infrared emission thermography (Figure 4.5). In such situations, the results of infrared thermal imaging measurements can be ignored, especially if the object's emission is high. This is an important conclusion for practical measurements in infrared thermal imaging. 4.3.3 Effect of the atmospheric temperature error of the dTob measurement error error of the dTob measurement error error of the dTob measurement error erro model (T Tatm) (3.15). Figure 4.11 The effect of the atmospheric temperature of Tatm setting an error on the error of the temperature (Tob and Tob qgt; for Tatm 1/4 To 1/4 293 K (Minkina 2004). 2004). by resolution of the temperature (Tob and Tob qgt; for Tatm 1/4 To 1/4 293 K (Minkina 2004). 2004). Tob Tatm) for Tatm 1/4 to 1/4 293 K (Minkin 2004). Reproduced at the permission of Cze sichov University of the temperature of the object - figure 4.11. and 4.12, in terms of the temperature of the error of temperature of the temperature of the object - figure 4.11. The error in the Tob measurement is proportional to the error in setting up the Tatm. For
example, if you make a dTatm error 1/4 3% dTob 0:05--0:35% if up to 1/4 (300-400) K and ob 1/4 0.40.98. The error dTob 1/4 ('dTatm th is not dependent on ob and increases with Tob and does not depend on ob. If Tob Tatm 1/4 293 K, Tob 1/4 (300-400) K and ob 1/4 0.40.98. The error dTob 1/4 ('dTatm th is not depend on ob. If Tob Tatm and Tob To, we can see in figure 4.12 that the error dTob 1/4 ('dTatm th is not dependent on ob and increases with Tob and does not depend on ob. If Tob Tatm 1/4 293 K, Tob 1/4 ('dTatm th is not depend on ob. If Tob Tatm and Tob To, we can see in figure 4.12 that the error dTob 1/4 ('dTatm th is not dependent on ob and increases with Tob and does not depend on ob. If Tob Tatm 1/4 293 K, Tob 1/4 ('dTatm th is not depend on ob. If Tob Tatm 1/4 293 K, Tob 1/4 ('dTatm th is not depend on ob. If Tob Tatm 1/4 293 K, Tob 1/4 ('dTatm th is not depend on ob. If Tob Tatm 1/4 293 K, Tob 1/4 ('dTatm th is not depend on ob. If Tob Tatm 1/4 293 K, Tob 1/4 ('dTatm th is not depend on ob. If Tob Tatm 1/4 293 K, Tob 1/4 ('dTatm th is not depend on ob. If Tob Tatm 1/4 293 K, Tob 1/4 ('dTatm th is not depend on ob. If Tob Tatm 1/4 293 K, Tob 1/4 ('dTatm th is not depend on ob. If Tob Tatm 1/4 293 K, Tob 1/4 ('dTatm th is not depend on ob. If Tob Tatm 1/4 293 K, Tob 1/4 ('dTatm th is not depend on ob. If Tob Tatm 1/4 293 K, Tob 1/4 ('dTatm th is not depend on ob. If Tob Tatm 1/4 293 K, Tob 1/4 ('dTatm th is not depend on ob. If Tob Tatm 1/4 293 K, Tob 1/4 ('dTatm th is not depend on ob. If Tob Tatm 1/4 293 K, Tob 1/4 ('dTatm th is not depend on ob. If Tob Tatm 1/4 293 K, Tob 1/4 ('dTatm th is not depend on ob. If Tob Tatm 1/4 293 K, Tob 1/4 ('dTatm th is not depend on ob. If Tob Tatm 203 K, Tob 1/4 ('dTatm th is not depend on ob. If Tob Tatm 203 K, Tob 1/4 ('dTatm th is not depend on ob. If Tob Tatm 203 K, Tob 1/4 ('dTatm th is not depend on ob. If Tob Tatm 203 K, Tob 1/4 ('dTatm th is not depend on ob. If Tob Tatm measurement error is not large, measurements should not be carried out under such conditions, it follows from the measurement of the industrial plant 76 Infrared measurements of the industrial plant 76 Infrared measurements of the industrial plant 76 Infrared measurement of the industrial plant 76 Infrared measurements of the thermalography described earlier. temperature of the industrial plant (Minkina 2003). See Color Plate 9 for the color version. Reproduced at the permission of Cze stochowa University of Technology The result of incorrect parameters of the temperature of te after the wrong Tatm and To settings in the camera, we first entered the correct Values Tatm 1/4 to 1/4 0 C and the recorded thermogram is shown in figure 4.13b. This time the camera calculated the temperature of the wrong values Tatm 1/4 to 1/4 to 1/4 and 20 C, and the recorded thermogram is shown in figure 4.13b. This time the camera calculated the temperature of the wrong values Tatm 1/4 to object in the same place as the Tob 1/4 1.2 C. In both cases, the camera software is calculated tobe for the same lining emission, 1/4 0.8. The difference in readings is due to the fact that the camera measures the total intensity of radiation coming to each pixel of the detector. We can analyze the contribution of specific radiation coming to each pixel of the detector for incorrect settings of the environment and atmosphere (Figures 4.13c and d), as was done earlier for incorrect setting of the object's emission. When the settings are correct, i.e. Tatm 1/4 To 1/4 O C, the camera's interpretation of radiation components is correct: the detector receives more radiation from the object and less from the environment and atmosphere (figure 4.13c), so the camera's interpretation of radiation components is correct: the detector receives more radiation from the object and less from the environment and atmosphere (figure 4.13c), so the camera's interpretation of radiation components is correct: the detector receives more radiation from the object and less from the environment and atmosphere (figure 4.13c), so the camera's interpretation of radiation components is correct: contribution of the object's radiation and reassigns the contribution of the environment and atmosphere (figure 4.13d). Consequently, the camera readings are too low (Tob 1/4 1.2 C). Measurement errors in infrared thermal imaging, taking into account the influence of the distance from the camera to the object and the relative humidity of the atmosphere Tatm, humidity v and the distance from the camera to the object d (Figures3.1aand b). Inthissection wedealwith the dependence of error of temperature measurement on the wrong setting of the distance from the camera to the object. The effect of adjusting relative humidity is discussed in the next section. The results of the simulations in the 4.14 and 4.15 models for the measurement with the error of distance from the camera to the do bject. The charts are 4.14 for Tob and Tot and Tatm and the graphics on Figure 4.15 for Tob To and Tob Tatm. Analysis of the presented results in terms of the impact of the error component associated with the distance from the camera to object: dTob zlt; 0:2% for dd 1/4 30% if up to 1/4 Tatm 1/4 293 K, Tob 1/4 (300-400) K Figure 4.14 Effect of camera-to-and the error component associated with the distance from the camera to object: dTob zlt; 0:2% for dd 1/4 30% if up to 1/4 Tatm 1/4 293 K, Tob 1/4 (300-400) K Figure 4.14 Effect of camera-to-and the error of measuring the temperature of the error from camera to object: dTob zlt; 0:2% for dd 1/4 30% if up to 1/4 (300-400) K Figure 4.14 Effect of camera-to-and the error of measuring the temperature of the error of measuring the temperature of the object: dTob zlt; 0:2% for dd 1/4 30% if up to 1/4 (300-400) K Figure 4.14 Effect of camera-to-and the error of measuring the temperature of temperature object D error when measuring tobe temperature measurement (Tob zgt; To and Tob's Tatm) for Tatm 1/4 To 1/4 293 K (Minkina and Tob zgt; Tatm 1/4 To 1/4 293 K (Minkina and Tob zgt; Tatm 1/4 To 1/4 293 K (Minkina and Tob zgt; Tatm 1/4 To 1/4 293 K (Minkina and Dob zgt; Tatm 1/4 To 1/4 293 K (Minkina and Tob zgt; Tatm 1/4 To 1/4 29 0.98 (Figure 4.14)., we see that this component of the error increases with the temperature of the Tob object and does not depend on 'about and increases. Despite small temperature errors, measurements in follows from the general principles of measurements in follows from the tobe decreases. Despite small temperature of the Tob Data does not depend on 'about and increases when the tobe decreases. Despite small temperature errors, measurements in follows from the general principles of measurements in follows from the general principles of measurements in follows from the tobe decreases. Despite small temperature errors, measurements in follows from the general principles of measurements in follows from the general pri infrared thermal imaging described earlier. 4.3.5 The effect of the relative humidity adjustment error on temperature measurement simulations relating to the relationship between the error of dv humidity is presented in figures 4.16 and 4.17. The results in Figure 4.16 for Tob and Tob and Tob and Tob and Tob and Tob and 4.17 allows us to draw the following conclusions: . Figure 4.16 shows that the relative humidity error has a minimal effect on the measurement of the error is increased with the object: dTob zlt; 0:2% for dv 1/4 30%, if up to 1/4 74m 1/4 293 K, Tob 1/4 (300-400) K and ob 1/4 0.4-0.98. This component of the error is increased with the object: dTob zlt; 0:2% for dv 1/4 74m 1/4 293 K, Tob 1/4 (300-400) K and ob 1/4 0.4-0.98. This component of the error is increased with the object: dTob zlt; 0:2% for dv 1/4 30%, if up to 1/4 74m 1/4 293 K, Tob 1/4 (300-400) K and ob 1/4 0.4-0.98. This component of the error is increased with the object: dTob zlt; 0:2% for dv 1/4 74m 1/4 293 K, Tob 1/4 (300-400) K and ob 1/4 0.4-0.98. This component of the error is increased with the object: dTob zlt; 0:2% for dv 1/4 74m 1/4 293 K, Tob 1/4 (300-400) K and ob 1/4 0.4-0.98. This component of the error is increased with the object: dTob zlt; 0:2% for dv 1/4 74m 1/4 293 K, Tob 1/4 (300-400) K and ob 1/4 0.4-0.98. This component of the
error is increased with the object: dTob zlt; 0:2% for dv 1/4 74m 1/4 293 K, Tob 1/4 (300-400) K and ob 1/4 0.4-0.98. This component of the error is increased with the object: dTob zlt; 0:2% for dv 1/4 74m 1/4 293 K, Tob 1/4 (300-400) K and ob 1/4 0.4-0.98. This component of the error is increased with the object: dTob zlt; 0:2% for dv 1/4 74m 1/4 293 K, Tob 1/4 (300-400) K and ob 1/4 0.4-0.98. This component of the error is increased with the object measurement error is increas (Tob and Tob zgt; Tatm) for Tatm 1/4 To 1/4 293 K (Minkina 2004). Reproduced at the permission of Cze Stokhov University of Technology. Tob's temperature is independent of ob emissions. Its characteristics are very similar to those of the D error component from camera to object (Figure 4.14). In figure 4.17, we see that for Tob Tatm and Tob To the bug dTob 1/4 f zdv is not dependent on the emission and increases when the tobe decreases. The graphs in figure 4.17 are very similar to the graphs in figure 4.15. Again, despite small temperature errors, measurement of the temperature errors, measurement of the temperature measurement of the temperature errors, measurement of the temperature errors in infrared thermal imaging due to systematic interaction, we can say that the main component of the temperature errors, measurement of the temperature errors, measurement of the temperature errors, measurement error is the result of incorrect adjustment of the temperature errors, measurement error is the result of incorrect adjustment of the temperature errors, measurement error is the result of incorrect adjustment of the temperature errors, measurement error is the result of incorrect adjustment of the temperature errors, measurement error is the result of incorrect adjustment of the temperature errors, measurement error is the result of incorrect adjustment of the temperature errors, measurement error is the result of incorrect adjustment of the temperature errors, measurement error is the result of incorrect adjustment of the temperature errors, measurement error is the result of incorrect adjustment of the temperature errors, measurement error is the result of incorrect adjustment of the temperature errors, measurement errors, measurement error is the result of incorrect adjustment error the measurement of infrared thermal imaging is in principle unreliable or even impossible. Another critical case is when the temperature of the object under study (useful signal). In practice, the temperature of the object should be higher at least 50 C than the background temperature. In our practical experience, most often there are situations when the temperature of the measured object is much higher than the temperature of the atmosphere or the environment. Assessing unknown ambient temperature to be measured that up to 1/4 Tatm. 80 Infrared thermography Figure 4.17 Atmospheric relative humidity v setting error on the temperature is a completely different problem. In practice it is assumed that up to 1/4 Tatm. 80 Infrared thermography Figure 4.17 Atmospheric relative humidity v setting error on the temperature to be measured that up to 1/4 Tatm. 80 Infrared thermography Figure 4.17 Atmospheric relative humidity v setting error on the temperature to be measured that up to 1/4 Tatm. 80 Infrared thermography Figure 4.17 Atmospheric relative humidity v setting error on the temperature to be measured to be me 293 K (Minkina 2004). Reproduced at the permission of Cze stochowa University of Technology All of the above observations lead to the conclusion that the assessment of errors in infrared thermal imaging measurements should be considered on a case-by-case basis. Theoretical analysis of such errors remains an open question. The result dTob, obtained in this chapter, concerns ThermaCAM PM 595 LW, FLIR camera. However, the model (3.17) is valid for other cameras. Thus, dTob and conclusions will be similar for most cameras produced in the world. As mentioned earlier, error theory is not the only method of quantifying measurement error. In this monograph, we present a different approach based on the concept of uncertainty. At the same time, all input quantities of the model (3.17) and atmospheric transmission of the T Tatm model (3.15) are considered as random variables. The methodology and results of the study of measurement uncertainty in the infrared thermal imaging model are presented in Chapter 5. 5 Uncertainty of measurements. In such cases, the measurements in infrared thermal imaging model are presented thermal imaging model is usually represented the basics of the theory of measurements. In Such cases, the measurement errors and uncertainty with special attention to indirect measurements. In such cases, the measurements in infrared thermal imaging model are presented thermal imagin defined by the function of five variables (3.17) and by increments (described in Chapter 1) to assess the impact of errors in individual input variables on the variable output error. The precision model, defined in this way, is fully determined. The approach presented in Chapter 4 allows for analysis of the measurement model in terms of its sensitivity to the data (defined) variations of input quantities. In fact, sources of inaccuracy should be found not only in the features of the model itself, but also in the structure of measurement data (representing input volumes). In measurement theory, this is described as random interaction), all error information is represented by certain values of individual input volumes. This does not cover all possible interdependences between inputs, so therefore the analysis is viewed each time with one specific set of input variables. Another approach to the problem of accuracy assessment is based on the modern theory of uncertainty (Guide 1995). The main definitions of this theory, as well as the method of assessing uncertainty is a statistical indicator. A model of precision based on uncertainty is a statistical indicator. A model is the entiplication of this theory, as well as the method of assessing uncertainty is a statistical indicator. ability to simultaneously account the structure of input data represented by the probability density function or cumulative distribution function, and the properties of the measurement model. When we use the theory of uncertainty, the statistical input vector, but on the accounting of information included in large sets of representative inputs. Therefore, you need to define these sets as random variables. Unfortunately, the statistical input vector, but on the account of input vector, but on the account input vector, but on the properties of the measurement model. parameters that determine infrared thermography: Mistakes and uncertainty are random variables as well. Therefore, they are evaluated only with a certain probability. In this paper, the study of temperature measurement uncertainty is based on the idea of uncertainty of the data processing algorithm (Minkina and Dudzik 2005), which is a measure of the spread of the output random variable, equal to the standard experimental deviation of this variables. The uncertainty of measurements we make the following assumptions; (Minkina and Dudzik 2005), which is a measure of the spread of the spread of the standard experimental deviation of this variables. The uncertainty of measurements we make the following assumptions; (Minkina and Dudzik 2005), which is a measure of the spread of the spread of the spread of the standard experimental deviation of this variables. The uncertainty of measurements we make the following assumptions; (Minkina and Dudzik 2005), which is a measure of the spread of the measuring an object's temperature described by the distribution of the spread of the spread of the spread of the amount of output implemented around the experimental deviation. For a fairly large number of input variables, arithmetic medium and standard experimental deviation are impartial deviation. For a fairly large number of input variables, arithmetic medium and standard experimental deviation are impartial evaluators of the expected value and standard deviation respectively (Guide 1995, Skubis 2003). The simulations were based on two options: model input variables are not related; model input variables are interconnected. In our modelling, we used the Monte Carlo method in accordance with the recommendations of Working Group 1 of the studies leading to the evaluation of the combined components of standard uncertainty included the following steps: 1. Assessing the distribution parameters of input variables. 2. A generation of variable input implementations of parameters assessed in step 1 and for a certain level of variables. 2. A generation of variables. 2. A generation of variables of the results designed to assess the combined standard uncertainty and coverage interval of 95% in accordance with the procedure described in section 1.3. In the analysis, we took on one of two distributions of input variables: logarithmic Gauss distribution was used to ensure that the (Руководство 1995 г.): e-1/4 z p'z'dz: 5:2 на основе (5.1) и (5.2), ожидаемое значение переменной q зависит от логаритмического гауссианского распределения: s2 : exp m No 2 Дисперсия случайной переменной q зависит от логаритмического гауссианского распределения: s2 : exp m No 2 Дисперсия переменной q зависит от логаритмического гауссианского распределения: s2 : exp m No 2 Дисперсия случайной переменной q зависит от логаритмического гауссианского распределения: s2 : exp m No 2 Дисперсия переменной q зависит от логаритмического распределения: s2 : exp m No 2 Дисперсия случайной переменной q зависит от логаритмического распределения: s2 : exp m No 2 Дисперсия случайной переменной q зависит от логаритмического распределения: s2 : exp m No 2 Дисперсия переменной q зависит от логаритмического распределения: s2 : exp m No 2 Дисперсия переменной q зависит от логаритмического распределения: s2 : exp m
No 2 Дисперсия переменной q зависит от логаритмического распределения: s2 : exp m No 2 Дисперсия случайной переменной q зависит от логаритмического распределения: s2 : exp m No 2 Дисперсия случайной переменной q зависит от логаритмического распределения: s2 : exp m No 2 Дисперсия случайной переменной q зависит от логаритмического распределения: s2 : exp m No 2 Дисперсия случайной переменной q зависит от логаритмического распределения: s2 : exp m No 2 Дисперсия случайной переменной q зависит от логаритмического распределения: s2 : exp m No 2 Дисперсия случайной переменной q зависит от логаритмического распределения: s2 : exp m No 2 Дисперсия случайной переменной q зависит от логаритмического распределения: s2 : exp m No 2 Дисперсия случайной переменной q зависит от логаритмического распределения: s2 : exp m No 2 Дисперсия случайной переменной q зависит от логаритмического распределения: s2 : exp m No 2 дисперсия случайной (5,3) и (5,5) дия (5,5) распределения that the expected value and variance of the random variable are equal to E(I) and V (I) respectively. 5.2.1.2 The uniform distribution of the probability density function of uniform distribution is given as: &It; 1 для z b p'z 1/4 b a : 0 для других z; No5:7 Инфракрасная термография 84 Таблица 5.1 Уравнения, определяющие параметры дистрибутивов, используемых в анализе моделирования модели (3.17) распределен Equation solution (5.8) and (5.9) for and b, we can determine As for the logarymic Gauss distribution, the relationship between parameters of the two divisions used by their statistics Presented in Table 5.1 (Minkina and Dudzik 2006a). 5.2.2 Generation of a series of variable input implementations As mentioned above, random input variables measurement models (3.15), were created for two modeling options. representing individual inputs of the measurement models (3.17) and atmospheric transmission models (3.15), were created using the built-in functions of the pseudo-random generator in the MATLAB environment. They have allowed for the generation of a series of implementations that are subject to a certain probability density of uncertainty measurements in infrared thermal imaging 85 Table 5.2 Model Input Estimates (3.17) are intended to model the combined standard uncertainty Input amount Value Assessment of the emission object (d), m 1, 100 functions. Generator parameters are simultaneously parameters of the combined standard uncertainty Input amount Value Assessment of the emission object (d), m 1, 100 functions. Generator parameters are simultaneously parameters of the probability density functions calculated earlier from (5.6) - for logarite Gausian distribution - or from (5.10) were given a priori statistics of this variables are given in table 5.2. To assess the impact of standard input uncertainty on the uncertainty of an object temperature estimate for a model (3.17) with a model (3.15), we must determine the ranges of change in these uncertainties. The ranges of changes in input variables relative to the standard uncertainty used for the simulation presented in this paper 5.3. The ambient and atmospheric temperature scale (ITS-90). In the first phase of the study, we assumed there was no correlation between input variables relative to the standard uncertainty used for the simulation presented in this paper 5.3. The ambient and atmospheric temperature scale (ITS-90). In the first phase of the study, we assumed there was no correlation between input variables relative to the standard uncertainty used for the simulation presented in this paper 5.4. and analyzed the worst possible case, i.e. the even distribution of variables. Series N 1/4 10,000 inputs were created using a single random to the density distributions. Figures 5.1-5.5 show histograms (the sum of all bunker heights is one). The implementations were created using a single random to the density distributions of probability g(xi) (where xi is a variable ith input) generated input. Histograms of 20-ben normalized histograms of 20-ben normalized histograms of 20-ben normalized histograms of 20-ben normalized histograms corresponding to the density distributions of probability g(xi) (where xi is a variable ith input) generated using a single random MATLAB generator. The calibration parameters and measurement conditions used in the simulation were read from the thermal files recorded during experiments with the infrared camera FLIR ThermaCAM PM 595 LW. The calibration options range from 40 to 120 C. Symbols on E charts for expected value and s for standard deviation. They were the thermal files recorded during experiments with the infrared camera FLIR ThermaCAM PM 595 LW. The calibration options range from 40 to 120 C. Symbols on E charts for expected value and s for standard deviation. created for the same statistics (expected value and standard deviation) as before, and were used to simulate the components of the combined standard uncertainty. Table 5.3 Ranges of Relative standard uncertainty (3.17), expected to model Uncertainty (3.17), expected to model components of shared uncertainty. Table 5.3 Ranges of Relative standard entry-number uncertainty range (%) Object Emission (Ob) 0-30 Environment Temperature (To), K 0-3 Atmospheric Temperature (Tatm), K 0-3 Relative camera-object humidity

distance (v) (d), m 0-30 0-30 86 Figure 5.1 Infraredrm thermalography Probability variable density function, Presenting Emission (Uniform Distribution) Figure 5.3 The function of the variable representing the atmospheric temperature of Tatm (even distribution) Uncertainty of measurements in infrared thermal imaging 87 Figure 5.4 Probability probability probability probability probability function of the variable representing the temperature of the variable representing the distribution) Figure 5.5 The probability of the variable representing the temperature of the environment (logarithmic Gaussian distribution) Figure 5.8 Function of probability probability probability probability of variable , Atmospheric Temperature Tatm (Logarithmic Gauss distribution) Figure 5.10 Variable probability density function, representing the distance from camera to object d (logarythmic Gauss distribution) Figure 5.10 Variable probability density function, representing the distance from camera to object d (logarythmic Gauss distribution) Figure 5.10 Variable probability of variable pr 5.2.4 Correlated input variables of combination standard uncertainty component modeling were conducted using MATLAB and its Statistical Instrument (MATLAB 2005). Therefore, the description of the input variables of Gaussian marginal distributions. It is also possible to determine the coririan matrix for generated variables As a result, variables are subject to Gaussian distribution and are compared with certain correlation rates. Unfortunately, the STATISTICAL set of MATLAB (2005b), there is a method of generating correlated variables of almost any marginal distribution (implemented in the Statistical Tool Set). This method is used in this monograph to generate interconnected input variables of the measurement model (3.17) and atmospheric transmission models (3.15). The algorithm of this method can be divided into the following steps (Dudzik 2005): 1. A generation of the Gaussian cumulative distribution function (CDF), referred to here f, to a normalized Gaussian random variable. As a result, we get a random U variable, subject to normalized even distribution at intervals of 0, 1. CDF variable U 1/4 f (I) expressed as (MATLAB 2005b): PrfU u0 g 1/4 Prf f 1 u0 zg 1/4 u0 : This is a CDF uniform random variables, the application of the reverse CDF of any distribution of probability F to (normalized uniform) random U variable gives a random variable, subject to distribution, identical to F. The proof of this statement is the reverse (5.11). Thus, the correlation algorithm can generate the implementation of the random variable, subject to distribution, identical to F. The proof of this statement is the reverse (5.11). Thus, the correlation work is repeated for both original random variables, which inherit the interdependence of the original variables, will determine the distribution of probabilities. Unfortunately, the use of non-linear reverse CDF changes the initial cross-correlations of variables. For variables that correlation of variables. For variables that correlation of variables. For variables that correlations of variables. In MATLAB (2005b) the correlation of Spearman's rank r and the correlation of The Kendall T rank are used to assess nonlinear correlations between random variables. In this monograph, we use single distributions as the resulting distributions between variables. The model input variable generation algorithm (3.17) with the atmospheric transmission model (3.15) was implemented in the MATLAB environment. The main window of the program is shown in figure 5.11. The program performs the following functions: . . Reading the measurement conditions from the thermogram file Generating a number of variable input implementations with a specified correlation ratio Figure 5.11. The main program file Generating a number of variable input implementations with a specified correlation ratio Figure 5.11. The main program window to study the effect of cross correlation ratio Figure 5.11. combined standard uncertainty (Dudzik 2007). See Color Plate 10 for the color version of Uncertainty Measurements in Infrared Termography 91 Figure 5.12 Simulation, T sensitivity of the combined standard uncertainty model to changes in input variables, correlation, T sensitivity of the combined standard uncertainty model to changes in input variables. Selected results from the programme are presented below for illustrative purposes. Figures 5.12-5.16 show cross-correlations of the two input variables: the ob emission and the temperature of the To environment, provided that they are subject to an even distribution of probabilities. Expected E ('ob) 1/4 0.7 (10%) were assigned to random number 5.13 Simulation of the correlated algorithm of variables ob and to, correlation ('ob) 1/4 0.7 (10%) were assigned to random number 5.13 Simulation of the correlated algorithm of variables ob and to, correlation ('ob) 1/4 0.7 (10%) were assigned to random number 5.13 Simulation of the correlated algorithm of variables ob and to, correlation ('ob) 1/4 0.7 (10%) were 1/4 0.5 (uniform distribution) 92 Infrared thermography Figure 5.14 Simulation of the ob and To variable correlation of r 1/4 0.0 (linked variables, o, expected E(To) 1/4 296 K and standard s(To) deviation of r 1/4 0.0 (linked variables, o, expected E(To) 1/4 29.6 K (10%) were assigned to a random variable correlation of r 1/4 0.0 (linked variables, o, expected E(To) 1/4 29.6 K (10%) were assigned to a random variable correlation of r 1/4 0.0 (linked variables, o, expected E(To) 1/4 29.6 K (10%) were assigned to a random variable correlation of r 1/4 0.0 (linked variables, o, expected E(To) 1/4 29.6 K (10%) were assigned to a random variable correlation of r 1/4 0.0 (linked variables, o, expected E(To) 1/4 29.6 K (10%) were assigned to a random variable correlation of r 1/4 0.0 (linked variables, o, expected E(To) 1/4 29.6 K (10%) were assigned to a random variable correlation of r 1/4 0.0 (linked variables, o, expected E(To) 1/4 29.6 K (10%) were assigned to a random variable correlation of r 1/4 0.0 (linked variables, o, expected E(To) 1/4 29.6 K (10%) were assigned to a random variable correlation of r 1/4 0.0 (linked variables, o, expected E(To) 1/4 29.6 K (10%) were assigned to a random variable correlation of r 1/4 0.0 (linked variables, o, expected E(To) 1/4 29.6 K (10%) were assigned to a random variable correlation of r 1/4 0.0 (linked variables, o, expected E(To) 1/4 29.6 K (10%) were assigned to a random variable correlation of r 1/4 0.0 (linked variables, o, expected E(To) 1/4 29.6 K (10%) were assigned to a random variable correlation of r 1/4 0.0 (linked variables, o, expected E(To) 1/4 29.6 K (10%) were assigned to a random variable correlation of r 1/4 0.0 (linked variables, o, expected E(To) 1/4 29.6 K (10%) were assigned to a random variable correlation of r 1/4 0.0 (linked variables, o, expected E(To) 1/4 29.6 K (10%) were assigned to a random variable correlation of r 1/4 0.0 (linked variables, o, expected E(To) 1/4 29.6 K (10%) were assigned to a random variable correlation of r 1/4 0.0 (li the measurements examined were also generated using the Logarythmic Gauss distribution, as well as The algorithm has been tested for this distribution and correlation of r as for even distribution and correlation of r as for even distribution as well. The modeling results presented in the 5.12-5.16). Figure 5.12-5.16 is the expected E, standard deviation and correlation of r as for even distribution of the expected E, standard deviation of r as for even distribution of r as for even distribution of r as for even distribution as well. (uniform distribution) Uncertainty measurements in infrared thermal imaging 93 Figure 5.16 Simulation of the correlated algorithm of variables ob and To, correlation r 1/4 0.99 (uniform distribution) Figure 5.17 Simulation of correlated algorithm of variables ob and To, correlated algorithm of variables ob and To, correlation r 1/4 0.99 (uniform distribution) Figure 5.17 Simulation of correlated algorithm of variables ob and To, correlated algorithm of variables ob a algorithm of variables ob and to, correlation r 1/4 0.99 (uniform distribution) Figure 5.17 Simulation of correlated algorithm of variables ob and to, correlated algorithm of variables ob and to, correlation r 1/4 0.99 (uniform distribution) Figure 5.17 Simulation of correlated algorithm of variables ob and To, correlated algorithm of variables ob and variables ob and to, correlation r 1/4 0.5 (logarithmic hau 94 Infrared thermography Figure 5.18 Simulation of the correlated algorithm of variables ob and to, correlation r 1/4 0.0 (unrelated variables, logarythmic hau Russian Distributions) Figure 5.20 Simulation of the correlated algorithm of variables ob and To, correlated algorithm of variables ob and to, correlation r 1/4 0.0 (unrelated variables, logarythmic hau Russian Distributions) Figure 5.19 Simulation of the correlated algorithm of variables ob and To, correlated algorithm of variables ob and To, correlated variables, logarythmic hau Russian Distributions) Figure 5.19 Simulation of the correlated algorithm of variables ob and To, correlated algorithm of variables ob and To, correlated variables, logarythmic hau Russian Distributions) Figure 5.19 Simulation of the correlated algorithm of variables ob and To, correlated variables, logarythmic hau Russian Distributions) Figure 5.19 Simulation of the correlated algorithm of variables ob and To, correlated variables ob and To, correlated variables, logarythmic hau Russian Distributions) Figure 5.19 Simulation of the correlated algorithm of variables ob and To, correlated variables, logarythmic hau Russian Distributions) Figure 5.19 Simulation of the correlated algorithm of variables ob and To, correlated variables, logarythmic hau Russian Distributions) Figure 5.19 Simulation of the correlated algorithm of variables ob and To, correlated variables,
logarythmic hau Russian Distributions) Figure 5.19 Simulation of the correlated variables ob and To, correlated variables, logarythmic hau Russian Distributions) Figure 5.19 Simulation of the correlated variables ob and To, correlated variables, logarythmic hau Russian Distributions) Figure 5.10 Simulation of the correlated variables ob and to correlated variables, logarythmic hau Russian Distributions) Figure 5.10 Simulation of the correlated variables ob and to corr correlation r 1/4 0.5 (logarithic Gauss distributions) Figure 5.21 Simulation of the correlated algorithm described above, discussed in r 1/4 0.99 (logarithic Gauss distributions) Uncertainty of temperature assessment using infrared thermal imaging explored using the algorithm described above, discussed in r 1/4 0.99 (logarithic Gauss distribution) Uncertainty of temperature assessment using infrared thermal imaging explored using the algorithm described above, discussed in section 5.4. In section 5.3, we evaluate and discuss the components of the combined standard uncertainty, assuming that the model input variables are not interconnected. 5.3 Components of the combined standard uncertainty, assuming that the model input variables are not interconnected. MATLAB 7.1 (R13 SP1). THE built-in MATLAB features allow you to generate random variables. The simulations presented in this section 5.2. Read the reference values and calibration parameters from the AFF (AGEMA File). The simulations presented in this section 5.2. Read the reference values and calibration parameters from the AFF (AGEMA File). Format) (TOOLKIT IC2) and atmospheric transmission models (3.15). Model-based processing algorithm simulation of variable; T frequency histograms of t input quantities; T frequency histograms of tinput frequencies is determined by a series of implementations generated for user settings (Gajda and Szyper 1998). Two probability distribution of the probability distribution of the probability distribution of the probability distribution of the probability distribution. In this monograph, we examine the effect of the probability distribution of the probability distribution of the probability distribution of the probability distribution of the probability distribution. function of the variable output model. The purpose of the simulation was to assess the uncertainties of the processing algorithm associated with the impact of a particular contribution on the joint uncertainty. As for the simulation of errors in Chapter 4, the uncertainty analysis was conducted on four object temperature values: 30 C (303 K), 50 C (323 K), 70 C (323 K), 70 C (323 K), 70 C (323 K) and 90 C (303 K). expected for modeling are represented in table 5.3. To examine the dependence of individual components of the combined standard uncertainty on the emission ob and the distance from the camera to the object d, the processing algorithm was modeled for four different ob values and two values d. 96 Infrared thermography Figure 5.22 The main program window for modeling the sensitivity of the Therma PMCAM 595 camera measurement model. See Color Plate 11 for color version 5.3.1 The combined standard uncertainty component associated with Emissivity Figures 5.23 and 5.24 shows the results of the uncertainty component associated with the uncertainty component associated with Emissivity Figures 5.23 and 5.24 shows the results of the uncertainty component associated with the associated with the uncertainty of the u (ob) of the object's emission, assuming d 1/4 100 m, are shown in figure 5.24. Analysis of graphs in 5.23 and 5.24 shows the following conclusions: . . . The u(Tob) component of the combined standard emission uncertainty is highly dependent on the temperature of the Tob object. For example, in figure 5.24, we see that an object temperature of the combined standard emission uncertainty is highly dependent on the temperature of the relative combined standard uncertainty (from about 1% to more than 5%) for the maximum standard uncertainty considered for the issue of u ('ob) 1/4 30%. The estimated value of an object's emission does not affect standard uncertainty. For example, 5.23 and 5.24, we can see that the temperature graphs of the Tob object relative to the uncertainty associated with the emission are identical in both digits, regardless of the temperature of the relative to the uncertainty associated with the emission are identical in both digits, regardless of the temperature of the uncertainty associated with the emission are identical in both digits, regardless of the temperature of the uncertainty associated with the emission are identical in both digits, regardless of the temperature of temperature o associated with the emission of the object, with the results obtained for other components (shown below in this section) we can say that the standard uncertainty component associated with the ambient temperature measurement for the model. 5.3.2 The combined standard uncertainty component associated with the sta ambient temperature uncertainty was performed, as in the previous section, for different emission values of the object and distance from camera to object. Results for d 1/4 1 m are shown in figure 5.25 and resu dependent on emissions. Comparison 98 Infrared thermography Figure 5.24 Component of the relative standard uncertainty associated with the emission of ob, assuming an even distribution. Results for the distance from the camera to the object 1/4 30%, the component in question changes from about 0.2% to ob 1/4 0.9 to about 2.6% for ob 1/4 0.4. The simulation shows that this component decreases with the emission of the object. The component also depends on the estimated temperature of the Tob object. For example, looking at a 5.25 pattern, we see that u(Tob) associated with To, is approximately 2% for u/To uncertainty 1/4 3/6 and Tob 1/ temperature of the Tob object, the weaker the effect of environmental temperature uncertainty u (To) on the total uncertainty of the 5.25 and 5.26 Of observations can be concluded that Environmental temperature uncertainty of the 5.25 and 5.26 Of observations can be regarding the accuracy of temperature uncertainties regarding the accuracy of temperature measurements in infrared thermal imaging. Comparing the numbers 5.25 and 5.26, we can say that the component considered for combined standard uncertainty depends very little on the distance from the camera to object d 1/4 1 m 5.3.3 Component of the relative standard uncertainty associated with To's ambient temperature, assuming even distribution. The results for the distance from the camera to object d 1/4 1 m 5.3.3 Component of the relative standard uncertainty associated with To's ambient temperature, assuming even distribution. The results for the distance from the camera to object d 1/4 1 m 5.3.3 Component of the combined standard uncertainty associated with atmospheric temperature 5.27 and 5.28 show the results of modelling of the uncertainty component associated with the uncertainty of u(Tatm) atmospheric temperature 5.27 and 5.28 show the results of the graphs shown in the 5.27 and 5.28 show the results of modelling took place under the same conditions as in previous sections. Analysis of the graphs shown in the 5.27 and 5.28 show the results of uncertainty of u(Tatm) atmospheric temperature 5.27 and 5.28 show the results of the graphs shown in the 5.27 and 5.28 show the results of uncertainty of u(Tatm) atmospheric temperature 5.27 and 5.28 show the results of the graphs shown in the 5.27 and 5.28 show the results of uncertainty of u(Tatm) atmospheric temperature 5.27 and 5.28 show the results of the graphs shown in the 5.27 and 5.28 show the results of uncertainty of u(Tatm) atmospheric temperature 5.27 and 5.28 show the results of uncertainty atmospheric temperature 5.27 and 5.28 show the results of uncertainty of u(Tatm) atmospheric temperature 5.27 and 5.28 show the results of uncertainty atmospheric temperature 5.27 and 5.28 show the results of uncertainty atmospheric temperature 5.27 and 5.28 show the results of uncertainty atmospheric temperature 5.27 and 5.28 show the
results of uncertainty atmospheric temperature 5.27 and 5.28 show the results of uncertainty atmospheric temperature 5.27 and 5.28 show the results of uncertainty atmospheric temperature 5.27 and 5.28 show the results of uncertainty atmospheric temperature 5.27 and 5.28 show the results of uncertainty atmospheric temperature 5.27 and 5.28 show the results of uncertainty atmospheric temperature 5.27 and 5.28 show the results of uncertainty atmospheric temperature 5.27 and 5.28 show the results of uncertainty atmospheric temperature 5.27 and 5.28 show the results of uncertainty atmospheric temperature 5.27 and 5.28 show the results of uncertainty atmospheric temperature 5.27 and 5.28 show the results of uncertainty atmospheric temperature the relative standard uncertainty associated with the temperature of the atmosphere Tatm in the figures 5.27 and 5.28. The u(Tob) component associated with atmospheric temperature of the results presented instituty higher than 0.05% when Tob 1/4 303 K and about 0.3% when Tob 1/4 308, it is slightly higher than 0.05% when Tob 1/4 303 K and about 0.3% when Tob 1/4 308, it is slightly higher than 0.05% when Tob 1/4 303 K and about 0.3% when Tob 1/4 303 K and about 0.3% when Tob 1/4 308 K and about 0.3% when Tob 1/4 303 K and about 0.3% when Tob 1/4 308 K and about 0.3% when Tob 1/ the figures 5.27 and 5.28 indicates that the uncertainty component considered depends on the distance from the camera to the object d. For example, the value of you (Tob) read from figure 5.27b, for you (Tatm) 1/4 3% and Tob 1/4 323 K, multiple 100 Infrared thermography Figure 5.26 Component of the relative standard uncertainty associated with the environment temperature to assume the distribution of a uniform. Results for the distance from the camera to the object d. For example, the value of you (Tob) read from figure 5.27b, for you (Tatm) 1/4 3% and Tob 1/4 323 K, multiple 100 Infrared thermography Figure 5.26 Component of the relative standard uncertainty associated with the environment temperature to assume the distribution of a uniform. to the object d 1/4 100 m above 0.01%, while its value read from the picture 5.28b, for the same values of you (Tatm) and Tob, is about 0.15%, that is 15 times more. Analyzing the simulation of the uncertainty affects combined standard U (Tatm) and Tob, is about 0.15%, that is 15 times more. very long distance from the camera to object d. 5.3.4 Component of combined standard uncertainty associated with the results of atmospheric relative humidity, modeling for the combined uncertainty of u(v) relative humidity, shown in figures 5.29 and 5.30 figures, we can say that: Uncertainty of measurements in infrared thermal imaging 101 Figure 5.27 Component of the object d 1/4 1 m The u(Tob) component of the combined standard uncertainty associated with Atmospheric Temperature Tatm, assuming even distribution. Results for the distance from the camera to the object d 1/4 1 m The u(Tob) component of the combined standard uncertainty associated with Atmospheric Temperature Tatm, assuming even distribution. the graphs of the component in question are identical in all four a-d cases. In fact, comparing the results in figure 5.30 for you (v) 1/4 30% and Tob 1/4 1 m (figure 5.29). The component of the component of the component is about 0.15%. The component is about 0.15%. and d 1/4 100 m (Figure 5.30), the component increases with Tob for any fixed uncertainty u(v). A comparison of the results presented in 5.29 b for you (v) 1/4 30% and Tob 1/4 323 K is about 0.006%, while the value of you (Tob) read from a figure of 5.30b, for the same values you (V) and Tob, is about 0.08%. Analysis of the simulation of the relative standard uncertainty component associated with the relative standard uncertainty of temperature measurement is even weaker than the impact associated with the relative standard uncertainty of temperature measurement is even weaker than the impact associated with the relative standard uncertainty of temperature measurement is even weaker than the impact associated with the relative standard uncertainty of temperature measurement is even weaker than the impact associated with the relative standard uncertainty of the relative standard uncertainty of temperature measurement is even weaker than the impact associated with the relative standard uncertainty of the relative standard uncertainty of temperature measurement is even weaker than the impact associated with the relative standard uncertainty of temperature measurement is even weaker than the impact associated with the relative standard uncertainty of temperature measurement is even weaker than the impact associated with the relative standard uncertainty of temperature measurement is even weaker than the impact associated with the relative standard uncertainty of temperature measurement is even weaker than the impact associated with the relative standard uncertainty of temperature measurement is even weaker than the impact associated with the relative standard uncertainty of temperature measurement is even weaker than the impact associated with the relative standard uncertainty of temperature measurement is even weaker than the impact associated with the relative standard uncertainty of temperature measurement is even weaker than the impact associated with the relative standard uncertainty of temperature measurement is even weaker than the impact associated with the relative standard uncertainty of temperature measurement is even weaker than the impact associated with the relative standard uncertainty of temperature measurement is even weaker than the impact associated with the relative standard temperature of the Tatm atmosphere, assuming an even distribution. The results for the distance from the camera to object d 1/4 100 m 5.3.5 Component associated with the uncertainty of u(d) distance from the camera to object d 1/4 100 m 5.3.5 Component of the simulation of the uncertainty of u(d) distance from the camera to object d 1/4 100 m 5.3.5 Component associated with the uncertainty of u(d) distance from the camera to object d 1/4 100 m 5.3.5 Component of the simulation of the uncertainty associated with the uncertainty associate sections. Analysis of the graphs shown in the figures 5.31 and 5.32, allows us to draw the following conclusions: . . The value of the uncertainty component associated with the distance from camera to object expected for the simulation (as in the case of the ob, Tatm and v components previously mentioned). For example, looking at a 5.31 figure for you (d) 1/4 30% and Tob 1/4 363 K, we see that u (Tob) 0.014% for all four a-d ob cases. The component considered depends on the temperature Toba and his contribution to the standard uncertainty increases with Tob. In fact, taking into account the uncertainty associated with relative S.32*a* Component of the relative standard uncertainty associated with relative S.32*a* Component for the distance from figure 5.32*a* Component of the relative S.32*a* Component of the relative standard uncertainty increases with Tob. In fact, taking into account the uncertainty associated with relative S.32*a* Component of the relative standard uncertainty associated with relative S.32*a* Component of the relative standard uncertainty associated with relative S.32*a* Component of the relative S it's easy to see that for you (d) 1/4 30% and Tob 1/4 303 K, the uncertainty component associated with distance d is approximately 0.03%, while for Tob 1/4 363 K, it exceeds 0.15%. Comparing the results shown in 5.31 and 5.32 results in the observation that the component depends on the distance d is approximately 0.03%, while for Tob 1/4 303 K, it exceeds 0.15%. Comparing the results shown in 5.31 and 5.32 results in the observation that the component depends on the distance d is approximately 0.03%, while for Tob 1/4 303 K, it exceeds 0.15%. Comparing the results shown in 5.31 and 5.32 results in the observation that the component depends on the distance d is approximately 0.03%, while for Tob 1/4 303 K, it exceeds 0.15%. Comparing the results shown in 5.31 and 5.32 results in the observation that the component depends on the distance d is approximately 0.03%, while for Tob 1/4 303 K, it exceeds 0.15%. Comparing the results shown in 5.31 and 5.32 results in the observation that the component depends on the distance d is approximately 0.03%, while for Tob 1/4 30% and Tob 1/4 same values you (Tatm) and Tob) read from a figure of 5.32 b is about 0.08%, that is 10 times more. An analysis of the results presented in figures 5.31 and 5.32 shows that the impact of the distance d uncertainty u(d). Comparing the error analysis conducted in Chapter 4 with the uncertainty u(d). (common error or combined uncertainty) associated with the same amount of input have a similar character. 104 Infrared thermography Figure 5.30 Component of the relative standard uncertainty associated with relative standard uncertainty for correlated input variables 5.4.1 Introduction In Section 5.3 we investigated the impact of specific variable input models (3.17) and (3.15) (Figures 3.10b-d) on the relative combined standard of infrared thermal imaging. Modelling for the models allowed us to evaluate the components of two or more input quantities can be statistically correlated. The cross-correlation between the two random variables is qualitatively expressed for 1 r 1, as defined (Taylor 1997), as: Pyy and Oxy x 5:12 r1/4h i1 In this section we are concerned about the impact of correlations between pairs of input variable models (3.17) and (3.15) (figures 3.10b-d) on the relative standard uncertainty associated with distance from object d, assuming an ever distribution. Results for d 1/4 1 m in section 5.1. Example random variables representing the individual input amounts of the model setimated estimated estimated estimated estimated estimated setimated estimated estimated by the correlation
algorithm, are shown in figures 5.12-5.21. Below are the results of the model reviewed, generated by the correlation algorithm, are shown in figures 5.12-5.21. Below are the results of the simulation performed for each pair of input variables. Inputs for model reviewed, generated by the correlation algorithm, are shown in figures 5.12-5.21. Below are the results of the simulation performed for each pair of input variables. Inputs for model setimates and relative stand analysis of the temperature dependence of the combined uncertainty by cross-correlation between input variables was conducted for the three selected object temperature of the Tatm atmosphere (as warranted earlier). Therefore, as we can see from table 5.5, the dependence of the ambient do unknown is assumed to be equal to the temperature of the ambient do unknown is assumed to be equal to the temperature of the temperature of the Tatm atmosphere (as warranted earlier). Therefore, as we can see from table 5.5, the dependence of the ambient do unknown is assumed to be equal to the temperature of the ambient do unknown is assumed to be equal to the temperature of the ambient do unknown is assumed to be equal to the temperature of the ambient do unknown is assumed to be equal to the temperature of the ambient do unknown is assumed to be equal to the temperature of the ambient do unknown is assumed to be equal to the temperature of the ambient do unknown is assumed to be equal to the temperature of the ambient do unknown is assumed to be equal to the temperature of the ambient do unknown is assumed to be equal to the temperature of the ambient do unknown is assumed to be equal to the temperature of the ambient do unknown is assumed to be equal to the temperature of the ambient do unknown is assumed to be equal to the temperature of the ambient do unknown is assumed to be equal to the temperature of the ambient do unknown is assumed to be equal to the temperature of the ambient do unknown is assumed to be equal to the temperature of the ambient do unknown is assumed to be equal to the temperature of the ambient do unknown is assumed to be equal to the temperature of the ambient do unknown is assumed to be equal to the temperature of the ambient do unknown is assumed to be equal to the temperature of the ambient do unknown is assumed to be equal to the temperature of the ambient do unknown is assumed to be equal to the temperature of the ambient do unknown is assumed to be equal to the temperature of temperature of tem combined uncertainty on cross-correlations between input variables is being studied in the light of the standard uncertainty entered by distance d. Situations discussed in this monograph do not exhaust the question of the dependence is strongly influencing quantities, standard uncertainty of specific input variables, etc.). Another infrared thermography 106 Figure 5.32 Component is a relative standard uncertainty associated with the distance of D from camera to object, assuming even distribution. Results for d 1/4 100 m Table 5.4 Estimates of input variables, estimated in the analysis of the impact of correlations between model inputs (3.17) and (3.15) (figure 3.10b-d) on relative combined standard uncertainty uc (Tob), % Object emission ('ob) Ambient temperature (To), K 0.9, 0.8, 0.4, 293 Air Temperature (Tatm), K 293 Relative Humidity (v) 0.5 Distance from Camera to Object (D), m 50, 100 Table 5.5 Relative standard uncertainty uc (Tob), % object emission (ob) 10% Environment temperature (To) 10% Atmosphere temperature (Tatm) 10% Relative humidity (v) 10% Distance from camera to object (d) 10% Measurement uncertainty in infrared thermalography 107 interesting cases of measurement uncertainty in infrared thermalography 107 interesting cases of measurement uncertainty in infrared thermalography 107 interesting cases of measurement uncertainty in infrared thermalography 107 interesting cases of measurement uncertainty in infrared thermalography 107 interesting cases of measurement uncertainty in infrared thermalography 107 interesting cases of measurement uncertainty in infrared thermalography 107 interesting cases of measurement uncertainty in infrared thermalography 107 interesting cases of measurement uncertainty in infrared thermalography 107 interesting cases of measurement uncertainty in infrared thermalography 107 interesting cases of measurement uncertainty in infrared thermalography 107 interesting cases of measurement uncertainty in infrared thermalography 107 interesting cases of measurement uncertainty in infrared thermalography 107 interesting cases of measurement uncertainty in infrared thermalography 107 interesting cases of measurement uncertainty in infrared thermalography 107 interesting cases of measurement uncertainty in infrared thermalography 107 interesting cases of measurement uncertainty in infrared thermalography 107 interesting cases of measurement uncertainty in infrared thermalography 107 interesting cases of measurement uncertainty in infrared thermalography 107 interesting cases of measurement uncertainty interesting cases of meas uncertainty of uc (Tob) of object temperature, suggesting correlations between pairs of random variable models (3.17) (3.15) (pictured) 5.33-5.52 as uc (Tob) graphs compared to the emission of the object ob and the temperature of the ambient To for two distances from camera to object: d 1/4 50 and 100 m. Values d are supposed to be performed in simulations from practical circumstances: on the one hand, for a short distance from the camera to the object, the effect of atmospheric transmission may be neglected; On the other hand, for a short distance of a through variables representing the effect of atmospheric transmission may be neglected; On the other hand, the distance of a through variables representing the rent of the correlation ratio of r random variables representing the effect of atmospheric transmission may be neglected; On the other hand, the distance of atmospheric transmission may be neglected; On the other hand, the distance of atmospheric transmission may be neglected; On the other hand, the distance from the camera to the object, the effect of atmospheric transmission may be neglected; On the other hand, the distance of atmospheric transmission may be neglected; On the other hand, the distance of atmospheric transmission may be neglected; On the other hand, the distance of atmospheric transmission may be neglected; On the other hand, the distance of atmospheric transmission may be neglected; On the other hand, the distance of atmospheric transmission may be neglected; On the other hand, the distance of atmospheric transmission may be neglected; On the other hand, the distance of atmospheric transmission may be neglected; On the other hand, the distance of atmospheric transmission may be neglected; On the other hand, the distance of atmospheric transmission may be neglected; On the other hand, the distance of atmospheric transmission may be neglected; On the other hand, the distance of atmospheric transmission may be neglected; On the other hand, the distance of atmospheric transmission may be neglected; On the other hand, the distance of atmospheric transmission may be neglected; On the other hand, the distance of atmospheric transmission may be neglected; On the other hand, the distance of atmospheric transmission may be neglected; On the other hand, the distance of atmospheric transmission may be neglected; On the d object of emission ob and ambient temperature for d 1/4 50 m 108 Infrared thermal imaging Figure 5.34 Modeling relative to the correlation ratio of r of random variables, Representing the object of emission ob and ambient temperature for d 1/4 100 m Simulation of the combined standard uncertainty of uc (Tob) compared to the correlation ratio of r of random variables, Representing object emission ob and the temperature of the atmosphere Tatm, for d 1/4 50 and d 1/4 100 m, are represented in the figures 5.35 and 5.36 respectively. Simulation of the ob object and atmospheric relative humidity v, for two distances from the camera to the object d 1/4 50 and 5.38 and 5.38 and 5.38 and 5.39 and 5.39 and 5.30 Figures 5.39 and 5.40 show a simulation of the combined standard uncertainty of uc (Tob) compared to the correlation ratio, suggesting a correlation ratio, suggesting a correlation between random variables representing the emission of the combined standard uncertainty of uc (Tob) compared to the correlation ratio, suggesting a correlation between random variables representing the temperature of the ambient To and the temperature of the atmosphere Tatm, at two distances d 1/4 50 and 100 m, is shown in the figures 5.43 and 5.42. Figures 5.43 and 5.42 show a simulation of the correlation between random variables representing the uncertainty of measurements in infrared thermal imaging 109 Figure 5.35 Simulation of the relative combined standard uncertainty of uc (Tob) compared to the correlation ratio of r random variables representing the object of emission ob and atmospheric temperature Tatm for d 1/4 50 m environment and atmospheric temperature and atmosphere of relative humidity v, at two distances d 1/4 50 m environment and atmospheric temperature and the distance from the camera to the d for 1/4 50 and 100 m is displayed in 5.45 and 5.46. Figures 5.47 and 5.48 show a simulation of the combined standard uncertainty of uc (Tob) compared to the correlation between random variables representing the temperature of the Tatm atmosphere and atmosphere (Tob) and the r correlation ratio, suggesting a correlation between random variables representing the temperature of the Tatm atmosphere and the distance of D from camera to object for d 1/4 50 and 5.51 and 5.52 show a simulation of the combined standard uncertainty of the relative humidity of the relative humidity of the relative humidity of the combined standard uncertainty of uc (Tob) and 100 m, is shown in the
figures 5.49 and 5.52 show a simulation of the combined standard uncertainty of the combined standard uncertainty of the relative humidity of the relative humidity of the combined standard uncertainty of uc (Tob) and 100 m, is shown in the figures 5.49 and 5.50. atmosphere v and the distance from the camera to object d, for d 1/4 50 and 100 m respectively. 110 Infrared thermography Figure 5.36 Simulation of the relative combined standard uncertainty of uc. Tob), taking into and atmospheric temperature Tatm for d 1/4 100 m 5.4.3 Conclusions Analysis provided by the simulation of the combined standard uncertainty of uc. Tob), taking into a the combined standard uncertainty of uc. Tob) to a the combined standard uncertainty of uc. Tob) to a the combined standard uncertainty of uc. Tob) to a the combined standard uncertainty of uc. Tob) to a the combined standard uncertainty of uc. Tob is a the combined standard uncertainty of uc account the possible cross-correlations between the input quantities of the infrared camera measurement model, allows us to draw the following conclusions: . . . The relative combined standard uncertainty of the uc (Tob) model (3.17) with the model (3.17) with the model (3.17) with the model, allows us to draw the following conclusions: . . . The relative combined standard uncertainty of the uc (Tob) model (3.17) with the model (3.10) w (Tob) and the correlation between ob and To depends on the distance from camera to object. Comparing, for example, drawing 5.33 and drawing 5.34a, we see that the graphs of uc (Tob), for d 1/4 50 and 100 m, are different. The effect of the correlation between ob and To on uncertainty uc (Tob) depends or the temperature of the temperature of the correlation between ob and To on uncertainty uc (Tob) depends or ob - compare, for example, the numbers 5.33a-d. Uncertainty of measurements in infrared thermal imaging 111 Figure 5.37 Simulation of the relative combined standard uncertainty of uc (Tob) compared to the correlative humidity v for d 1/4 50 m . . . The graphs presented in the figures 5.35 and 5.36 show that the combined uncertainty of uc (Tob) depends on the correlation between input variables representing the object emission ob and the atmospheric temperature of 5.35 5.36 that the impact of this correlation decreases with the decrease in the about. Figures of 5.35 and 5.36 that the impact of this correlation factor. This trenc can be seen by comparing, for example, the figures 5.36a and c. Charts in these figures are at odds with the decrease in the emission of the object. This effect can be observed for all pairs of correlated input variables. Thus, we can conclude that the lower the emission of the object. This effect can be observed for all pairs of correlated input variables. uncertainty on the temperature of the Tob object. Figures of 5.41 and 5.42 suggest that the combined uncertainty of uc (Tob) also depends on the correlation between the temperature of the atmosphere Tatm. A comparison, for example, of 5.41a-d shows that the effect of the correlation between To and Tatm on uc uncertainty (Tob) decreases with a decrease in ob. From the drawings 5.41 and 5.42 we also see that the distance from the camera to object d, in principle, does not affect the 112 Infrared thermography figure 5.38 Simulation of the relative combined standard uncertainty. The d values taken in the simulations are followed by practical circumstances: for a short distance from the camera to the object, the influence of atmospheric transmission can be ignored. On the other hand, the distance of d 100 m appears to be the upper limit for most infrared thermal imaging inspections. Analysis of the submitted modelling results leads to the observation that the combined uncertainty of uc (Tob) depends mainly on correlations between the pairs of variables mentioned above: that is, ob with To, ob with To with Tatm and To with Tatm. All other cases of cross-correlation between the two input variables have little or no effect on the cumulative uncertainty of the standard - see Figures 5.37-5.40. Summing up the above considerations between input variables of models (3.17) and (3.15) (figures 3.10b-d) on the relative uncertainty of the standard - see Figures 5.37-5.40. Summing up the above considerations between input variables of models (3.17) and (3.15) (figures 3.10b-d) on the relative uncertainty of the standard - see Figures 5.37-5.40. Summing up the above considerations between input variables of models (3.17) and (3.15) (figures 3.10b-d) on the relative uncertainty of the standard - see Figures 5.37-5.40. Summing up the above considerations between input variables of models (3.17) and (3.15) (figures 3.10b-d) on the relative uncertainty of the standard - see Figures 5.37-5.40. Summing up the above considerations between input variables of models (3.17) and (3.15) (figures 3.10b-d) on the relative uncertainty of uc (Tob) temperature measurements using infrared thermal imaging, we can say that this effect is strongly dependent on measurement conditions between the two input variables of models (3.17) and (3.15) (figures 3.10b-d) on the relative uncertainty of uc (Tob) temperature measurements using infrared thermal imaging, we can say that this effect is strongly dependent on measurement conditions between the two input variables of models (3.17) and (3.19) (figures 3.10b-d) on the relative uncertainty of uc (Tob) temperature measurement conditions (3.17) and (3.19) (figures 3.10b-d) on the relative uncertainty of uc (Tob) temperature measurement conditions (3.17) and (3.19) (figures 3.10b-d) on the relative uncertainty of uc (Tob) temperature measurement (3.17) and (3.19) (figures 3.10b-d) on the relative uncertainty of uc (Tob) temperature measurement (3.17) and (3.19) (figures 3.10b-d) on the relative uncertainty of uc (Tob) temperature measurement (3.17) and (3.17) (figures 3.10b-d) on the relative uncertainty (figures 3.10b-d) on the relative Looking at the uc (Tob) graphs, we can conclude that the values received do not contribute much to the overall uncertainty of 1 sigma, which is determined at a relatively low level of confidence. To determined at a relatively low level of confidence. To determined at a relatively low level of contribute much to the so-called uncertainty of uc (Tob) by r correlation ratio of random variable variables the emission of the ob object and the distance from the camera to the object d, for d 1/4 50 m should be multiplied by the expansion factor - see (1.20) in section 1.2. This increases the impact of correlations on uncertainty. In addition, our analysis is associated with relative uncertainty. In addition, our analysis is associated with relative uncertainty. The actual impact of correlations can be obtained by recalculating the values shown in the graphs on absolute uncertainty. The actual impact of correlations can be obtained by recalculating the values shown in the graphs on absolute uncertainty. in Kelvin, K). For example, the relative uncertainty in figure 5.33d for Tob 1/4 343 K is about 12%, i.e. about 41 K in absolute uncertainty is about 12.5%, so absolute uncertainty is about 13.5%, so absolute uncertainty is about 46 K. This example shows how large the discrepancies between the ob and To emission and the choice of this pair for the above example is not purely theoretical. As described in section 2.3, the emission of an object depends on its temperature. Since practical considerations relate to gray bodies 114 Infrared thermography Figure 5.40 Simulation of the relative combined standard uncertainty of uc (Tob) compared to the emission estimate is highly dependent on the surrounding radiation, which in turn depends on the radiation. Example 2.3 in section 2.3 describes the measurement of emissions in open measuring chambers. Placing an object in a chamber is designed to make measurements as independent as possible from the surrounding radiation. Unfortunately, the complete separation of the ambient To) affects the measurement of infrared thermalography to some extent. Taking into account the cross-relationship between about and to is not a theoretical issue and may be necessary in practical measurements of infrared thermal imaging, because as we have shown, the impact of this correlation on combined uncertainty is significant. Similar reasoning can be performed for other pairs of input variables if correlated; It is generally thought to be equal to the Tatma or strictly dependent on the Tatma, because the temperature of some or all of the emitting objects located in the the object under study, i.e. the ambient temperature, is equal to Tatma, because the temperature, is equal to Tatma - figure 5.41 Simulation of the relative combined standard uncertainty of uc (Tob) compared to the correlation ratio (Tob) compared to the correlation ratio (Tob) compared to the co random variables representing the temperature of the environment and atmospheric temperature Tatm for d 1/4 50 m can strongly affect the function of measurement conditions in infrared thermal imaging, this chapter can be considered more as an introduction than as a comprehensive study of the subject. In our opinion, in addition to simulatior to simulatior to simulatior to simulation to simulatin to simulation to simulation to sintef studies, a broad experimental test of the presented thesis is necessary. This test should cover different models of measurements of infrared thermalography, atmospheric transmission, etc. The final stage of the model study (3.17) and (3.15) (figure 3.10b-d) is to assess the combined standard temperature measurements of infrared thermalography, atmospheric transmission, etc. The final stage of the model study (3.17) and (3.15) (figure 3.10b-d) is to assess the combined standard temperature measurement uncertainty along with the corresponding coverage intervals. practical numerical example will illustrate considerations about the dependence of the
relative combined standard uncertainty of uc (Tob) on the correlation ratio of r of random variables, representing the temperature of the relative combined standard uncertainty of uc (Tob) compared to the correlation ratio of r of random variables of models (3.17) and (3.15). Infrared thermography 116 Figure 5.42 Simulation of the relative combined standard uncertainty of uc (Tob) compared to the correlation ratio of r of random variables of models (3.17) and (3.15). Tatm for d 1/4 100 m Example 5.1 Assessment of the relative combined standard uncertainty taking into account the correlations), data in Table 5.6, subject to the relative standard uncertainty of these quantities, as in Table 5.5. In this example, we assume that the correlation occurs only between the object of the emission about and the atmospheric temperature of Tatm. Let's also assume that in order to set the estimates ob Table 5.6 Emission Object ('ob) 0.9 Estimates of input quantities, taken in Example 5.1 Ambient Temperature (To), K 293 Atmosphere Temperature (To of the relative combined standard uncertainty of uc (Tob) compared to the correlation ratio of r random variables, a series of 20 pairs measurements (ob. Tatm) was performed. The results are shown in figures 5.53 and 5.54. Horizontal lines indicate averages (estimates) of measurements: ob 1/4 0:9. T atm 1/4 296 K. Correlation ratio is determined by formula (5.12): it gives r 1/4 0.5. Finally, let's assume that the temperature of the object read from the camera was 1/4 343 K. Now, with a figure of 5.35a, we see that the temperature of the object read from the cambined standard uncertainty for unrelated input variables 5.5.1 The simulation of the combined standard uncertainty of uc (Tob) is 1.6%. leads to an assessment of the combined standard uncertainty. This combined standard uncer- 118 Infrared thermography Figure 5.44 Simulation of the relative combined standard uncertainty of uc (Tob) compared to the correlation ratio of r random variables representing environmental temperature and atmospheric relative combined standard uncertainty of uc (Tob) compared to the correlation ratio of r random variables representing environmental temperature and atmospheric relative humidity v for d 1/4 100 m tainty uniquely characterizes the accuracy of measurement errors, the combined standard uncertainty is determined from its components associated with individual quantities. Unfortunately, it is usually assessed at a relatively low. As mentioned in section 1.2, in order to increase the likelihood of finding a measurement result in a certain interval associated with uncertainty, we need to kno the value of the so-called expansion factor, which extends the uncertainty interval and therefore the likelihood of finding the result of measurement within that extended interval. In section 1.2, we indicated that the value of the expansion factor depended on the form of distribution of the number of degrees of freedom. This monograph assesses the combined standard uncertainty of individual input variables in the temperature measurement model were discussed in section 1.3. The components of the combined standard uncertainty associated with the uncertainty associated with the uncertainty of measuring infrared thermal imaging using the distribution method presented in section 1.3. The components of the relative combined standard uncertainty of uc (Tob) compared to the correlation ratio of r random variables. In this section, we present a simulation of the combined standard uncertainty from correlations between between correlations between to a simulation of the combined standard uncertainty from correlations between between to a simulation of the combined standard uncertainty from correlations between between to the combined standard uncertainty of uc (Tob) of the object d, for d 1/4 50 m Section 5.4 we reviewed combined standard uncertainty of uc (Tob) of the object temperature, assuming the temperature of the environment to and the distance from the camera to object d, for d 1/4 50 m Section 5.4 we reviewed combined standard uncertainty of uc (Tob) of the object temperature of the combined standard uncertainty of uc (Tob) of the object temperature of the environment to and the distance from the camera to object d, for d 1/4 50 m Section 5.4 we reviewed combined uncertainty from correlations between the temperature of the object temperature of the environment to and the distance from the camera to object d, for d 1/4 50 m Section 5.4 we reviewed combined uncertainty from correlations between the temperature of the environment to and the distance from the camera to object d, for d 1/4 50 m Section 5.4 we reviewed combined uncertainty from correlations between the temperature of the environment to and the distance from the camera to object d, for d 1/4 50 m Section 5.4 we reviewed combined uncertainty from correlations between the temperature of the environment to an envine ten probability described in section 5.2, namely logarithmic Gaussian or even distribution. The simulation was carried out, for example, with data from standard volume uncertainty. The final step in our measurement accuracy study was to estimate the coverage interval of 95%. In accordance with the Recommendations of the Guide (2004), it was determined on the basis of the distribution of output variable models (3.17) and (3.15) (figures 3.10b-d) derived from modelling. The results of the simulation are presented further. 5.5.2 Simulation of the Combined Standard Uncertainty Simulation was carried out in 12 cases of different estimates and three object temperature estimates). As in the uncertainty component investigation, the simulation was performed for the temperature of the Tob object equal to: 323 K (50 C), 343 K (70 C) 120 Infrared thermography Figure 5.46 Simulation of relative combined standard uncertainty uc (Tob) vs. correlation ratio r of random variables, representing the temperatures are within the I range of a typical camera, so the simulation results are valid for this range - other measurement ranges have different calibration constants. For each case, the coverage interval of 95% l95% was assessed. Certain coverage intervals were compared with intervals calculated for the Gausian distribution, which is assumed to be, in most dimensions, a variable distribution, which is assumed to be, in most dimensions, a variable distribution of output variables includes a k-42 expansion ratio for a confidence level of 95%. In section 1.3, we mentioned that the width of the 95% coverage interval depends on the symmetry of the distribution of variable probability of output relative to expected cost. For example, a factor that appears in (1.27) directly determines the quantitative probability of covering 95% p. For a symmetry, we present for each case a 95% coverage interval depends on distribution of 1/4 0.025. To determines the quantitative probability of covering 95% p. For a symmetry, we present for each case a 95% coverage interval depends on distribution of 1/4 0.025. To determine how the coverage interval depends on distribution of 1/4 0.025. with the width for the estimated symmetrical distribution of the variable output (a 1/4 0.025). Uncertainty of measurements in infrared thermal imaging 121 Figure 5.47 Simulation of the relative combined standard uncertainty of measurements in infrared thermal imaging 121 Figure 5.47 Simulation of the relative combined standard uncertainty of uc (Tob) compared to the correlation ratio r of random representing the atmospheric temperature of Tatm and the relative combined standard uncertainty of measurements in infrared thermal imaging 121 Figure 5.47 Simulation of the variable output (a 1/4 0.025). environment. The input for modeling (i.e. estimates and uncertainties of input variables) is given in tables 5.7 and 5.8. For each case, we present a normalized histogram of the grobability density function of the probability density function of the probability of the grobability of the stributions determined by the Gausian distribution of the probability of the grobability density function of the probability of the grobability density function of the probability of the grobability o variable output. Table 5.7 Estimates of input volumes expected to analyze combined standard model uncertainty (3.17) and (3.15) (figure 3.10b-d) Object emission (about) 0.9, 0.6, 0.4 Environment Temperature (Totm) 293 K Relative Humidity (v) 0.5 Camera Distance to Object (d) 10 m Infrared Thermography 122 Table 5. 8 Standard uncertainty models tandard uncertainty (3.17) and (3.15) (figure 3.10b-d) Object emission (about) 0.9, 0.6, 0.4 Environment Temperature (Tot) 293 K Relative Humidity (v) 0.5 Camera Distance to Object (d) 10 m Infrared Thermography 122 Table 5. 8 Standard uncertainty of input amount expected for analysis of combined standard uncertainty models (d) 10 m Infrared Thermography 122 Table 5. 8 Standard uncertainty (3.17) and (3.15) (figure 3.10b-d) Object (d) 10 m Infrared Thermography 122 Table 5. 8 Standard uncertainty (3.17) and (3.15) (figure 3.10b-d) Object (d) 10 m Infrared Thermography 122 Table 5. 8 Standard uncertainty (3.17) and (3.15) (figure 3.10b-d) Object (d) 10 m Infrared Thermography 122 Table 5. 8 Standard uncertainty (3.17) and (3.15) (figure 3.10b-d) Object (d) 10 m Infrared Thermography 122 Table 5. 8 Standard uncertainty (3.17) and (3.15) (figure 3.10b-d) Object (d) 10 m Infrared Thermography 122 Table 5. 8 Standard uncertainty (3.17) and (3.15) (figure 3.10b-d) Object (d) 10 m Infrared Thermography 122 Table 5. 8 Standard uncertainty (3.17) and (3.15) (figure 3.10b-d) Object (d) 10 m Infrared Thermography 122 Table 5. 8 Standard uncertainty (3.17) and (3.15) (figure 3.10b-d) Object (d) 10 m Infrared Thermography 122 Table 5. 8 Standard uncertainty (3.17) and (3.15) (figure 3.10b-d) Object (d) 10 m Infrared Thermography 122 Table 5. 8 Standard uncertainty (3.17) and (3.15) (figure
3.10b-d) Object (d) 10 m Infrared Thermography 122 Table 5. 8 Standard uncertainty (3.17) and (3.15) (figure 3.10b-d) Object (d) 10 m Infrared Thermography 122 Table 5. 8 Standard uncertainty (3.17) (figure 3.10b-d) (figure 3.10b-d) (figure 3.10b-d) (figure 3.10b-d) (figure 3.10b-d) (figure 3.10b-d (3.17) and (3.15) (figure 3.10b-d) Object emission (about) Environment temperature (C) 0.09, 0.06, 0.04 (10%) 9 K (3%) Air temperature (Tatm) 9 K (3%) Air temperature (at 1 m (10%) Left side graphs in the 5.55-5.72 figures show the probability density of the output variable models (3.17) and (3.15) with marked end coverage intervals of 95%. These limits were determined on the basis of cumulative distributions assuming that the Gaussian distribution of ob values in table 5.7, and for Tob 1/4 323, 343 and 363 K. When modeling the distribution of neutral assessment. In our study, we also looked at logarithmic Gaussian distributions of variables. This follows from the fact that even distribution of output variables. When modeling the distribution of the worst case in terms of a combined standard uncertainty assessment. In our study, we also looked at logarithmic Gaussian distribution is the worst case in terms of a combined standard uncertainty assessment. In our study, we also looked at logarithmic Gaussian distribution is the worst case in terms of a combined standard uncertainty assessment. relative combined standard uncertainty of uc (Tob) compared to the correlation ratio of r random variables representing the atmospheric temperature of Tatm and relative humidity v for d 1/4 100 m Uncertainty of uc. Tob) Compared to the ratio of r random variables representing the atmospheric temperature of Tatm and relative humidity v for d 1/4 50 m of the estimated measurement and modeling of input data, we did not notice any significant differences between the uncertainties estimated for a given distribution. However, we cannot rule out that other modeling data results of 95% on quantum order a are represented in the drawings 5.56-5.72. The intervals were determined on the basis of cumulative distributions, assuming the Gaussian distribution of the simulation of the simulation. The 195%-norm refers to a 95% coverage interval determined by the condition that the variable output of the models (3.17) and (3.15) is to be distributed on Gaussia. Values in 195%-sim brackets and 195%-sim brackets in the same row of the table. Infrared thermography 124 Table 5.9 Simulation results for infrared thermal imaging models (3.17) and (3.15), in terms of combined standard uncertaint uc (Tob) ob Tob, K uc (Tob), K 0.9 323 343 363 323 343 363 323 343 363 323 343 363 323 343 363 2.9 (0.9%) 4.3 (1.3%) 5.6 (1.7%) 6.0 (1.7\%) 6.0 (1.7\%) 6.0 (1.7\%) 6.0 (1.7\%) 6.0 (1.7\%) 6.0 (1.7\%) 6.0 (1.7\%) 6.0 (1.7\%) 6.0 (1.7\%) 6.0 (1.7\%) 6.0 (1.7\%) 6.0 (1.7\%) 6.0 (1.7\%) 6.0 (1.7\%) 6.0 (1.7\%) 6.0 (1.7\%) 6.0 (1.7\%) 6.0 (1.7\%) 6.0 (1.7\%) 6.0 377 K 344 K 363 K 382 K (12 K) (17 K) (23 K) (22 K) (23 K) (23 K) (27 K) (44 K) (40 K) (20 K) (23 K) (27 K) (44 K) (40 K) (20 K) uncertainty of uc (Tob) compared to the correlation ratio of r of random variables, representing atmospheric relative humidity v and distance from camera to object d, for d 1/4 50 m 5.5.3 Conclusions Analysis of simulation of the combined standard uncertainty increases with the rise in temperature of the Tob object. For ob 1/4 0.4 this link is the backlink. Additional simulations have confirmed that for low object emission this trend inversion is common: for ob below 0.5, combined uncertainty increases with the increase in Tobe. The results of the additional simulations have confirmed that for low object is the object the faster the increase in uncertainty. 126 Infrared thermography Figure 5.52 Simulation of the relative combined standard uncertainty of uc (Tob) compared to the correlation ratio of r random variables representing atmospheric relative humidity v and distance from camera to object d, for d 1/4 100 m Figure 5.53 Values 20 emission measurements 'ob uncertainty measurements in infrared termography Figure 5.54 . 127 Values of 20 measurements of temperature Tatm Coverage interval 95% is greatly extended with a decrease in the emission of the object ob. For example, table 5.9 shows that for ob 1/4 0.2 and Tob 1/4 323 K it increases to 39 K. This trend is also visible from the comparison of figures 5.56 and 5.68. By comparing coverage intervals determined by the approximation of the output of the cumulative distribution variables to the coverage intervals determined for Gaussian distributions, we may notice that the differences are insignificant. In general, assuming that the coverage intervals determined for Gaussian distributions, we may notice that the differences are insignificant. In general, assuming that the coverage intervals determined for Gaussian distributions, we may notice that the differences are insignificant. In general, assuming the coverage intervals determined for Gaussian distributions, we may notice that the differences are insignificant. coating interval for the Gaussian chart 5.55 Probability probability probability function of the output variable Tobe model (3.17), and (3.15), for Tob 1/4 323 K and ob 1/4 0.9 distributions always lie above the solid lines representing the width of the coating intervals compared to the quantitative order A for Tob 1/4 323 K and ob 1/4 0.9 distributions always lie above the solid lines representing the width of the coating intervals compared to the quantitative order A for Tob 1/4 323 K and ob 1/4 0.9 distributions always lie above the solid lines representing the width of the coating intervals compared to the quantitative order A for Tob 1/4 323 K and ob 1/4 0.9 distributions always lie above the solid lines representing the width of the coating intervals compared to the quantitative order A for Tob 1/4 323 K and ob 1/4 0.9 distributions always lie above the solid lines representing the width of the coating intervals compared to the quantitative order A for Tob 1/4 323 K and ob 1/4 0.9 distributions always lie above the solid lines representing the width of the coating intervals compared to the quantitative order A for Tob 1/4 323 K and ob 1/4 0.9 distributions always lie above the solid lines representing the width of the coating intervals compared to the quantitative order A for Tob 1/4 323 K and ob 1/4 0.9 distributions always lie above the solid lines representing the width of the coating intervals compared to the quantitative order A for Tob 1/4 323 K and ob 1/4 0.9 distributions always lie above the solid lines representing the width of the coating intervals compared to the quantitative order A for Tob 1/4 323 K and ob 1/4 0.9 distributions always lie above the solid lines representing the width of the coating intervals compared to the quantitative order A for Tob 1/4 0.9 distributions always lie above the solid lines representing the width of the coating intervals compared to the quantitative order A for Tob 1/4 0.9 distributions always lie above the solid lines representing the distributions always lin observations, it can be concluded that in order to assess the extended uncertainty of temperature measurement using models (3.17) and (3.15) with a confidence level of 95%, it is safe to assumption will result in a slight extension of the coverage interval obtained as a result of the simulation. In other words, the confidence level of the interval determined for the Gaussian distribution of the output variable of the measurement model examined is just over 95%, meaning the estimate is safe. By comparing the graphs corresponding to the distributions, we see that the width of the coverage interval of 95% is virtually independent of the safe. By comparing the estimate is safe. By comparing the graphs corresponding to the Gaussian distributions, we see that the width of the coverage interval of 95% is virtually independent of the safe. By comparing the estimate is safe. By comparing the estimate is safe. 0.4, we see that the coverage interval figure is Figure 5.57 Probability Probability Exit Probability Exit Probability Exit Probability Feature Tob models (3.17) and (3.15), for Tob 1/4 0.01. A comparison of the width of the interval for 1/4 0.02.
A comparison of the width of the interval for 1/4 0.01. A comparison of the width of the interval for 1/4 0.02. Set 129 95% coverage intervals compared to the quantum order A for Tob 1/4 0.01. A comparison of the width of the interval for 1/4 0.02. Set 129 95% coverage intervals for 1/4 0.02. Set 129 95% coverage intervals compared to the quantum order A for Tob 1/4 0.02. Set 129 95% coverage intervals compared to the quantum order A for Tob 1/4 0.01. A comparison of the width of the interval for 1/4 0.02. Set 129 95% coverage intervals compared to the quantum order A for Tob 1/4 0.02. Set 129 95% coverage intervals compared to the quantum order A for Tob 1/4 0.02. Set 129 95% coverage intervals compared to the quantum order A for Tob 1/4 0.02. Set 129 95% coverage intervals compared to the quantum order A for Tob 1/4 0.02. Set 129 95% coverage intervals compared to the quantum order A for Tob 1/4 0.02. Set 129 95% coverage intervals compared to the quantum order A for Tob 1/4 0.02. Set 129 95% coverage intervals compared to the quantum order A for Tob 1/4 0.02. Set 129 95% coverage intervals compared to the quantum order A for Tob 1/4 0.02. Set 129 95% coverage intervals compared to the quantum order A for Tob 1/4 0.02. Set 129 95% coverage intervals compared to the quantum order A for Tob 1/4 0.02. Set 129 95% coverage intervals compared to the quantum order A for Tob 1/4 0.02. Set 129 95% coverage intervals compared to the quantum order A for Tob 1/4 0.02. Set 129 95% coverage intervals compared to the quantum order A for Tob 1/4 0.02. Set 129 95% coverage intervals compared to the quantum order A for Tob 1/4 0.02. Set 129 95% coverage intervals compared to the quantum order A for Tob 1/4 0.02. Set 129 95% coverage intervals compared to the quantum order A for Tob (symmetrical distribution) shows that the width varies by no more than 1 K, which is negligible if we remember that the width of the interval is above 40 K. The simulation was performed for selected reference quantities and for a certain standard uncertainty of the interval is above 40 K. The simulation of which is presented here was conducted to assess the combined standard uncertainty of the interval is above 40 K. input variables was recorded during the simulation because we did not address model sensitivity analysis (3.17) and (3.15). The sensitivity analysis of the results leads to assessing the combined standard uncertainty in specific measurement situations of infrared thermal imaging. The analysis (3.17) and (3. figure 5.59 Probability Function of the Output variable Tobe Models (3.17) and (3.15), for Tob 1/4 363 K and ob 1/4 0.9 Figure 5.61 Probability Function of the Output Variable Tobe Models (3.17) and (3.15), for Tob 1/4 363 K and ob 1/4 0.9 Figure 5.62 62 95% coverage intervals compared to quantitative orde A for Tob 1/4 323 K and 'ob 1/4 323 K and ob 1/4 0.6 Figure 5.63 Probability P thermography 95% coverage intervals compared to quantitative order A for Tob 1/4 363 K and ob 1/1/4 4 0.6 Figure 5.69 Probability Function of the Output Variable Tob Models (3.17) and (3.15), for Tob 1/4 323 K and ob 1/1/4 4 0.6 Figure 5.69 Probability Function of the Output Variable Tob Models (3.17) and (3.15), for Tob 1/4 323 K and ob 1/4 0.4 Figure 5.69 Probability Function of the Output Variable Tobe Models (3.17) and (3.15), for Tobe 1/4 343 K and ob 1/4 0.4 Figure 5.70 Coverage compared to quantum order a for Tob 1/4 0.4 Figure 5.71 Probability combined standard measurement uncertainty depends on the temperature of the Tob object. For medium and high emission, ob zlt; 0.5, the trend is reversed - uncertainty does not depend on the temperature of the object. In fact, this was confirmed by a simulation study of the infrared camera measurement model. The result described above can have practical significance: that is, when measuring the temperature of high-emission objects, it should be taken into account that the standard measuring the temperature of high-emission objects, it should be taken into account that the standard measurement uncertainty (both absolute and relative) increases with the temperature of high-emission objects, it should be taken into account that the standard measurement uncertainty modelling is the observation that, although the relative combined standard uncertainty component associated with object emission is not dependent on ob, (generally) the combined standard uncertainty (absolute as well as relative) dependence clearer, we have increased the relative standard uncertainty is 9.8 K, which is about 3% of the end and rob 1/4 323 K, the cumulative standard uncertainty associated with object emission to 30%. Then, for ob 1/4 323 K, the cumulative standard uncertainty is 9.8 K, which is about 3% of the relative standard uncertainty is 9.8 K. measured value. The calculations were then repeated for ob 1/4 0.4, keeping all other simulations intact. The new combined standard uncertainty standard is 16 K, which is about 5% of the measured value. We must emphasize that in both of these cases, the relative combined standard uncertainty standard is 16 K, which is about 5% of the measured value. We must emphasize that in both of these cases, the relative combined standard uncertainty standard uncertainty standard uncertainty associated with emissions was 30 per cent. We would not have reached this conclusion if we had only considered the combined standard uncertainty standard u components of the common error in section 4.3). Thus, the analysis of uncertainty components alone is not enough to assess the impact of reference input variables on the uncertainty of temperature measurement in infrared thermal imaging. Additional modelling of the combined standard uncertainty is needed. Another important finding from the above results is the 95 per cent estimates of coverage intervals. The Monte Carlo distribution and modelling method allowed the limits of these intervals to be determined. Uncertainty of measurements in infrared thermalography 135 assumptions about the Gaussian probability distribution for variable model of the mod measurements considered. In turn, the distribution of distributions allows us to estimate the cumulative standard uncertainty, as well as the intervals of measurement coverage in infrared thermalography. In addition, uncertainty of uc (Tob) and 95% of the coverage interval of the measurement of infrared thermal imaging Consider a set of several thermograms recorded for an object whose surface has a constant emission. The temperature estimate of the Tob object is 1/4 10%. The relative standard uncertainty of the measurement of u ('ob) is 1/4 10%. The relative standard uncertainty of other input variables (3.17) is assumed as in Table 5.8, and the estimates of these variables, as in table 5.7. A uniform probability distribution of all input variables of the model (3.17) is expected to be used to assess the combined standard uncertainty. The results presented in Table 5.9, we see that the minimum coverage interval width of 95% is 18 K and that the coverage interval limits 195% 1/4 (355, 373). 6 Summary The purpose of this monograph was to present questions related to the assessment of errors and uncertainties of measurements in infrared thermal imaging. Each contactless temperature measurement, due, first, to the large number of influencing quantities and, secondly, to a high non-linear measurement model, which leads to ineffective analytical methods of assessing accuracy In this paper, we proposed using the (accurate) increments method to assess temperature measurement errors using an infrared camera. First, we introduced the basic laws and definitions related to the measurements of infrared camera. First, we introduced the basic laws and definitions related to the measurements of infrared thermal imaging, namely radiation transmission of heat (section 2.2), the concept of emission (section 2.3), as well as the principles of work and the basic metrological parameters of modern infrared cameras (section 2.4). Next, we discussed the camera trajectory processing algorithm and the mathematical measurement model in infrared thermal imaging, according to this algorithm (section 3.2). The algorithm is described in the example of the mathematical model of temperature measurement has allowed to identify the components of the error in the method. Analysis of the results of the calculation showed that the error of temperature measurement mainly depends on the components associated with the emission of the impact on the measurement error, was the temperature is measured (section 4.3.1). The second important number, in terms of the impact on the object about whose temperature is measurement error, was the temperature is measurement mainly depends on the components associated with the error components associated with relative humidity v, camera for the impact on the measurement error, was the temperature is measurement mainly depends on the components associated with the error components associated with relative humidity v, camera for the impact on the measurement error. to the overall error of the method error allowed us to investigate the sensitivity of the method (sections 4.3.3-5.3.5). Analysis of the method error analysis only takes into account the impact of systematic interactions. This interaction is related to strictly defined measurement conditions that are classic error analysis of the method error allowed us to investigate the sensitivity of the model to changes in input variables. We would like to emphasize that the classic error analysis only takes into account the impact of systematic interaction is related to strictly defined measurement conditions that are classic error analysis of the method error allowed us to investigate the sensitivity of the method error allowed us to investigate the sensitivity of the model to changes in the classic error analysis of the method error allowed us to investigate the
sensitivity of the method error allowed us to investigate the sensitivity of the method error allowed us to investigate the sensitivity of the method error allowed us to investigate the sensitivity of the method error allowed us to investigate the sensitivity of the method error allowed us to investigate the sensitivity of the method error allowed us to investigate the sensitivity of the method error allowed us to investigate the sensitivity of the method error allowed us to investigate the sensitivity of the method error allowed us to investigate the sensitivity of the method error allowed us to investigate the sensitivity of the method error allowed us to investigate the sensitivity of the method error allowed us to investigate the sensitivity of the method error allowed us to investigate the sensitivity of the method error allowed us to investigate the sensitivity of the method error allowed us to investigate the sensitivity of the method error allowed us to investigate the sensitivity of the method error allowed us to investigate the sensitivity of the method error allowed us to investigate the sensitivity of the method error allowed us to investigate the sen difficult to implement in practice. Therefore, in this monograph we also investigated random interactions. This study is based on the concept of uncertainty of the processing algorithm (Chapter 5). There we presented a methodology for modeling studies of combined standard uncertainty in infrared thermal imaging: Errors and Uncertainty of the processing algorithm (Chapter 5). There we presented a methodology for modeling studies of combined standard uncertainty in infrared thermal imaging: Errors and Uncertainty of the processing algorithm (Chapter 5). components of the combined standard uncertainty were evaluated provided that measurements of the input number of each model could be represented by a random variable, as well as the form of probability density distributions: a uniform distribution that describes a critical case; or the logarimic Gaussian distribution, the random variable of which has only positive meanings. The results of the components of combined standard uncertainty for unrelated input variables of the measurement model in infrared thermal imaging. However, it turns out that assessing the effect of cross-correlations between physical input quantities. Keep in mind that input random variables represent the results of measurements number of models. Analysis of the effects of correlations has shown that this effect depends on the measurement conditions, and they can vary greatly. The modelling results showed that the combined standard uncertainty mainly depends on the measurement conditions, and they can vary greatly. The modelling results showed that the combined standard uncertainty mainly depends on the measurement conditions, and they can vary greatly. The modelling results showed that the combined standard uncertainty mainly depends on the measurement conditions, and they can vary greatly. correlation between variables representing the to and the temperature of the Tatm environment affects the uncertainty of temperature measurement to some extent as well. Overall, we have stated that neglecting the correlations between these variables may result in a revaluation of the combined standard temperature measurement to some extent as well. investigation of uncertainties, as they do not exclude each other. In addition, they complement each other and expand our knowledge of the measurement model of thermography measurement. Our study had two main objectives: first, to assess the combined standard uncertainty in differen measurement conditions in order to determine its dependence on individual input variables; and, secondly, an estimate of coverage intervals of 95%, taking into account the actual distribution of the output variable (measured object temperature) was assessed using the distribution of the probability of a variable output model. The distribution of the output variable (measured object temperature) was assessed using the distribution of the probability of a variable output variable (measured object temperature) was assessed using the distribution of the output variable (measured object temperature) was assessed using the distribution of the probability of a variable on Fundamental Problems in the metrology of the International Bureau of Weights and Measures. The distribution of distributions based on Monte Carlo simulations also allowed us to estimate 95% of the measurement interval in infrared thermal imaging. One of the main findings drawn from the analysis of the combined standard uncertainty is that, despite the actual asymmetry of the main findings drawn from the analysis of the combined standard uncertainty is that the state-owned allocation to estimate the coverage interval is 95% of the measurement interval in a symmetry of the main findings drawn from the analysis of the combined standard uncertainty is that, despite the actual asymmetry of the distribution of output variables, it is safe to assume that the state-owned allocation to estimate the coverage interval is 95% of the measurement interval in a symmetry of the distribution of distributions also allowed us to estimate the coverage interval is 95% of the measurement interval interval interval interval is 95% of the measurement interval interval interval interval is 95% of the measurement interval interva It turned out that the distribution of distribution of distributions is an ideal tool for assessing the combined standard uncertainty in infrared thermal imaging, as well as for coverage intervals associated with this uncertainty. The subject. Such a study should include an analysis of different models and conditions of measurement, models of phenomena affecting accuracy (such as atmospheric Etc. On the other hand, such in-depth analysis would not be practical. An extensive set of tables, characteristics and other detailed data will not necessarily allow for the practical application of the accuracy (such as atmospheric Etc. On the other hand, such in-depth analysis would not be practical. results presented. We hope that the methods described in assessing errors and uncertainties will help improve the accuracy of measurement of infrared thermal imaging in real-world conditions. However, the final test of any theory is an experiment . . . A MATLAB Scripts and Functions A.1 environment. In order to help infrared camera users assess the uncertainty of contactless temperature measurement for their own conditions, we present below the source code of the MATLAB environment editor or by digitizing with OCR (optical character recognition) software. M files must be located in the same folder as the MATLAB environment (for example, in Matlab-Work). Mfiles were created as functions and scripts. Table A.1 lists the collected scripts, and in table A.2 - functions. Below are procedures for calculating the accuracy of measurements of infrared thermal imaging. When calculating, you must provide measurement sof infrared thermal imaging. When calculating the accuracy of measurements of infrared thermal imaging. When calculating, you must provide measurement sof infrared thermal imaging. When calculating the accuracy of measurement parameters from the .img file. For this reason, the first stage of the program is to enter the name of this file (recorded with an infrared camera). This file should be located in the same catalog as suitable m-files. It should be emphasized that the stories created with this software may differ from those described in this book. This is the result of different calibration and adjustment parameters, as well as the combined standard uncertainty in the measurement of infrared thermal imaging using the presented software 1. The procedure for calculating the combined standard uncertainty in the measurement of infrared thermal imaging using the presented software 1. The procedure for calculating the combined standard uncertainty in the measurement of infrared thermal imaging using the presented software 1. The procedure for calculating the combined standard uncertainty in the measurement of infrared thermal imaging using the presented software 1. components are in the MATLAB command window. 2. Enter numerical data (measurement conditions, standard uncertainties, and so on) according to the script, five graphs of suitable components will be built. Infrared thermography: Errors and Uncertainties No. 2009 John Wylie and Sons, Ltd Waldemar Minkinations, standard uncertainties, and so on) according to the script, five graphs of suitable components will be built. and Sebastian Dudzik Appendix A 142 Table A.1 M-file Scripts used in calculations of accuracy measurements of infrared thermal imaging The name of components of the FLIR ThermaCAM infrared camera model on the combined standard uncertainty calculates the coverage interva for infrared cameras FLIR Therma the process for calculating coverage interval and combined standard uncertainty in infrared measurement thermals using submitted software 1. The type of coverage in the MATLAB team window. 2. Enter numerical data (measurement conditions, standard uncertainties, and so on) according to the messages on the screen. Table A.2 M-file Features used in the calculates the approximation of the distribution for the input random variable Of the logging parameters based on the expected value and variance of the Score of even distribution based on the expected value and deviation, cross-correlated journal-corrected Cross-correlated input random variables for a given value of correlated input random variables for a given value of correlated journal-corrected Cross-correlated input random variables for a given value from the .img file calculates the pixel value on the basis of the temperature value estlogpars.m estunifrpars.m gencorruni.m loadimgheader.m plotcorrelated.m plotcorrelated.m plotatistcomp.m plotsensensitive.m
readimgdatablock.m temptosignal.m App A 143. When the script is finished, we're going to have plotresults in order to build the calculation results. As a result of the script, seven graphs of suitable components will be built. Five graphs show histograms of input random variables, the sixth graph shows the probability of a random variable, and the seventh graph shows the approach of the output variable distribution function. A.4 The procedure for modeling cross-correlations between the input variable distribution function. A.4 The procedure for modeling cross-correlations in the MATLAB team window. 2. Enter numerical data (measuring uncertainty and so on) according to the messages on the screen. 3. When the script is finished, announce storylines to build cross-entry random variables. As a result of the script, a graph of the right pair of cross input variables will be built. It presents the combined standard uncertainty of variable output versus correlatior ratio between input variables selected in the correlation scenario. A.5 MATLAB Source code (scenario)

%standard object uncertainty % Temperature for FLIR ThermaCAM infrared % % camera with the method to distribute % distribution % with the assumption % different types of distribution to input % random variable % % 2008 Sebastian Dudzik % % (mail protected) % %

object (m): '; % Calculation of the signal value from the detector % based on tObject temperature % SEE ALSO: temptosignal. m functional signal - temptosignal (tObject, emiss, tAtm, tAmb, humRel,dist,... h.B, h.F,h.obas, h.L, h.globalOffset); Appendix A App A disp, '); % Entry for the standard uncertainty range % of emission measurement minEmissUn'input ('Minimum emission uncertainty (%); % Entry for the standard uncertainty (%); % Entry for the standard uncertainty ... 'Environmental temperature (%); % Entry for the standard uncertainty range % of ambient temperature (%); % Entry for the standard uncertainty range % of ambient temperature (%); % Entry for the standard uncertainty range % temperature measurement of the atmosphere minTAtmUn'input ('Minimum temperature uncertainty' ... 'atmosphere (%): 'K'; maxTAtmUn'input ('Minimum uncertainty ... 'Atmosphere (%): 'K'; maxTAtmUn'input (range % of the camera to the minDistUn'input distance measurement object ('Minimum uncertainty'... 'distance from camera to object (%): "; % Entering the number of nodeling points:'); % Calculation of uncertainty values % Emission emissUn and linspace (((minEmissUn'emiss)/100,... (maxEmissUn'emiss)/100,nPoints); % Environment temperature tAmbUn and linspace (((minTAmbUn'tAmb)/100,... (maxTAmbUn'tAmb)/100,... (maxTAmbUn'tAmb)/100, nPoints); % Relative Humidity 145 Appendix A 146 humRelUn'humRel/100,... (maxTAtmUn'tAtm)/100, ... (maxTAtmUn'tAt (maxDistUn'dist)/100,nPoints); disp,' '); disp

(a,b,1,10000); emissDistribution-emissDistribution-emissDistribution-hlpVar; конец; ясно hlpVar; конец; я tAmbDistribution-tAmbDistribution-hlpVar; приложение А для i'2:nPoints a,b'estlogpars (tAmb, tAmbUn (i); hlpVar-unifrnd (a,b,1,10000); tAmbDistribution-tAmbDistribution; hlpVar; конец; ясно hlpVar; приложение А для i'2:nPoints a,b'estlogpars (tAmb, tAmbDistribution-tAmbDistribution-tAmbDistribution; hlpVar; конец; ясно hlpV конец; % Распределение для входно случайной переменной, представляюей % температуру атмосферы tAtmDistribution-tAtmDistribution-tAtmDistribution-tAtmDistribution; hlpVar lognrnd (a,b,1,10000); tAtmDistribution-tAtmDistribution; hlpVar; ясно hlpVar; все а,беесунифрпарс (tAtm, tAtmUn(1).2); hlpVar-unifrnd (a,b,1,10000); tAtmDistribution-tAtmDistribution-tAtmDistribution-hlpVar; для i'2:nPoints a,b'estunifrpars (tAtm, tAtmUn(i); hlpVar-unifrnd (a,b,1,10000); tAtmDistribution); tAtmDistribution-tAtmDistribution; hlpVar; конец; % Pacnpegenetue для входной слл учайной переменной%, представляюей относительную влажность humRelDistribution; hlpVar; конец; % Pacnpegenetue для входной слл учайной переменной%, представляюей относительную влажность humRelDistribution; hlpVar; конец; % Pacnpegenetue для входной слл учайной переменной%, представляюей относительную влажность humRelDistribution; hlpVar; конец; % Pacnpegenetue для входной слл учайной переменной%, представляюей относительную влажность humRelDistribution; hlpVar; конец; % Pacnpegenetue для входной слл учайной переменной%, представляюей относительную влажность humRelDistribution; hlpVar; конец; % Pacnpegenetue для входной слл учайной переменной%, представляюей относительную влажность humRelDistribution; hlpVar; конец; % Pacnpegenetue для входной слл учайной переменной (a,b,1,10000); humRelDistribution; hlpVar; конец; % Pacnpegenetue для входной слл учайной переменной (a,b,1,10000); humRelDistribution; hlpVar; конец; % Pacnpegenetue для входной слл учайной переменной (a,b,1,10000); humRelDistribution; hlpVar; конец; % Pacnpegenetue для входной слл учайной переменной (a,b,1,10000); humRelDistribution; hlpVar; конец; % Pacnpegenetue для входной слл учайной переменной (a,b,1,10000); http://doi.org/10.0000; http://doi.org/10.0 humRelDistribution-hlpVar; для i'2:nPoints a,b'estlogpars (humRel, humRelDistribution-hlpVar; 147 148 конец; ясно hlpVar; конец; ясно hlpVar; 147 148 конец; 147 148 hlpVar ; конец; % Распределение для ввода с лучайной переменной%, представляюей расстояние от камеры к оббекту distDistribution-distDistribution-distDistribution; hlpVar; конец; % Распределение для ввода с лучайной переменной%, представляюей расстояние от камеры к оббекту distDistribution-distDistribution-distDistribution-distDistribution-distDistribution; hlpVar; конец; % Распределение для ввода с лучайной переменной%, представляюей расстояние от камеры к оббекту distDistribution-distDistribution-distDistribution-distDistribution-distDistribution-distDistribution; hlpVar; конец; ясно hlpVar; конец; ясн hlpVar; для i'2:nPoints a,b'estunifrpars (dist, distUn(i); hlpVar-unifrnd (a,b,1,10000); distDistribution-distDistribution-distDistribution; hlpVar; конец; %------для i'1:nPoints emissComponent (:,i) - камерамодель (сигнал, ... emissDistribution (i,:), TAmb, Atm, humRel, ... dist, h.alpha1, h.alpha2, h.beta1,

... h.X, h.R, h.B, h.f, h.o, h.I, h.globalGain,... h.globalGain, h.globalOffset); eeeee ambStd и std (TAmbComponent); (AmbStd/TObject) 100 epepepo; %1000,000 TAtmComponent - 1000,000; eeeeeea i'n AtmMComponent (:,i) - ceeeeeea i'n AtmMComponent (:,i) - ceeeeeea i'n AtmMComponent; humRelComponent (:,i) - ceeeeeea i'n AtmMComponent (:,i) - ceeeeeea i'n AtmRelComponent; humRelComponent (:,i) - ceeeeeea i'n AtmRelComponent (:,i) - ceeeeeea (ceeeea, ecccunnun, ... TAmb, Atm, humRelComponent; humRelComponent; humRelComponent; humRelComponent; humRelComponent; humRelStdRel (humRelStdRel (humRelStdRel (humRelStdRel (humRelStdRel); eieeeea i'n 1:nPoints distComponent (:,i) - ceeeeeea (ceeeeea, ecccunnunu, ... TAmb, Atm, humRelComponent; humRelComponent; humRelStdRel (humRelStdRel (humRelStdRel (humRelStdRel (humRelStdRel (humRelStdRel (humRelStdRel (humRelStdRel); humRelComponent); eieeeea i'n AtmRelComponent (:,i) - ceeeeeea (ceeeea, ecccunnunu, ... TAmb, Atm, humRelComponent; humRelStdRel (humRelStdRel (humRelStdRel

сисссиии, ... TAmb, Atm, humRel, distDistribution (i,:), h.alpha1, ... h.alpha2, h.beta1, h.minta2, h.X, h.R, h.B, h.F, ... h.obas, h.L, h.globalGain, h.globalOffset); distStd и std (distComponent); distStdRel (distStd/tObject) 100;

%с%сраи

0.5,0,5,0,3,0,1, 'BackgroundColor', ... 'white', 'String', 'Expected value:' ... num2str (average (x1),3); 'Standard deviation: '... num2str (std(x1),3); 'BackgroundColor', 'lone',', 'EdgeColor', 'lone',', 'lone' 'BackgroundColor', ... 'white', 'String', 'Expected value:' ... num2str (average (x2),3) 'K'; 'Standard deviation: '... num2str (std(x2),3) 'K'; 'Standard deviation: '... num2str (std(x2),3) 'K'; 'Standard deviation: '... num2str (std(x2),3) 'K'; 'Standard deviation: '... representation of the temperature of the atmospheric distribution figure; Hist (x3.45); h3'get (gka, 'baby'); set (h3, 'FaceColor', 'none',', 'EdgeColor', 'none',' 0.5,0,5,0,3,0,1, 'BackgroundColor', ... 'white', 'String', 'Expected value:' ... representing relative humidity) ylabel (size;; abstract ('textbox', 0.5,0,5,0,3,0,1, 'BackgroundColor', ... 'white', 'String', 'Expected value:' ... representing relative humidity) ylabel (size;; abstract ('textbox', 0.5,0,5,0,3,0,1, 'BackgroundColor', ... 'white', 'String', 'Expected value:' ... num2str (average (x4),3); Standard deviation: ... num2str (std(x4),3)); % The location of the camera to object is the distance from camera to object is the distance (it'd'rm m') ylabel ('size (samples))); abstract ('textbox', 0,5,0,5,0,3,0,1, 'BackgroundColor',... 'white', 'String', 'Expected value:' ... num2str (medium (x5),3); Standard deviation: ... num2str (std(x5),3); % Plot of histogram temperature) to ('T_, th rm K'); set (h1,'LineWidth',2); set (h1,'LineWidth',2); set (h1,'LineWidth',2); set (h1,'Color', 'white'); Hold it. h1 - plot (TLow, tLow, 0 max (nn)); set (h1,'Color', 'black'); h2 - plot (tHigh, tHigh), 0 max(nn)); set (h1,'Color', 'black'); h2 - plot (tHigh, tHigh), 0 max(nn)); set (h1,'Color', 'black'); h2 - plot (tHigh, tHigh), 0 max(nn)); set (h1,'Color', 'black'); h2 - plot (tHigh, tHigh), 0 max(nn)); set (h1,'Color', 'black'); h2 - plot (tHigh, tHigh), 0 max(nn)); set (h1,'Color', 'black'); h2 - plot (tHigh, tHigh), 0 max(nn)); set (h1,'Color', 'black'); h2 - plot (tHigh, tHigh), 0 max(nn)); set (h1,'Color', 'black'); h2 - plot (tHigh, tHigh), 0 max(nn)); set (h1,'Color', 'black'); h2 - plot (tHigh, tHigh), 0 max(nn)); set (h1,'Color', 'black'); h2 - plot (tHigh, tHigh), 0 max(nn)); set (h1,'Color', 'black'); h2 - plot (tHigh, tHigh), 0 max(nn)); set (h1,'Color', 'black'); h2 - plot (tHigh, tHigh), 0 max(nn)); set (h1,'Color', 'black'); h2 - plot (tHigh, tHigh), 0 max(nn)); set (h1,'Color', 'black'); h2 - plot (tHigh, tHigh), 0 max(nn)); set (h1,'Color', 'black'); h2 - plot (tHigh, tHigh), 0 max(nn)); set (h1,'Color', 'black'); h2 - plot (tHigh, tHigh), 0 max(nn)); set (h1,'Color', 'black'); h2 - plot (tHigh, tHigh), 0 max(nn)); set (h1,'Color', 'black'); h2 - plot (tHigh, tHigh), 0 max(nn)); set (h1,'Color', 'black'); h2 - plot (tHigh, tHigh), 0 max(nn)); set (h1,'Color', 'black'); h2 - plot (tHigh, tHigh), 0 max(nn)); set (h1,'Color', 'black'); h2 - plot (tHigh, tHigh), 0 max(nn)); set (h1,'Color', 'black'); h2 - plot (tHigh, tHigh), 0 max(nn)); set (h1,'Color', 'black'); h2 - plot (tHigh, tHigh), 0 max(nn)); set (h1,'Color', 'black'); h2 - plot (tHigh, tHigh), 0 max(nn)); set (h1,'Color', 'black'); h2 - plot (tHigh, tHigh), 0 max(nn)); set (h1,'Color', 'black'); h2 - plot (tHigh, tHigh), 0 max(nn)); set (h1,'Color', 'black'); (nn);; set (h2,'LineWidth',2); set (h2, 'color', 'black'); (The probability density function of a random variable is a random variable is a random variable;... Abstract representing the temperature), 3)) % A site close to the temperature of the object) (textbox, 0,5,0,5,0,3,0,1, BackgroundColor, ... 'white', 'String', 'Expected value:' ... num2str (medium (temperature), 3)) % A site close to the temperature), 3)) % A site close to the temperature of the object) (textbox, 0,5,0,5,0,3,0,1, BackgroundColor, ... 'white', 'String', 'Expected value:' ... num2str (medium (temperature), 3)) % A site close to the temperature of the object) (textbox, 0,5,0,5,0,3,0,1, BackgroundColor, ... 'white', 'String', 'Expected value:' ... num2str (temperature), 3)) % A site close to the temperature of the object) (textbox, 0,5,0,5,0,3,0,1, BackgroundColor, ... 'white', 'String', 'Expected value:' ... num2str (temperature), 3)) % A site close to the temperature of the object) (textbox, 0,5,0,5,0,3,0,1, BackgroundColor, ... 'white', 'String', 'Expected value:' ... num2str (temperature), 3)) % A site close to the temperature of the object) (textbox, 0,5,0,5,0,3,0,1, BackgroundColor, ... 'white', 'String', 'Expected value:' ... num2str (temperature), 3)) % A site close to the temperature of the object) (textbox, 0,5,0,3,0,1, BackgroundColor, ... 'white', 'String', 'Expected value:' ... num2str (temperature), 3)) % A site close to the temperature of the object (temperature), 3) % A site close to the temperature of the object (temperature), 3) % A site close to the temperature of the object (temperature), 3) % A site close to the temperature of the object (temperature), 3) % A site close to the temperature of temperature), 3) % A site close to the temperature of temperatur 'on'); set (gca, 'YMinorTick', 'on'); (Approaching cumulative distribution, '95% coverage interval', 'Location', 'best'; % End plotRESULTS ('temperature 'T_'ob'rm K') 151 152 ylabel ('itG (T_'ob)';;; Hold it. line (tLow tLow, 0 1, Color, red, LineWidth,2); line (tHigh tHigh, 0 1, Color, Red, LineWidth,2); legend ('Approaching the function of cumulative distribution, '95% coverage interval', 'Location', 'best'; % End plotRESULTS

% camera model on the combined standard % uncertainty % % % % copyright February, 2008 Sebastian Dudzik % (mail protected) %

(yap.); disp (japanese) disp (""simulates the influence of K'); disp (- cross-correlations between input); disp (variable FLIR ThermaCAM);; disp ('-infrared camera model on k'); disp ("sip ('-); % Entry for the name of a file recorded with an infrared disp camera ("FILE NAME AND MEASURED TEMPERATURE BLOCK); disp, '); % Entry for the name of a file recorded with an infrared disp camera ("FILE NAME AND MEASURED TEMPERATURE BLOCK); disp, '); % Entry for the name of a file recorded with an infrared disp camera ("FILE NAME AND MEASURED TEMPERATURE BLOCK); disp, '); % Entry for the name of a file recorded with an infrared disp camera ("FILE NAME AND MEASURED TEMPERATURE BLOCK); disp, '); % Entry for the name of a file recorded with an infrared disp camera ("FILE NAME AND MEASURED TEMPERATURE BLOCK); disp, '); % Entry for the name of a file recorded with an infrared disp camera ("FILE NAME AND MEASURED TEMPERATURE BLOCK); disp, '); % Entry for the name of a file recorded with an infrared disp camera ("FILE NAME AND MEASURED TEMPERATURE BLOCK); disp, '); % Entry for the name of a file recorded with an infrared disp camera ("FILE NAME AND MEASURED TEMPERATURE BLOCK); disp, '); % Entry for the name of a file recorded with an infrared disp camera ("FILE NAME AND MEASURED TEMPERATURE BLOCK); disp, '); % Entry for the name of a file recorded with an infrared disp camera ("FILE NAME AND MEASURED TEMPERATURE BLOCK); disp, '); % Entry for the name of a file recorded with an infrared disp camera ("FILE NAME AND MEASURED TEMPERATURE BLOCK); disp, '); % Entry for the name of a file recorded with an infrared disp camera ("FILE NAME AND MEASURED TEMPERATURE BLOCK); disp, '); % Entry for the name of a file recorded with an infrared disp camera ("FILE NAME AND MEASURED TEMPERATURE BLOCK); disp, '); % Entry for the name of a file recorded with an infrared disp camera ("FILE NAME AND MEASURED TEMPERATURE BLOCK); disp, '); % Entry for the name of a file recorded with an infrared disp camera ("FILE NAME AND MEASURED TEMPERATURE BLOCK); d data from the q.img % file to the structure h SEE ALSO: loadimgheader.m function h and loadimgheader (fileName, h); % Entry for the temperature of the specified pixel % in the tobject-input thermogram (Measured temperature value (set in the chamber); % Entry for the temperature value (set in the chamber) input thermogram (Measured temperature value (K): '; disp, '); disp ('); % Entry for the temperature value (set in the chamber) input thermogram (Measured temperature value (Set in the chamber)); % Entry for the temperature value (set in the chamber) tAmb'input (Ambient temperature value (K): '; % Entry for the value of the atmosphere % (installed in the chamber) tAtm'input ('Value relative humidity: '); % Entry for the distance from camera to object (m): '; % Entry fo BLOCK VARIABLES); disp,' '); % Entry for standard uncertainty of measurement (Standard temperature uncertainty:); % Entry for standard temperature (K): 'K'; % Entry for standard temperature (K): 'K'; % Entry for standard temperature uncertainty '. 'Temperature (K): 'K'; % Entry for standard temperature uncertainty '. 'Atmosphere (K):'; % Entry for standard temperature uncertainty '. 'Temperature uncertainty '. 'Bentry for standard temperature uncertainty '. ' uncertainty of relative % measurement of humRelUn'input humidity (Standard uncertainty of relative humidity:'; % Entry for standard camera uncertainty to an object % of distUn'input distance (m):'; NOSAMPLES - 10,000 EUROS; % Number of random variables parsNorm{1} parsNorm{2} parsNorm{2} parsNorm{2} parsNorm{2} parsNorm{4} parsNorm{4} parsNorm{4} parsNorm{4} parsNorm{2} parsNorm{2} parsNorm{2} parsNorm{4} parsNorm{2} parsNorm{4} parsNorm{2} parsNorm{4} parsN tAmbUn»; «tAtm tAtmUn»; «HumRel humRelUn»; «HumRel humRelUn»; «Dist distUn»; Appendix A 154 disp (VECTOR BLOCK CROSS-CORRELATION Options); disp, ' '); % Input data for the construction vector: '); jEnd - entry (End of cross-correlation vector; '); jEnd - entry (ister value in cross-correlation vector: '); jEnd - entry (End of cross-correlation vector; '); jStep and input ('step value in cross-correlation vector; '); disp, ' '); % Input data for the construction of the cross-correlation vector; '); jEnd - entry (End of cross-correlation vector; '); disp, ' '); disp ...

. 'RANDOM VARIABLES BLOCK); disp,' '); disp ('1 - Lognormal Distribution'); disp ('2 - Even Distribution'); disp,' '); typeOfDist - input ('Enter type of distribution type choice if typeOfDist - 1% Journal-normal distribution '); disp ('1 - Lognormal Distribution'); disp ('2 - Even Distribution (1/2): '; % Distribution type choice if typeOfDist - 1% Journal-normal distribution '); disp ('1 - Lognormal Distribution'); disp ('2 - Even Distribution'); disp ('1 - Lognormal Distribution'); di for i - 1:5 (parsLog'i) (1,1) parsLog'i (1,2)... estlogpars (parsNormish (1,1), ParsNormish (1,2)); (J.) CROSS-CORRELATED TIME RANDOM ' ... 'VARIABLES BLOCK); (disp,' '); (J.) CROSS-CORRELATED TIME RANDOM ' ... 'VARIABLES BLOCK); (disp,' '); (J.) CROSS-CORRELATED TIME RANDOM ' ... 'VARIABLES BLOCK); (disp,' '); (J.) CROSS-CORRELATED TIME RANDOM ' ... 'VARIABLES BLOCK); (disp,' '); (J.) CROSS-CORRELATED TIME RANDOM ' ... 'VARIABLES BLOCK); (disp,' '); (J.) CROSS-CORRELATED TIME RANDOM ' ... 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CROSS-CORRELAT parsNorm'kPopup (1,1) parsNorm-kPopup (1,2); pNorm{2} th parsNormlPopup (1,2); pNorm{2} th parsNorm'lPopup (1,2); pLog{1} th parsLog'kPopup (1,2); pLog{1} th parsLog'kPopup (1,2); pLog{2} th parsLog'kPopup (1,2); pLog{2} th parsLog'kPopup (1,2); pLog{2} th parsLog'kPopup (1,2); pLog{1} th parsLog'kPopup (1,2); pLog{2} th parsLog'kPopup (1,2); pLog{1} th parsLog'kPopup (1,2); pLog{2} th parsLog'kPopup (1,2); pLog{1} th parsLog'kPopup (1,2); pLog{2} th parsLog ('1 Emission'); disp ('2 Ambient temperature'); disp ('3 Atmosphere Temperature'); disp ('4 Relative humidity'); disp ('5 Distance from camera to object'); disp, '); kPopup and input ('Enter the index Second'... 'cross-correlated input variables'; % Auxiliary array of parameters for cross-correlated input variables'; % Auxiliary array of parameters for cross-correlated input variables'; % Auxiliary array of parameters for cross-correlated input variables'; % Auxiliary array of parameters for cross-correlated input variables'; % Auxiliary array of parameters for cross-correlated input variables'; % Auxiliary array of parameters for cross-correlated input variables'; % Auxiliary array of parameters for cross-correlated input variables'; % Auxiliary array of parameters for cross-correlated input variables'; % Auxiliary array of parameters for cross-correlated input variables'; % Auxiliary array of parameters for cross-correlated input variables'; % Auxiliary array of parameters for cross-correlated input variables'; % Auxiliary array of parameters for cross-correlated input variables'; % Auxiliary array of parameters for cross-correlated input variables'; % Auxiliary array of parameters for cross-correlated input variables'; % Auxiliary array of parameters for cross-correlated input variables'; % Auxiliary array of parameters for cross-correlated input variables'; % Auxiliary array of parameters for cross-correlated input variables'; % Auxiliary array of parameters for cross-correlated input variables'; % Auxiliary array of parameters for cross-correlated input variables'; % Auxiliary array of parameters for cross-correlated input variables'; % Auxiliary array of parameters for cross-correlated input variables'; % Auxiliary array of parameters for cross-correlated input variables'; % parsNormlPopup (1,1) parsNorm'lPopup (1,2); pUni{1} - parsUni'kPopup (1,2); End % End of distribution type selection % Conversion of cell array variables into matrix for i'1:jLen kPopupVariable (:,i) PopupVariable (:,i) PopupVariable (:,i) - biCorrVariable - 1,i'::,2); The end; % Place cross-correlated variables in an array of cells % of the input random input of variables (kPopup) and kPopupVariables; (lPopupVariable; (lPopupVariable; (lPopup) - iPopupVariable; (lPopup) and kPopupVariable; (lPopupVariable; (lPopup) - iPopupVariable; (lPopup) - iPopupVariable; (lPopupVariable; (lPopup) - iPopupVariable; (lPopupVariable; (lPo Of February, 2008 Sebastian Dudzik % (mail protected) %

disp (yap.); disp disp ('- Coverage interval calculation'); disp ('''); file Name and catter of a file recorded with an infrared cameras FLIR ThermaCAM'); disp, '); % Reading radiometric data from the q.img % file to the structure h SEE ALSO: loadimgheader.m function h and loadi (fileName, h); % Entry for the temperature of the specified pixel % in the tObject-input thermogram ('Value of measured temperature value (K): '; % Entry for atmospheric temperature value % (set in the chamber) input temperature value (K): '; % Entry for atmospheric temperature value % (set in the chamber) input emission value (installed in the chamber) the chamber) the chamber) input emission value (K): '; % Entry for atmospheric temperature value % (set in the chamber) input emission value (installed in the chamber) input emission value (K): '; % Entry for atmospheric temperature value % (set in the chamber) input emission value (K): '; % Entry for atmospheric temperature value % (set in the chamber) input emission value (K): '; % Entry for atmospheric temperature value % (set in the chamber) input emission value (installed in the chamber) input emission value (installed in the chamber) input emission value (K): '; % Entry for atmospheric temperature value % (set in the chamber) input emission value (installed in the chamber) input emission value (K): '; % Entry for atmospheric temperature value % (set in the chamber) input emission value (installed in the chamber) input emission value (K): '; % Entry for atmospheric temperature value % (set in the chamber) input emission value (installed in the chamber) input emission value (K): '; % Entry for atmospheric temperature value % (set in the chamber) input emission value (installed in the chamber) input emission value (K): '; % Entry for atmospheric temperature value % (set in the chamber) input emission value (installed in the chamb thatm'input (Atmospheric temperature value (K): '); % Entry for relative humidity (set in the camera) humRel'input ('Value relative humidity: '); % Entry for the distance from camera to object (m) : '); disp, '); % Entry for the distance from camera to object (m) : '); % Entry for the distance from camera to object (m) : '); % Entry for the distance from camera to object (m) : '); % Entry for the distance from camera to object (m) : '); % Entry for the distance from camera to object (m) : '); % Entry for the distance from camera to object (m) : '); % Entry for the distance from camera to object (m) : '); % Entry for the distance from camera to object (m) : '); % Entry for the distance from camera to object (m) : '); % Entry for the distance from camera to object (m) : '); % Entry for the distance from camera to object (m) : '); % Entry for the distance from camera to object (m) : '); % Entry for the distance from camera to object (m) : '); % Entry for the distance from camera to object (m) : '); % Entry for the distance from camera to object (m) : '); % Entry for the distance from camera (standard uncertainty of measurement of the atmosphere tAtmUn'input (Standard environmental uncertainty '... 'Temperature uncertainty of relative % measurement of the atmosphere (K):'; % Entry for standard temperature (K): '; % Entry for standard temperature uncertainty of relative % measurement of humRelUn'input (Standard temperature uncertainty '... 'atmosphere (K):'; % Entry for standard temperature uncertainty of relative % measurement of the atmosphere (K):'; % Entry for standard temperature (K): '; % Entry for standard temperature uncertainty '... 'atmosphere (K):'; % Entry for standard temperature uncertainty '... 'atmosphere (K):'; % Entry for standard temperature uncertainty '... 'atmosphere (K):'; % Entry for standard temperature uncertainty of relative % measurement of humRelUn'input (Standard temperature uncertainty '... 'atmosphere (K):'; % Entry for standard temperature uncertainty '... 'atmosphere (K):'; % Entry for standard temperature uncertainty '... 'atmosphere (K):'; % Entry for standard temperature uncertainty '... 'atmosphere (K):'; % Entry for standard temperature uncertainty '... 'atmosphere (K):'; % Entry for standard temperature uncertainty '... 'atmosphere (K):'; % to the % object distUn'input measurement (Standard camera uncertainty to object'... 'distance (m):'; % Calculation of the signal value from the detector based on % tObject temperature % SEE ALSO: temptosignal.m signal function and temptosignal.m signal function parameters for variable emission input % SEE ALSO: function estunifrpars.m (a1 b1) estunifrpars (tAmb, tAmbUn-2); % Assessment of the parameters of uniform distribution % for atmospheric temperature input variable input temperature % SEE ALSO: estunifrpars.m function a3 b3 estunifrpars (tAmb, tAmbUn-2); % Assessment of the parameters of uniform distribution of the percentage for the relative humidity of the input variable % SEE ALSO: estunifrpars.m function a4 b4 estunifrpars (humRelUn-2); % Assessment of the % even distribution parameters for variable distance from camera to object % SEE ALSO: function estunifrpars.m (a5 b5) estunifrpars.m (a5 b5) estunifrpars.m (a5 b5) estunifrpars (dist, distUn-2); % Generation of random even distribution of variable emission input according to parameters calculated above (1e6 samples) x1-unifrnd (a1,b1,1e6,1); % Generation of random even distribution of variable emission input according to parameters calculated above (1e6 samples) x1-unifrnd (a1,b1,1e6,1); % Generation of random even distribution parameters for variable emission input according to parameters calculated above (1e6 samples) x1-unifrnd (a1,b1,1e6,1); % Generation of random even distribution of variable emission input according to parameters calculated above (1e6 samples) x1-unifrnd (a1,b1,1e6,1); % Generation of random even distribution of variable emission input according to parameters (above (1e6 samples) x1-unifrnd (a1,b1,1e6,1); % Generation of random even distribution of variable emission input according to parameters (above (1e6 samples) x1-unifrnd (a1,b1,1e6,1); % Generation of random even distribution of variable emission input according to parameters (above (1e6 samples) x1-unifrnd (a1,b1,1e6,1); % Generation of random even distribution of variable emission input according to parameters (above (1e6 samples) x1-unifrnd (a1,b1,1e6,1); % Generation of variable emission input according to parameters (above (1e6 samples) x1-unifrnd (a1,b1,1e6,1); % Generation of variable emission input according to parameters (above (1e6 samples) x1-unifrnd (a1,b1,1e6,1); % Generation of variable emission input according to parameters (above (1e6 samples) x1-unifrnd (a1,b1,1e6,1); % Generation (above (1e6 samples) x1-unifrnd even distribution of % of the temperature of the variable input of the atmosphere according to the parameters calculated above (1e6 samples) x3'unifrnd (a2,b2,1e6,1); % Generation of random even distribution of relative% humidity of variable input according to parameters calculated above (1e6 samples) x3'unifrnd (a2,b2,1e6,1); % Generation of random even distribution of relative% humidity of variable input according to the parameters calculated above (1e6 samples) x3'unifrnd (a2,b2,1e6,1); % Generation of random even distribution of variable input of the parameters calculated above (1e6 samples) x3'unifrnd (a2,b2,1e6,1); % Generation of random even distribution of variable input according to the parameters calculated above (1e6 samples) x3'unifrnd (a2,b2,1e6,1); % Generation of random even distribution of variable input according to parameters calculated above (1e6 samples) x3'unifrnd (a2,b2,1e6,1); % Generation of random even distribution of variable input according to the parameters calculated above (1e6 samples) x3'unifrnd (a2,b2,1e6,1); % Generation of random even distribution of variable input according to parameters calculated above (1e6 samples) x3'unifrnd (a2,b2,1e6,1); % Generation of random even distribution of variable input according to the parameters calculated above (1e6 samples) x3'unifrnd (a2,b2,1e6,1); % Generation of random even distribution of variable input according to the parameters calculated above (1e6 samples) x3'unifrnd (a2,b2,1e6,1); % Generation of random even distribution of variable input according to the parameters calculated above (1e6 samples) x3'unifrnd (a2,b2,1e6,1); % Generation of random even distribution of variable input according to the parameters calculated above (1e6 samples) x3'unifrnd (a2,b2,1e6,1); % Generation of random even distribution of variable input according to the parameters calculated above (1e6 samples) x3'unifrnd (a2,b2,1e6,1); % Generation of random even distribution of variable input according to the parameters calculated above (1e6 samples) x3'unifrnd % above (1e6 samples) x4-unifrnd (a4,b4,1e6,1); % Generation of random even distribution of variable distance from camera to object according to parameters calculated above (1e6 samples) x5-unifrnd (a5,b5,1e6,1); % Use of the method to distribution to obtain temperature distribution % SEE ALSO: cameramodel.m - camera model (signal, x1, x2, x3, x4, x5,... h.alpha2, h.beta1, h.beta2, h.X, h.R, ... h.B, h.F, h.obas, h.L, h.globalGain, h.globalOffset); disp,' '); disp (" RESULTS BLOCK) disp ('); disp (Combined standard object temperature, for infrared cameras FLIR (temperature); '% Calculation of the combined standard temperature); 'B Coverage interval calculation of the combined standard temperature); 'I disp ('); disp (Combined standard temperature, for infrared cameras FLIR (temperature); 'I disp ('); the recorded file (should be in the same video): D1017-10.img Value measured (K): 293 Value relative humidity: 0.5 Value distance from camera to object (m): 1 - RANGE S OF THE STANDARD UNCERTAINTIES OF INPUT VARIABLES BLOCK - Annex A 173 Minimum Emission Uncertainty (%): 0 Maximum Emission Uncertainty (%): 30 Minimum distance un from camera to object (%) : 0 Minimum distance uncertainty from camera to object (%): 30 Number of simulation points: 100mal distribution 2 - Even Distribution 5.3.1-5.3.5). A.7.2 Calculation of the combined standard uncertainty and the coverage interval of 95% of the object temperature problem. Calculate the cumulative standard uncertainty and 95% object temperature (To), K Atmosphere Temperature (Tatm), K Relative Humidity (v) Camera Distance to and 5.8): Table 5.7 and 5.8): Table 5.7 and 5.8): Table 5.7 and 5.8): Object (d), m Estimated value 0.9 293 293 0.5 10 Uncertainty range 0.09 9 9 0.05 1 Temperature, AND MEASURED TEMPERATURE BLOCK - The name of the recorded file (should be in the same video): 1017-10.img Value distance from camera to object (m): 10 VARIABLES BLOCK - Standard uncertainty of standard uncertainty of standard emission uncertainty: 0.5 09 Ambient Temperature (K): 9 Atmospheric Temperature Liica) - 5.6505 95% coverage interval (tLow tHigh) : 355,063, 374,2662 plotresults Results can be compared with table 5.9 and figure 5.59 (section 5.5.2). A.7.3 Simulation of a relative combined standard uncertainty compared to the correlation ratio of the selected problem of random input variables. To simulate the effect of cross correlations between input random variables representing object emission and atmospheric temperature for the following measured by the camera is 363 K. Correlation factor values have changed from 0.99 to 0.99 in 0.01. The thermal image, recorded with an infrared camera, was stored in the file: D1017-10.img. Annex A 175 Table A.5 Measurement Conditions to simulate the relationship between relative combined standard uncertainty and correlation. Below is an example of a MATLAB session to address this issue using m-files correlations.m and plotcorrsens.m from sections A.5 and A.6. It's not a good place to be correlations and correlations and correlations and plotcorrsens.m from sections A.5 and A.6. It's not a good place to be correlations and correlations and correlations of the recorded file (should be in the same dir): D1017-710.img Value measured temperature (K): REFERENCE CONDITIONS BLOCK -Emission value: 0.9 Ambient temperature (K): 293 Atmospheric temperature value (K): 293 Value of telative humidity: 0.5 Value of distance from camera to object (m): 50 - STANDARD OF THE MAIN PART BLOCK - Standard Uncertainty Standard Uncert Humidity: 0.05 Camera-Object Distance (m): 5 PARAMETERS CROSS-CORRELATION VECTOR BLOCK - Original value of cross-correlation vector: 0.99 176 Appendix A DISTRIBUTION OF THE RANDOM RANDOMS BLOCK No 1 - Lognormal Distribution 2 - Even Distribution Type VARIABLES BLOCK - List of Index Input Variables ------

Materials (IR-Book 2000, Minkina 2004) Temperature specification material, C Spectruma Emittance 10 mm 3 mm T T LW 0.04 0.09 0.04 0.04 0.09 0.04 0.04 0.05 0.95 METALS and METAL OXIDES, Black Aluminum Oxide Aluminum Aluminum Oxide Aluminum Oxide Aluminum Oxide Aluminum Oxide Aluminum Aluminum Oxide Aluminum Aluminum Oxide Aluminum Oxide Aluminum Oxide Aluminum Aluminum Aluminum Oxide Aluminum Oxide Aluminum Aluminum Aluminum Aluminum Oxide Aluminum Oxide Aluminum Oxide Aluminum Oxide Aluminum Oxide Aluminum Aluminum Oxide Aluminum Oxide Aluminum Oxide Aluminum Aluminum Aluminum Oxide Aluminum Oxide Aluminum Oxide Aluminum Oxide Aluminum Oxide Aluminum Aluminum Oxide Aluminum Aluminum Oxide Aluminum Aluminum Aluminum Oxide Aluminum Oxide Aluminum Oxide Aluminum Aluminum Oxide Aluminum Oxide Aluminum Oxide Aluminum Oxide Aluminum Oxide Aluminum Aluminum Oxide Aluminum Oxide Aluminum Oxide Aluminum Aluminum Aluminum Oxide Aluminum Oxide Aluminum Oxide Aluminum Oxide Aluminum Aluminum Oxide Aluminum Aluminum Oxide Aluminum Oxide Aluminum Aluminum Oxide Aluminum Oxide Aluminum Oxide Aluminum Aluminum Oxide Aluminum Aluminum Oxide Aluminum Aluminum Aluminum Oxide Aluminum Aluminu Boring anodized sheet 27 27 20 50-100 100 70 100 20 T T 0.55 0.60 0.28 T T 0.46 0.16 100 200 200 T T T 0.28-0.38 0.10 Powder Activated, Powder Clean, Powder Clean, Powder Clean, Powder Clean, Powder Clean, Powder Activated, Powder Activated, Powder Activated, Powder Clean, Powder Clean, Powder Clean, Powder Activated, Powder Activated Dudzik Appendix B 178 METALS and METAL OXIDES (continued) Material Copper oxide Copper oxide Copper oxide copper oxide copper oxide 2 T 0.008 22 T 0.015 50-100 27 T T 0.02 0.78 0.88 T T 0.70 0.84 Золото полированной, высоко 130 200-600 100 T T T 0,018 0,02-0,03 0,02 железа, бросил полированной полированной полированной слитки 38 40 900-1100 1000 T T T 0.05 0,05 0,05-06 260 400-1000 200-600 24 92 30 30 20 70 T T T T T T T T T T T T T T T T T SW LW 0.07 0.14-0.38 0.80 0.064 0.07 0.23 0.28 0.64 0.05 250 200 T T T T 0.07 0.86 Приложение В 179 МЕТАLS и МЕТАL OXIDES (продолжение) Материальная спецификация температуры молибдена, С

0.17 Серебряный польский Чистый, полированный 100 200-600 T T 0.03 0.02-0.03 Hepжавеющая сталь Типа 18-8, отполированный тип 18-8, отпо 200 500 200 200 T T T T 0.15 0.20 0.40 0.05 600-1000 1500-2200 3 300 T T T 0.1-0.16 0.24-0.31 0.39 Никель оксид Платина Олово виглізне олово виглізне олово виглізне олово виглізне о касляется при температуре 540 С вольфрамовая нить (продолжение) Приложение В 180 МЕТАLS и МЕТАL ОХІDES (продолжение) Приложение В 180 МЕТАLS и МЕТАLS и МЕТАLS и МЕТАLS (продолжение) Приложение В 180 МЕТАLS (продолжение В 180 МЕ окисленного поверхности , C 200-300 400 50 1000-1200 Spectruma Emittance T T T 0.04-0.05 0.11 0.20 0.50-0.60 T T SW T 1 0.40-400.60 0.78 0.94 0.96 0.93-0.95 ДРУГИЕ МАТЕРИАЛЫ Асбест Порошок Ткань Напольная плитка Доска Шиферная бумага Асфальтовый кирпич 35 20 20 40-400 4 Силлиманит, 33% SiO2, 64% Огнеупорные Al2O3, Marnesut or heynophain, корунд огнеупорный, корунд огнеупорный, корунд огнеупорный, корунд огнеупорный, корунд огнеупорный, корунд огнеупорный, корунд огнеупорные Al2O3, Marnesut or heynophane Al2O3, Пористые, необработанные masonite 20 20 70 SW LW Бетонный Эбонит Эмери Enamel Fiberboard 20 20-400 0,85 0,85 0,85 0,88 Приложение В 181 ДРУГИЕ МАТЕРИАЛЫ (продолжение в 181 ДРУГИЕ МАТЕРИАЛЫ (продолжение в 181 ДРУГИЕ МАТЕРИАЛЫ) (продолжение в 181 ДРУГИЕ МАТЕ 0,9 20 T 0,4 80 100 40-100 T T T T 0. 83 0,97 0,96-0,98 0,8-0,95 T 0,75-0,80 T 0,3-0,4 Лайм Сухое масло, смазка краска бумаги фильм на базе Ni: Ni базы только : 0,025 мм пленка : 0,025 мм пленка : 0,025 мм пленка : 0,025 мм пленки : 0,025 мм пленка : 0,025 мм пленка : 0,025 мм пленка : 0,025 мм пленки : 0,025 мм пленка : 0,025 мм пле Black, dull Emittance 20 21 70 Tanned Mortar Spectruma 0.849 0.879 0.95–0.97 17 36 SW SW 0.87 0.94 20 T 0.05 20 20 T T T T 0.27 0.46 0.72 0.82 50–100 T 0.27–0.67 T T SW SW SW 0.28–0.33 0.65–0.70 0.7–0.8 0.87 0.96 0.92 17 2 0.70 0.70 T T SW SW SW 0.28–0.33 0.65–0.70 0.7–0.8 0.87 0.96 0.95 17 20 20 T T T T T 20 20 7 0 T T T SW SW SW 0.28–0.33 0.65–0.70 0.70 T T SW SW SW 0.87 0.96 0.95 17 20 20 T T T T T 20 20 7 0 T T SW SW SW 0.87 0.96 0.95 17 20 20 T T T T T 20 20 7 0 T T SW SW SW 0.87 0.96 0.95 17 20 20 T T T T T 20 20 7 0 T T SW SW SW 0.87 0.96 0.95 17 20 20 T T T T T 20 20 7 0 T T SW SW SW 0.87 0.96 0.95 17 20 20 T T T T SW SW SW 0.87 0.96 0.95 17 20 20 T T T T T 20 20 7 0 T T SW SW SW 0.87 0.96 0.95 17 20 20 T T T T SW SW SW 0.87 0.96 0.95 17 20 20 T T T T T 20 20 7 0 T T SW SW SW 0.87 0.96 0.95 17 20 20 T T T T T 20 20 7 0 T T SW SW SW 0.87 0.96 0.95 17 20 20 T T T T T SW SW SW 0.87 0.96 0.95 17 20 20 T T T T T SW SW SW 0.87 0.96 0.95 17 20 20 T T T T T T 20 20 7 0 T T T SW SW SW 0.87 0.96 0.95 17 20 20 T T T T T SW SW SW 0.87 0.96 0.95 17 20 20 T T T T T SW SW SW 0.87 0.96 0.95 17 20 20 T T T T T SW SW SW 0.87 0.96 0.95 17 20 20 T T T T T SW SW SW 0.87 0.96 0.95 17 20 20 T T T T T SW SW SW 0.87 0.96 0.95 17 20 20 T T T T T SW SW SW 0.87 0.96 0.95 17 20 20 T T T T T SW SW SW 0.87 0.96 0.95 17 20 20 T T T T T SW SW SW 0.87 0.96 0.95 17 20 20 T T T T T SW SW SW 0.87 0.96 0.95 17 20 20 T T T T T SW SW SW 0.87 0.96 0.95 17 20 20 T T T T T SW SW SW 0.87 0.96 0.95 17 20 20 T T T T T SW SW SW 0.87 0.96 0.95 17 20 20 T T T T T SW SW SW 0.87 0.96 0.95 17 20 20 T T T T T SW SW SW 0.87 0.96 0.95 17 20 20 T T T T T SW SW SW 0.87 0.96 0.95 17 20 20 T T T T T SW SW SW 0.87 0.96 0.95 17 20 20 T T T T SW SW SW 0.87 0.96 0.95 17 20 20 T T T T SW SW SW 0.87 0.96 0.95 17 20 20 T T T T SW SW SW 0.87 0.96 0.95 17 20 20 T T T T T SW SW SW 0.87 0.96 0.95 17 20 20 T T T T T SW SW SW 0.87 0.95 17 20 20 T T T T T SW SW SW 0.87 0.95 17 20 20 T T T T T SW SW SW 0.87 0.95 17 20 20 T T T T T SW SW SW 0.87 0.95 17 20 20 T T T T T SW SW S Spectrum Emitted 17 20 20 SW SW 0.86 0.91 0.90 SW 0.86 0.91 0.90 SW 0.94 70 LW 0.93 White, Shiny Glazed 20 T T 0.70-0.73 0.89-0.78 Soil Dry Water Saturated plastic floor, blunt, structured PVC, plastic floor, blunt, structured vor T 0.97-0.93 0.89-0.78 Soil Dry Water Saturated plaster untreated plastic temperatures, C PVC, plastic floor, blunt, structured vor T 0.97-0.93 0.89-0.78 Soil Dry Water Saturated vor T 0.97-0.93 Soil Dry Water Sa Astarita T., Cardone G., Carlomano G.M. and Meola K. 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ISO 31/VI Terms and Units of Light and related electromagnetic emitters of the web address, as given in the text, FLIR SYSTEMS AB: www.flir.com, www.flir.com, linker and related electromagnetic emitters of the web address, as given in the text ELIR SYSTEMS AB: www.flir.com, www.flir ThermoSensorik: www.thermosensorik.de Index AGEMA File Format (AFF) 49, 59, 60, 95 atmospheric longwave window 53 shortwave 53 black bodies 16-19, 21, 23, 32, 38, 46 calibration characteristic 48, 53, 62, 64 constants 48, 120 array detector 48, 53, 62, 64 constants 48, 120 array detector 48, 53, 62, 64 constants 48, 120 array detector 48, 53, 62, 64 constants 48, 120 array detector 48, 53, 62, 64 constants 48, 120 array detector 48, 53, 62, 64 constants 48, 120 array detector 48, 53, 62, 64 constants 48, 120 array detector 48, 53, 62, 64 constants 48, 120 array detector 48, 53, 62, 64 constants 48, 53, 64 constant photons 45 photovoltaic 45 pyroelectric 44 quantum 45 shortwave (SW) 29 thermo 44 uncooled 30, 3 31, 41 Infrared thermagraphy: Errors and Uncertainty No. 2009 John Wylie and Sons, Ltd. emissions 20 monochrome 21 Total 21 error 1-4 components 66-80 in infrared thermaging, limiting 2 measurements 1 relative 61-66 field field 23, 30 Vision (FOV) 35 Focus Array Plane (FPA) 30, 41 Infrared thermaging, limiting 2 measurements 1 relative 61-66 field field 23, 30 Vision (FOV) 35 Focus Array Plane (FPA) 30, 41 Infrared thermaging, limiting 2 measurements 1 relative 61-66 field field 23, 30 Vision (FOV) 35 Focus Array Plane (FPA) 30, 41 Infrared thermaging, limiting 2 measurements 1 relative 61-66 field field 23, 30 Vision (FOV) 35 Focus Array Plane (FPA) 30, 41 Infrared thermaging, limiting 2 measurements 1 relative 61-66 field field 23, 30 Vision (FOV) 35 Focus Array Plane (FPA) 30, 41 Infrared thermaging, limiting 2 measurements 1 relative 61-66 field field 23, 30 Vision (FOV) 35 Focus Array Plane (FPA) 30, 41 Infrared thermaging, limiting 2 measurements 1 relative 61-66 field field 23, 30 Vision (FOV) 35 Focus Array Plane (FPA) 30, 41 Infrared thermaging, limiting 2 measurements 1 relative 61-66 field field 23, 30 Vision (FOV) 35 Focus Array Plane (FPA) 30, 41 Infrared thermaging, limiting 2 measurements 1 relative 61-66 field field 23, 30 Vision (FOV) 35 Focus Array Plane (FPA) 30, 41 Infrared thermaging, limiting 2 measurements 1 relative 61-66 field field 23, 30 Vision (FOV) 35 Focus Array Plane (FPA) 30, 41 Infrared thermaging, limiting 2 measurements 1 relative 61-66 field field 23, 30 Vision (FOV) 35 Focus Array Plane (FPA) 30, 41 Infrared thermaging, limiting 2 measurements 1 relative 61-66 field field 23, 30 Vision (FOV) 35 Focus Array Plane (FPA) 30, 41 Infrared thermaging, limiting 2 measurements 1 relative 61-66 field field 73, 30 Vision (FOV) 35 Focus Array Plane (FPA) 30, 41 Infrared thermaging, limiting 2 measurements 1 relative 61-66 field field 73, 30 Vision (FOV) 35 Focus Array Plane (FPA) 30, 41 Inf Scale Temperature (ITS) Lambertian Surface 21 Law Kirchhoff in 17, 21 Cosin Lambert 21 Plank 17, 18 Reilly-Jeans 19 Stefan-Boltzmann 19 Wien's 18 Wien Displacement 19 Infrared Near (NIR), Away (FIR) 30 Shining Exit Group 18 Waldemar Minkina and Sebastian Dudzik 18, 85 Index 192 Shining Output (Continued) monochrome 17 spectral 17 radiation external 63 object 10 black body 17-20 thermal 47, 51 reflectivity) 16 spectral 17 relative humidity 55, 65, 78, 79, 100, 101 resolution spatial 32, 36 temperature 32 response speed 46 sensitivity analysis 67, 129 detector band 24 index 3 spectral (voltage or current) 46 thermal 35, 83, 74-76, 99-100 object 33, 55 range 59 thermal 17 uncertainties combined 6, 82, 104, 117, 123, 124 expanded 7, 8 measurements 4 of the type 5 Type B data processing algorithm 5 standard 4 plate 1 Heatgram heater with a marked temperature of the infrared thermalography of the aluminum cylinder (cross-section Li02), paper (cross-section Li03) and plastic (cross-section Li04) in stationary conditions The infrared camera shows a distinctly different temperature for each material: (a) the thermogram; (b) Temperature profiles; and c) a top view of the experimental installation (Minkina 2004). Reproduced by Cze, Technical University of H.S. (see page 29) Plate 3 Image of a small object (anchor clip for the bridge connection of the high-voltage anchorage line) on the array detector, allowing to correctly measure the temperature: a) no detector is completely exposed; (b) At least one detector is completely irradiated (1, object image; 2, array detectors); (c) The clip thermogram, registered at a long distance - about 40 meters (optical and digital zoom); (d) A short-distance clip thermogram, registered at a long distance - about 40 meters (b) Real optics; blur of images - irradiation area 3 3 or 4 4 (sometimes 5 5) detectors needed for correct measurement (Danjoux 2001, Minkina 2004). (See page 38) Plate Detector 5 Array (FPA) used in FLIR cameras: (a) uncooled microbolometers with (Peltier element), air temperature is about 30 C (www.flir.com.pl, and Raytheon (www.raytheon.com): b) 512 512 ALADDIN III (use page 47) Plate 6 Enhanced digital image for various color maps: (a) grey scale; (b) Cool; (c) Hot; HSI (Intensity of Shade Saturation); Spring; (f) Summer; Autumn; (h) Winter. (See page 50) Plate 8 Termograms of polished aluminum sheet, the temperature of which is close to the ambient temperature; (a) mirror image of a person, measuring the temperature of the sheet; (b) The image of a glass of hot water in the background of the sheet and its background reflection (the right edge of the paper sheet stuck on the aluminum is marked with a dotted line), c) view (Minkina 2003). Reproduced by the paper sheet stuck on the aluminum is marked with a dotted line), c) view (Minkina 2003). Reproduced by the paper sheet stuck on the aluminum is marked with a dotted line), c) view (Minkina 2003). Reproduced by the paper sheet stuck on the aluminum is marked with a dotted line), c) view (Minkina 2003). resolution of Cze. The technical university named H.S. (see page 76) Plate 10 The main program window to study the effect of cross correlations between the input quantities of the program to simulate the sensitivity of the camera measurement model on the combined standard uncertainty (Dudzik 2007). (See page 90) Plate 11 The main window of the program to simulate the sensitivity of the camera measurement model ThermaCAM PM 595. (See page 96) 96) infrared thermography errors and uncertainties pdf. minkina and dudzik's infrared thermography errors and uncertainties

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